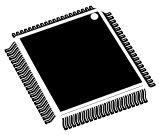
STM8L052R8

Value Line, 8-bit ultralow power MCU, 64-KB Flash, 256-byte data EEPROM, RTC, LCD, timers, USART, I2C, SPI, ADC

Datasheet - production data

Features

- Operating conditions
  - Operating power supply: 1.8 V to 3.6 V
  - Temperature range: -40 °C to 85 °C
- Low power features
  - 5 low power modes: Wait, Low power run (5.9 µA), Low power wait (3 µA), Active-halt with full RTC (1.4 µA), Halt (400 nA)
  - Dynamic power consumption: 200 µA/MHz + 330 µA
  - Ultra-low leakage per I/0: 50 nA
  - Fast wakeup from Halt: 4.7 µs
- Advanced STM8 core
  - Harvard architecture and 3-stage pipeline
  - Max freq. 16 MHz, 16 CISC MIPS peak
  - Up to 40 external interrupt sources
- Reset and supply management
  - Low power, ultra-safe BOR reset with 5 programmable thresholds
  - Ultra low power POR/PDR
  - Programmable voltage detector (PVD)
- Clock management
  - 32 kHz and 1 to 16 MHz crystal oscillators
  - Internal 16 MHz factory-trimmed RC
  - 38 kHz low consumption RC
  - Clock security system
- Low power RTC
  - BCD calendar with alarm interrupt
  - Digital calibration with +/- 0.5ppm accuracy
  - Advanced anti-tamper detection
- LCD: 8x24 or 4x28 w/ step-up converter
- Memories
  - 64 KB Flash program memory and 256 bytes data EEPROM with ECC, RWW
  - Flexible write and read protection modes
  - 4 KB of RAM



LQFP64

- DMA
  - 4 channels supporting ADC, SPIs, I2C, USARTs, timers
  - 1 channel for memory-to-memory
- 12-bit ADC up to 1 Msps/27 channels
  - Internal reference voltage
- Timers
  - Three 16-bit timers with 2 channels (used as IC, OC, PWM), quadrature encoder
  - One 16-bit advanced control timer with 3 channels, supporting motor control
  - One 8-bit timer with 7-bit prescaler
  - 2 watchdogs: 1 Window, 1 Independent
  - Beeper timer with 1, 2 or 4 kHz frequencies
- Communication interfaces
  - Two synchronous serial interfaces (SPI)
  - Fast I2C 400 kHz SMBus and PMBus
  - Three USARTs (ISO 7816 interface + IrDA)
- Up to 54 I/Os, all mappable on interrupt vectors
- Development support
  - Fast on-chip programming and non-intrusive debugging with SWIM
  - Bootloader using USART

This is information on a product in full production.

www.st.com

深圳市满度科技有限公司
Web:www.manduic.com

Tel:150-1290-5940
Email:sales@manduic.com

微信扫码咨询客服

Contents

1 **Introduction 8**

2 **Description 9**

2.1 Device overview 10

2.2 Ultra low power continuum 11

3 **Functional overview 12**

3.1 Low power modes 13

3.2 Central processing unit STM8 14

3.2.1 Advanced STM8 Core 14

3.2.2 Interrupt controller 14

3.3 Reset and supply management 15

3.3.1 Power supply scheme 15

3.3.2 Power supply supervisor 15

3.3.3 Voltage regulator 15

3.4 Clock management 16

3.5 Low power real-time clock 17

3.6 LCD (Liquid crystal display) 18

3.7 Memories 18

3.8 DMA 18

3.9 Analog-to-digital converter 19

3.10 System configuration controller and routing interface 19

3.11 Timers 19

3.11.1 TIM1 - 16-bit advanced control timer 20

3.11.2 16-bit general purpose timers 20

3.11.3 8-bit basic timer 20

3.12 Watchdog timers 20

3.12.1 Window watchdog timer 20

3.12.2 Independent watchdog timer 20

3.13 Beeper 21

3.14 Communication interfaces 21

3.14.1 SPI 21

3.14.2 I²C 21

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

3.14.3 USART 21
3.15 Infrared (IR) interface 22
3.16 Development support 22

4 Pin description 23
4.1 System configuration options 30

5 Memory and register map 31
5.1 Memory mapping 31
5.2 Register map 32

6 Interrupt vector mapping 51

7 Option bytes 53

8 Electrical parameters 56
8.1 Parameter conditions 56
8.1.1 Minimum and maximum values 56
8.1.2 Typical values 56
8.1.3 Typical curves 56
8.1.4 Loading capacitor 56
8.1.5 Pin input voltage 57
8.2 Absolute maximum ratings 57
8.3 Operating conditions 59
8.3.1 General operating conditions 59
8.3.2 Embedded reset and power control block characteristics 60
8.3.3 Supply current characteristics 63
8.3.4 Clock and timing characteristics 76
8.3.5 Memory characteristics 81
8.3.6 I/O current injection characteristics 83
8.3.7 I/O port pin characteristics 83
8.3.8 Communication interfaces 92
8.3.9 LCD controller 97
8.3.10 Embedded reference voltage 98
8.3.11 12-bit ADC1 characteristics 99
8.3.12 EMC characteristics 104
8.4 Thermal characteristics 106

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

9 Package information 107
9.1 LQFP64 package information 107

10 Ordering information 110

11 Revision history 111

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

List of tables

Table 1. High density value line STM8L05xxx low power device features and peripheral counts . . . 10
Table 2. Timer feature comparison . . . 19
Table 3. Legend/abbreviation for *Table 4* . . . 24
Table 4. High density value line STM8L05xxx pin description . . . 24
Table 5. Flash and RAM boundary addresses . . . 31
Table 6. I/O port hardware register map . . . 32
Table 7. General hardware register map . . . 33
Table 8. CPU/SWIM/debug module/interrupt controller registers . . . 49
Table 9. Interrupt mapping . . . 51
Table 10. Option byte addresses . . . 53
Table 11. Option byte description . . . 54
Table 12. Voltage characteristics . . . 57
Table 13. Current characteristics . . . 58
Table 14. Thermal characteristics . . . 58
Table 15. General operating conditions . . . 59
Table 16. Embedded reset and power control block characteristics . . . 60
Table 17. Total current consumption in Run mode . . . 63
Table 18. Total current consumption in Wait mode . . . 66
Table 19. Total current consumption and timing in Low power run mode at VDD = 1.8 V to 3.6 V . . . 68
Table 20. Total current consumption in Low power wait mode at VDD = 1.8 V to 3.6 V . . . 70
Table 21. Total current consumption and timing in Active-halt mode at VDD = 1.8 V to 3.6 V . . . 71
Table 22. Typical current consumption in Active-halt mode, RTC clocked by LSE external crystal . . . 72
Table 23. Total current consumption and timing in Halt mode at VDD = 1.8 to 3.6 V . . . 74
Table 24. Peripheral current consumption . . . 75
Table 25. Current consumption under external reset . . . 76
Table 26. HSE external clock characteristics . . . 76
Table 27. LSE external clock characteristics . . . 77
Table 28. HSE oscillator characteristics . . . 77
Table 29. LSE oscillator characteristics . . . 78
Table 30. HSI oscillator characteristics . . . 79
Table 31. LSI oscillator characteristics . . . 80
Table 32. RAM and hardware registers . . . 81
Table 33. Flash program and data EEPROM memory . . . 82
Table 34. I/O current injection susceptibility . . . 83
Table 35. I/O static characteristics . . . 84
Table 36. Output driving current (high sink ports) . . . 87
Table 37. Output driving current (true open drain ports) . . . 87
Table 38. Output driving current (PA0 with high sink LED driver capability) . . . 87
Table 39. NRST pin characteristics . . . 89
Table 40. SPI1 characteristics . . . 92
Table 41. I2C characteristics . . . 95
Table 42. LCD characteristics . . . 97
Table 43. Reference voltage characteristics . . . 98
Table 44. ADC1 characteristics . . . 99
Table 45. ADC1 accuracy with VDDA = 3.3 V to 2.5 V . . . 101

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 46. ADC1 accuracy with VDDA = 2.4 V to 3.6 V . . . 101
Table 47. ADC1 accuracy with VDDA = $VREF_+$ = 1.8 V to 2.4 V . . . 101
Table 48. EMS data . . . 104
Table 49. EMI data . . . 105
Table 50. ESD absolute maximum ratings . . . 105
Table 51. Electrical sensitivities . . . 105
Table 52. Thermal characteristics . . . 106
Table 53. LQFP64 – 10 x 10 mm, 64-pin low-profile quad flat package mechanical data . . . 108
Table 54. Document revision history . . . 111

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

List of figures

Figure 1. High density value line STM8L05xxx device block diagram . . . 12
Figure 2. High density value line STM8L05xxx clock tree diagram . . . 17
Figure 3. STM8L052R8 64-pin LQFP64 package pinout . . . 23
Figure 4. Memory map . . . 31
Figure 5. Pin loading conditions . . . 56
Figure 6. Pin input voltage . . . 57
Figure 7. Power supply thresholds . . . 62
Figure 8. Typical $I_{DD(RUN)}$ from RAM vs. V_{DD} (HSI clock source), f_{CPU} =16 MHz 1) . . . 65
Figure 9. Typical $I_{DD(RUN)}$ from Flash vs. V_{DD} (HSI clock source), f_{CPU} = 16 MHz1) . . . 65
Figure 10. Typical $I_{DD(Wait)}$ from RAM vs. V_{DD} (HSI clock source), f_{CPU} = 16 MHz 1) . . . 67
Figure 11. Typical $I_{DD(Wait)}$ from Flash (HSI clock source), f_{CPU} = 16 MHz 1) . . . 67
Figure 12. Typical $I_{DD(LPR)}$ vs. V_{DD} (LSI clock source), all peripherals OFF . . . 69
Figure 13. Typical $I_{DD(LPW)}$ vs. V_{DD} (LSI clock source), all peripherals OFF (1) . . . 70
Figure 14. Typical IDD(AH) vs. V_{DD} (LSI clock source) . . . 73
Figure 15. Typical IDD(Halt) vs. V_{DD} (internal reference voltage OFF) . . . 74
Figure 16. HSE oscillator circuit diagram . . . 78
Figure 17. LSE oscillator circuit diagram . . . 79
Figure 18. Typical HSI frequency vs. V_{DD} . . . 80
Figure 19. Typical LSI clock source frequency vs. VDD . . . 81
Figure 20. Typical VIL and VIH vs. VDD (standard I/Os) . . . 85
Figure 21. Typical VIL and VIH vs. VDD (true open drain I/Os) . . . 85
Figure 22. Typical pull-up resistance R_{PU} vs. V_{DD} with VIN=VSS . . . 86
Figure 23. Typical pull-up current I_{pu} vs. V_{DD} with VIN=VSS . . . 86
Figure 24. Typical VOL @ VDD = 3.0 V (high sink ports) . . . 88
Figure 25. Typical VOL @ VDD = 1.8 V (high sink ports) . . . 88
Figure 26. Typical VOL @ VDD = 3.0 V (true open drain ports) . . . 88
Figure 27. Typical VOL @ VDD = 1.8 V (true open drain ports) . . . 88
Figure 28. Typical VDD - VOH @ VDD = 3.0 V (high sink ports) . . . 88
Figure 29. Typical VDD - VOH @ VDD = 1.8 V (high sink ports) . . . 88
Figure 30. Typical NRST pull-up resistance R_{PU} vs. V_{DD} . . . 89
Figure 31. Typical NRST pull-up current I_{pu} vs. V_{DD} . . . 90
Figure 32. Recommended NRST pin configuration . . . 91
Figure 33. SPI1 timing diagram - slave mode and CPHA=0 . . . 93
Figure 34. SPI1 timing diagram - slave mode and CPHA=1(1) . . . 93
Figure 35. SPI1 timing diagram - master mode(1) . . . 94
Figure 36. Typical application with I2C bus and timing diagram 1) . . . 96
Figure 37. ADC1 accuracy characteristics . . . 102
Figure 38. Typical connection diagram using the ADC . . . 102
Figure 39. Power supply and reference decoupling (V_{REF+} not connected to V_{DDA}) . . . 103
Figure 40. Power supply and reference decoupling (VREF+ connected to VDDA) . . . 103
Figure 41. LQFP64 – 10 x 10 mm, 64 pin low-profile quad flat package outline . . . 107
Figure 42. Recommended footprint . . . 108
Figure 43. Example of package marking (package top view) . . . 109
Figure 44. Ordering information . . . 110

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

1 Introduction

This document describes the features, pinout, mechanical data and ordering information of the high density value line STM8L052R8 microcontroller with a Flash memory density of 64 Kbytes.

For further details on the whole STMicroelectronics high density family please refer to *Section 2.2: Ultra low power continuum*.

For detailed information on device operation and registers, refer to the reference manual (RM0031).

For information on to the Flash program memory and data EEPROM, refer to the programming manual (PM0054).

For information on the debug module and SWIM (single wire interface module), refer to the STM8 SWIM communication protocol and debug module user manual (UM0470).

For information on the STM8 core, refer to the STM8 CPU programming manual (PM0044).

High density value line devices provide the following benefits:

- Integrated system
  - 64 Kbytes of high density embedded Flash program memory
  - 256 bytes of data EEPROM
  - 4 Kbytes of RAM
  - Internal high speed and low-power low speed RC
  - Embedded reset
- Ultra low power consumption
  - 1 µA in Active-halt mode
  - Clock gated system and optimized power management
  - Capability to execute from RAM for Low power wait mode and low power run mode
- Advanced features
  - Up to 16 MIPS at 16 MHz CPU clock frequency
  - Direct memory access (DMA) for memory-to-memory or peripheral-to-memory access
- Short development cycles
  - Application scalability across a common family product architecture with compatible pinout, memory map and modular peripherals
  - Wide choice of development tools

These features make the value line STM8L05xxx ultra low power microcontroller family suitable for a wide range of consumer and mass market applications.

Refer to *Table 1: High density value line STM8L05xxx low power device features and peripheral counts* and *Section 3: Functional overview* for an overview of the complete range of peripherals proposed in this family.

Figure 1 shows the block diagram of the high density value line STM8L05xxx family.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

2 Description

The high density value line STM8L05xxx devices are members of the STM8L ultra low power 8-bit family.

The value line STM8L05xxx ultra low power family features the enhanced STM8 CPU core providing increased processing power (up to 16 MIPS at 16 MHz) while maintaining the advantages of a CISC architecture with improved code density, a 24-bit linear addressing space and an optimized architecture for low power operations.

The family includes an integrated debug module with a hardware interface (SWIM) which allows non-intrusive In-application debugging and ultra-fast Flash programming.

High density value line STM8L05xxx microcontrollers feature embedded data EEPROM and low-power, low-voltage, single-supply program Flash memory.

All devices offer 12-bit ADC, real-time clock, four 16-bit timers, one 8-bit timer as well as standard communication interface such as two SPIs, I2C, three USARTs and 8x24 or 4x28-segment LCD. The 8x24 or 4x 28-segment LCD is available on the high density value line STM8L05xxx.

The STM8L05xxx family operates from 1.8 V to 3.6 V and is available in the -40 to +85 °C temperature range.

The modular design of the peripheral set allows the same peripherals to be found in different ST microcontroller families including 32-bit families. This makes any transition to a different family very easy, and simplified even more by the use of a common set of development tools.

All value line STM8L ultra low power products are based on the same architecture with the same memory mapping and a coherent pinout.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

2.1 Device overview

Table 1. High density value line STM8L05xxx low power device features and peripheral counts

Features		STM8L052R8
Flash (Kbytes)		64
Data EEPROM (bytes)		256
RAM (Kbytes)		4
LCD		8x24 or 4x28
Timers	Basic	1 (8-bit)
	General purpose	3 (16-bit)
	Advanced control	1 (16-bit)
Communication interfaces	SPI	2
	I2C	1
	USART	3
GPIOs		54(1)
12-bit synchronized ADC (number of channels)		1 (26)
Others		RTC, window watchdog, independent watchdog, 16-MHz and 38-kHz internal RC, 1- to 16-MHz and 32-kHz external oscillator
CPU frequency		16 MHz
Operating voltage		1.8 V to 3.6 V
Operating temperature		-40 to +85 °C
Package		LQFP64

1. The number of GPIOs given in this table includes the NRST/PA1 pin but the application can use the NRST/PA1 pin as general purpose output only (PA1).

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

2.2 Ultra low power continuum

The ultra low power value line STM8L05xxx and STM8L15xxx are fully pin-to-pin, software and feature compatible. Besides the full compatibility within the STM8L family, the devices are part of STMicroelectronics microcontrollers ultra low power strategy which also includes STM8L101xx and STM32L15xxx. The STM8L and STM32L families allow a continuum of performance, peripherals, system architecture, and features.

They are all based on STMicroelectronics 0.13 µm ultra-low leakage process.

Note: 1 The STM8L05xxx is pin-to-pin compatible with STM8L101xx devices.

2 The STM32L family is pin-to-pin compatible with the general purpose STM32F family. Please refer to STM32L15x documentation for more information on these devices.

Performance

All families incorporate highly energy-efficient cores with both Harvard architecture and pipelined execution: advanced STM8 core for STM8L families and ARM Cortex™-M3 core for STM32L family. In addition specific care for the design architecture has been taken to optimize the mA/DMIPS and mA/MHz ratios.

This allows the ultra low power performance to range from 5 up to 33.3 DMIPs.

Shared peripherals

STM8L05x, STM8L15x and STM32L15xx share identical peripherals which ensure a very easy migration from one family to another:

- Analog peripheral: ADC1
- Digital peripherals: RTC and some communication interfaces

Common system strategy

To offer flexibility and optimize performance, the STM8L and STM32L devices use a common architecture:

- Same power supply range from 1.8 to 3.6 V
- Architecture optimized to reach ultra-low consumption both in low power modes and Run mode
- Fast startup strategy from low power modes
- Flexible system clock
- Ultra-safe reset: same reset strategy for both STM8L and STM32L including power-on reset, power-down reset, brownout reset and programmable voltage detector

Features

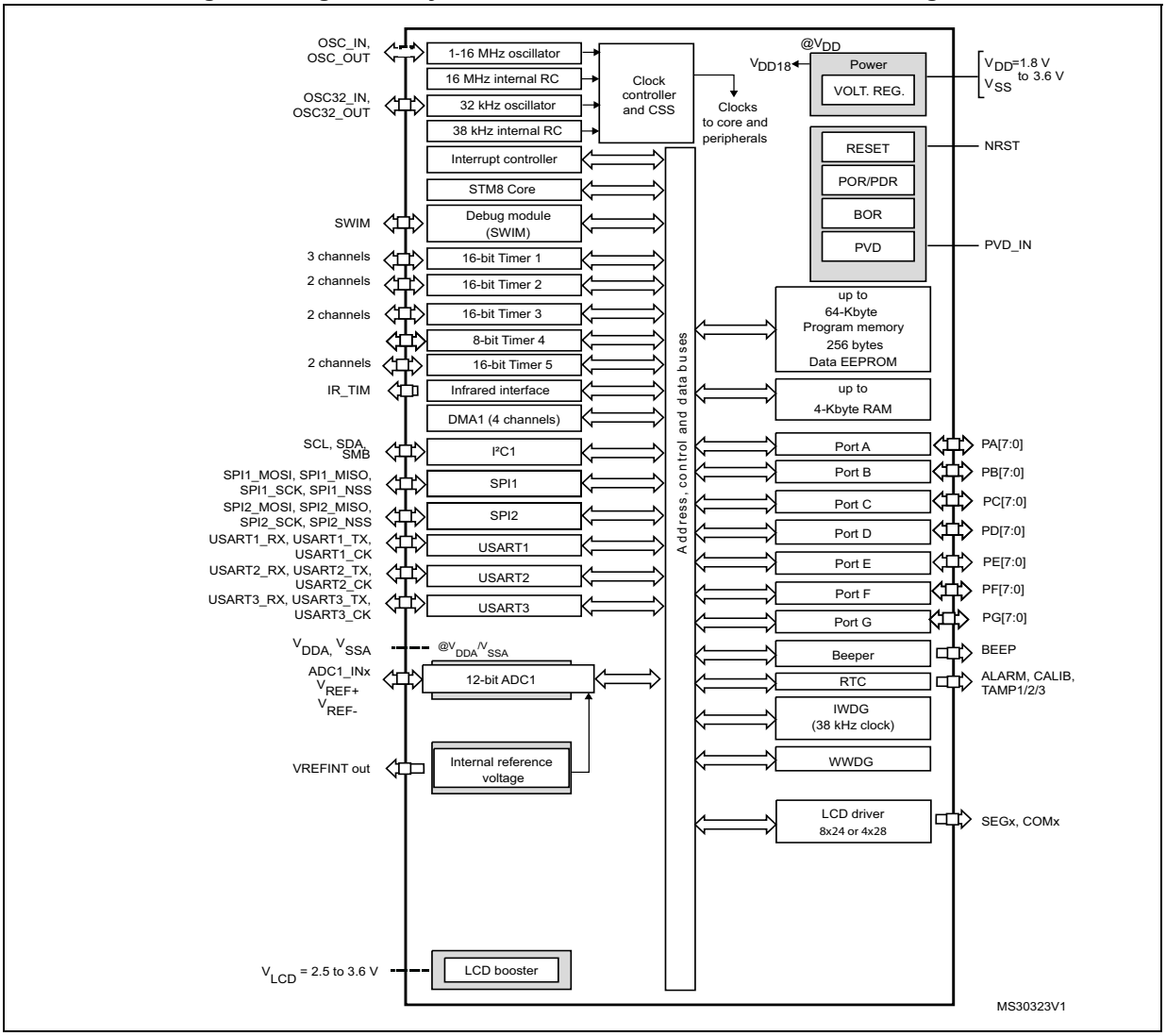
ST ultra low power continuum also lies in feature compatibility:

- More than 10 packages with pin count from 20 to 100 pins and size down to 3 x 3 mm
- Memory density ranging from 4 to 128 Kbytes

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

3 Functional overview

Figure 1. High density value line STM8L05xxx device block diagram



1. **Legend**:
   ADC: Analog-to-digital converter
   BOR: Brownout reset
   DMA: Direct memory access
   I²C: Inter-integrated circuit multimaster interface
   LCD: Liquid crystal display
   POR/PDR: Power on reset / power down reset
   RTC: Real-time clock
   SPI: Serial peripheral interface
   SWIM: Single wire interface module
   USART: Universal synchronous asynchronous receiver transmitter
   WWDG: Window watchdog
   IWDG: independent watchdog

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

3.1 Low power modes

The high density value line STM8L05xxx devices support five low power modes to achieve the best compromise between low power consumption, short startup time and available wakeup sources:

- **Wait mode**: The CPU clock is stopped, but selected peripherals keep running. An internal or external interrupt, event or a Reset can be used to exit the microcontroller from Wait mode (WFE or WFI mode).
- **Low power run mode**: The CPU and the selected peripherals are running. Execution is done from RAM with a low speed oscillator (LSI or LSE). Flash memory and data EEPROM are stopped and the voltage regulator is configured in ultra low power mode. The microcontroller enters Low power run mode by software and can exit from this mode by software or by a reset.
  All interrupts must be masked. They cannot be used to exit the microcontroller from this mode.
- **Low power wait mode:** This mode is entered when executing a Wait for event in Low power run mode. It is similar to Low power run mode except that the CPU clock is stopped. The wakeup from this mode is triggered by a Reset or by an internal or external event (peripheral event generated by the timers, serial interfaces, DMA controller (DMA1) and I/O ports). When the wakeup is triggered by an event, the system goes back to Low power run mode.
  All interrupts must be masked. They cannot be used to exit the microcontroller from this mode.
- **Active-halt mode**: CPU and peripheral clocks are stopped, except RTC. The wakeup can be triggered by RTC interrupts, external interrupts or reset.
- **Halt mode**: CPU and peripheral clocks are stopped, the device remains powered on. The wakeup is triggered by an external interrupt or reset. A few peripherals have also a wakeup from Halt capability. Switching off the internal reference voltage reduces power consumption. Through software configuration it is also possible to wake up the device without waiting for the internal reference voltage wakeup time to have a fast wakeup time of 5 µs.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

3.2 Central processing unit STM8

3.2.1 Advanced STM8 Core

The 8-bit STM8 core is designed for code efficiency and performance with an Harvard architecture and a 3-stage pipeline.

It contains 6 internal registers which are directly addressable in each execution context, 20 addressing modes including indexed indirect and relative addressing, and 80 instructions.

Architecture and registers

- Harvard architecture
- 3-stage pipeline
- 32-bit wide program memory bus - single cycle fetching most instructions
- X and Y 16-bit index registers - enabling indexed addressing modes with or without offset and read-modify-write type data manipulations
- 8-bit accumulator
- 24-bit program counter - 16-Mbyte linear memory space
- 16-bit stack pointer - access to a 64-Kbyte level stack
- 8-bit condition code register - 7 condition flags for the result of the last instruction

Addressing

- 20 addressing modes
- Indexed indirect addressing mode for lookup tables located anywhere in the address space
- Stack pointer relative addressing mode for local variables and parameter passing

Instruction set

- 80 instructions with 2-byte average instruction size
- Standard data movement and logic/arithmetic functions
- 8-bit by 8-bit multiplication
- 16-bit by 8-bit and 16-bit by 16-bit division
- Bit manipulation
- Data transfer between stack and accumulator (push/pop) with direct stack access
- Data transfer using the X and Y registers or direct memory-to-memory transfers

3.2.2 Interrupt controller

The high density value line STM8L05xxx devices feature a nested vectored interrupt controller:

- Nested interrupts with 3 software priority levels
- 32 interrupt vectors with hardware priority
- Up to 40 external interrupt sources on 11 vectors
- Trap and reset interrupts

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

3.3 Reset and supply management

3.3.1 Power supply scheme

The device requires a 1.8 V to 3.6 V operating supply voltage (V_{DD}). The external power supply pins must be connected as follows:

- V_{SS1}, V_{DD1}, V_{SS2}, V_{DD2}, V_{SS3}, V_{DD3} = 1.8 to 3.6 V: external power supply for I/Os and for the internal regulator. Provided externally through V_{DD} pins, the corresponding ground pin is VSS. V_{SS1}/V_{SS2}/V_{SS3}/V_{SS4} and V_{DD1}/V_{DD2}/V_{DD3} must not be left unconnected.
- V_{SSA} ; V_{DDA} = 1.8 to 3.6 V: external power supplies for analog peripherals. V_{DDA} and V_{SSA} must be connected to V_{DD} and V_{SS}, respectively.
- V_{REF+} ; V_{REF-} (for ADC1): external reference voltage for ADC1. Must be provided externally through V_{REF+} and V_{REF-} pin.

3.3.2 Power supply supervisor

The device has an integrated ZEROPOWER power-on reset (POR)/power-down reset (PDR), coupled with a brownout reset (BOR) circuitry that ensures proper operation starting from 1.8 V. After the 1.8 V BOR threshold is reached, the option byte loading process starts, either to confirm or modify default thresholds, or to disable BOR permanently.

Five BOR thresholds are available through option bytes, starting from 1.8 V to 3 V. To reduce the power consumption in Halt mode, it is possible to automatically switch off the internal reference voltage (and consequently the BOR) in Halt mode. The device remains under reset when V_{DD} is below a specified threshold, $V_{POR/PDR}$ or V_{BOR}, without the need for any external reset circuit.

The device features an embedded programmable voltage detector (PVD) that monitors the V_{DD}/V_{DDA} power supply and compares it to the V_{PVD} threshold. This PVD offers 7 different levels between 1.85 V and 3.05 V, chosen by software, with a step around 200 mV. An interrupt can be generated when V_{DD}/V_{DDA} drops below the V_{PVD} threshold and/or when V_{DD}/V_{DDA} is higher than the V_{PVD} threshold. The interrupt service routine can then generate a warning message and/or put the MCU into a safe state. The PVD is enabled by software.

3.3.3 Voltage regulator

The high density value line STM8L05xxx embeds an internal voltage regulator for generating the 1.8 V power supply for the core and peripherals.

This regulator has two different modes:

- Main voltage regulator mode (MVR) for Run, Wait for interrupt (WFI) and Wait for event (WFE) modes
- Low power voltage regulator mode (LPVR) for Halt, Active-halt, Low power run and Low power wait modes

When entering Halt or Active-halt modes, the system automatically switches from the MVR to the LPVR in order to reduce current consumption.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

3.4 Clock management

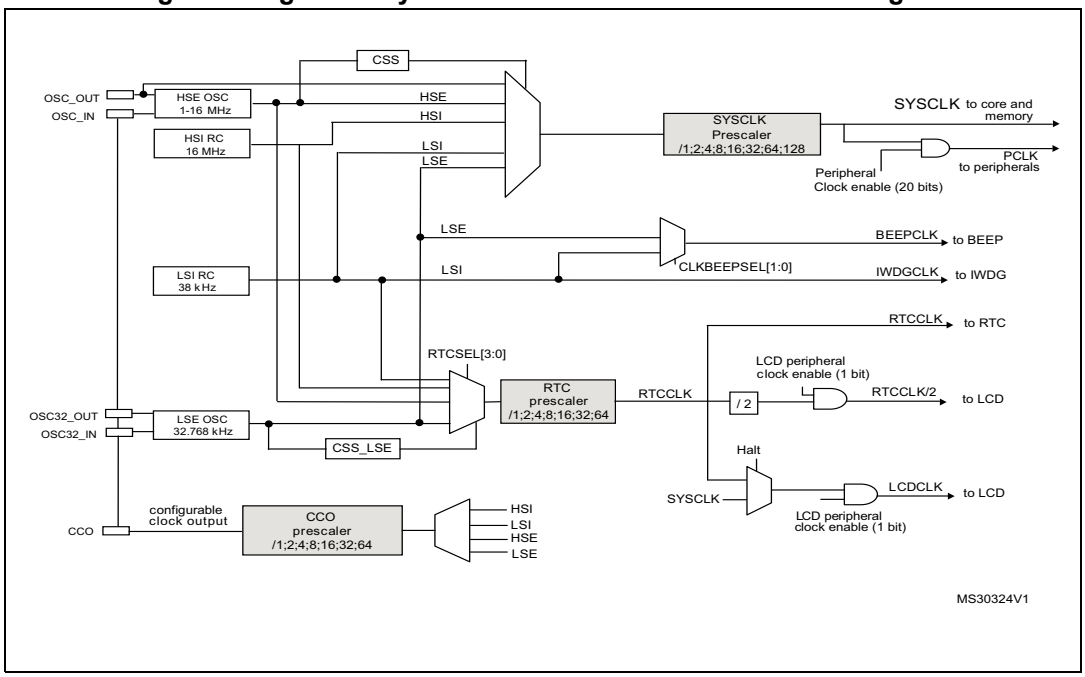
The clock controller distributes the system clock (SYSCLK) coming from different oscillators to the core and the peripherals. It also manages clock gating for low power modes and ensures clock robustness.

Features

- **Clock prescaler:** To get the best compromise between speed and current consumption the clock frequency to the CPU and peripherals can be adjusted by a programmable prescaler.
- **Safe clock switching:** Clock sources can be changed safely on the fly in run mode through a configuration register.
- **Clock management:** To reduce power consumption, the clock controller can stop the clock to the core, individual peripherals or memory.
- **System clock sources:** 4 different clock sources can be used to drive the system clock:
  - 1-16 MHz High speed external crystal (HSE)
  - 16 MHz High speed internal RC oscillator (HSI)
  - 32.768 kHz Low speed external crystal (LSE)
  - 38 kHz Low speed internal RC (LSI)
- **RTC and LCD clock sources:** The above four sources can be chosen to clock the RTC and the LCD, whatever the system clock.
- **Startup clock:** After reset, the microcontroller restarts by default with an internal 2 MHz clock (HSI/8). The prescaler ratio and clock source can be changed by the application program as soon as the code execution starts.
- **Clock security system (CSS):** This feature can be enabled by software. If a HSE clock failure occurs, the system clock is automatically switched to HSI.
- **Configurable main clock output (CCO):** This outputs an external clock for use by the application.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 2. High density value line STM8L05xxx clock tree diagram



1. The HSE clock source can be either an external crystal/ceramic resonator or an external source (HSE bypass). Refer to *Section HSE clock* in the STM8L15x and STM8L16x reference manual (RM0031).
2. The LSE clock source can be either an external crystal/ceramic resonator or a external source (LSE bypass). Refer to *Section LSE clock* in the STM8L15x and STM8L16x reference manual (RM0031).

3.5 Low power real-time clock

The real-time clock (RTC) is an independent binary coded decimal (BCD) timer/counter.

Six byte locations contain the second, minute, hour (12/24 hour), week day, date, month, year, in BCD (binary coded decimal) format. Correction for 28, 29 (leap year), 30, and 31 day months are made automatically.The subsecond field can also be read in binary format.

The calendar can be corrected from 1 to 32767 RTC clock pulses. This allows to make a synchronization to a master clock.

The RTC offers a digital calibration which allows an accuracy of +/-0.5ppm.

It provides a programmable alarm and programmable periodic interrupts with wakeup from Halt capability.

- Periodic wakeup time using the 32.768 kHz LSE with the lowest resolution (of 61 µs) is from min. 122 µs to max. 3.9 s. With a different resolution, the wakeup time can reach 36 hours.
- Periodic alarms based on the calendar can also be generated from every second to every year.

A clock security system detects a failure on LSE, and can provide an interrupt with wakeup capability. The RTC clock can automatically switch to LSI in case of LSE failure.

The RTC also provides 3 anti-tamper detection pins. This detection embeds a programmable filter and can wakeup the MCU.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

3.6 LCD (Liquid crystal display)

The LCD is only available on STM8L052xx devices.

The liquid crystal display drives up to 8 common terminals and up to 24 segment terminals to drive up to 192 pixels. It can also be configured to drive up to 4 common and 28 segments (up to 112 pixels).

- Internal step-up converter to guarantee contrast control whatever V_{DD}.
- Static 1/2, 1/3, 1/4, 1/8 duty supported.
- Static 1/2, 1/3, 1/4 bias supported.
- Phase inversion to reduce power consumption and EMI.
- Up to 8 pixels which can be programmed to blink.
- The LCD controller can operate in Halt mode.

Note: Unnecessary segments and common pins can be used as general I/O pins.

3.7 Memories

The high density value line STM8L05xxx devices have the following main features:

- 4 Kbytes of RAM
- The non-volatile memory is divided into three arrays:
  - 64 Kbytes of high density embedded Flash program memory
  - 256 bytes of data EEPROM
  - Option bytes

The EEPROM embeds the error correction code (ECC) feature. It supports the read-while-write (RWW): it is possible to execute the code from the program matrix while programming/erasing the data matrix.

The option byte protects part of the Flash program memory from write and readout piracy.

3.8 DMA

A 4-channel direct memory access controller (DMA1) offers a memory-to-memory and peripherals-from/to-memory transfer capability. The 4 channels are shared between the following IPs with DMA capability: ADC1, I2C1, SPI1, SPI 2, USART1, USART2, USART3 and the five timers.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

3.9 Analog-to-digital converter

- 12-bit analog-to-digital converter (ADC1) with 27 channels (including 4 fast channels) and internal reference voltage
- Conversion time down to 1 µs with f_{SYSCLK}= 16 MHz
- Programmable resolution
- Programmable sampling time
- Single and continuous mode of conversion
- Scan capability: automatic conversion performed on a selected group of analog inputs
- Analog watchdog: interrupt generation when the converted voltage is outside the programmed threshold
- Triggered by timer

Note: ADC1 can be served by DMA1.

3.10 System configuration controller and routing interface

The system configuration controller provides the capability to remap some alternate functions on different I/O ports. TIM4 and ADC1 DMA channels can also be remapped.

The highly flexible routing interface allows application software to control the routing of different I/Os to the TIM1 timer input captures. It also controls the routing of internal analog signals to ADC1 and the internal reference voltage V_{REFINT}.

3.11 Timers

The high density value line STM8L05xxx devices contain one advanced control timer (TIM1), three 16-bit general purpose timers (TIM2, TIM3 and TIM5) and one 8-bit basic timer (TIM4).

All the timers can be served by DMA1.

Table 2 compares the features of the advanced control, general-purpose and basic timers.

Table 2. Timer feature comparison

Timer	Counter resolution	Counter type	Prescaler factor	DMA1 request generation	Capture/compare channels	Complementary outputs
TIM1	16-bit	up/down	Any integer from 1 to 65536	Yes	3 + 1	3
TIM2			Any power of 2 from 1 to 128		2	None
TIM3						
TIM5						
TIM4	8-bit	up	Any power of 2 from 1 to 32768		0	

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

3.11.1 TIM1 - 16-bit advanced control timer

This is a high-end timer designed for a wide range of control applications. With its complementary outputs, dead-time control and center-aligned PWM capability, the field of applications is extended to motor control, lighting and half-bridge driver.

- 16-bit up, down and up/down autoreload counter with 16-bit prescaler
- 3 independent capture/compare channels (CAPCOM) configurable as input capture, output compare, PWM generation (edge and center aligned mode) and single pulse mode output
- 1 additional capture/compare channel which is not connected to an external I/O
- Synchronization module to control the timer with external signals
- Break input to force timer outputs into a defined state
- 3 complementary outputs with adjustable dead time
- Encoder mode
- Interrupt capability on various events (capture, compare, overflow, break, trigger)

3.11.2 16-bit general purpose timers

- 16-bit autoreload (AR) up/down-counter
- 7-bit prescaler adjustable to fixed power of 2 ratios (1…128)
- 2 individually configurable capture/compare channels
- PWM mode
- Interrupt capability on various events (capture, compare, overflow, break, trigger)
- Synchronization with other timers or external signals (external clock, reset, trigger and enable)

3.11.3 8-bit basic timer

The 8-bit timer consists of an 8-bit up auto-reload counter driven by a programmable prescaler. It can be used for timebase generation with interrupt generation on timer overflow.

3.12 Watchdog timers

The watchdog system is based on two independent timers providing maximum security to the applications.

3.12.1 Window watchdog timer

The window watchdog (WWDG) is used to detect the occurrence of a software fault, usually generated by external interferences or by unexpected logical conditions, which cause the application program to abandon its normal sequence.

3.12.2 Independent watchdog timer

The independent watchdog peripheral (IWDG) can be used to resolve processor malfunctions due to hardware or software failures.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

It is clocked by the internal LSI RC clock source, and thus stays active even in case of a CPU clock failure.

3.13 Beeper

The beeper function outputs a signal on the BEEP pin for sound generation. The signal is in the range of 1, 2 or 4 kHz.

3.14 Communication interfaces

3.14.1 SPI

The serial peripheral interfaces (SPI1 and SPI2) provide half/ full duplex synchronous serial communication with external devices.

- Maximum speed: 8 Mbit/s ($f_{SYSCLK}/2$) both for master and slave
- Full duplex synchronous transfers
- Simplex synchronous transfers on 2 lines with a possible bidirectional data line
- Master or slave operation - selectable by hardware or software
- Hardware CRC calculation
- Slave/master selection input pin

Note: SPI1 and SPI2 *can be served by the DMA1 Controller.*

3.14.2 I²C

The I^2C bus interface (I^2C1) provides multi-master capability, and controls all I²C bus-specific sequencing, protocol, arbitration and timing.

- Master, slave and multi-master capability
- Standard mode up to 100 kHz and fast speed modes up to 400 kHz
- 7-bit and 10-bit addressing modes
- SMBus 2.0 and PMBus support
- Hardware CRC calculation

Note: I^2C1 can be served by the DMA1 Controller.

3.14.3 USART

The USART interfaces (USART1, USART2 and USART3) allow full duplex, asynchronous communications with external devices requiring an industry standard NRZ asynchronous serial data format. It offers a very wide range of baud rates.

- 1 Mbit/s full duplex SCI
- SPI1 emulation
- High precision baud rate generator
- Smartcard emulation
- IrDA SIR encoder decoder
- Single wire half duplex mode

Note: USART1, USART2 and USART3 *can be served by the DMA1 Controller.*

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

3.15 Infrared (IR) interface

The high density value line STM8L05xxx devices contain an infrared interface which can be used with an IR LED for remote control functions. Two timer output compare channels are used to generate the infrared remote control signals.

3.16 Development support

Development tools

Development tools for the STM8 microcontrollers include:

- The STice emulation system offering tracing and code profiling
- The STVD high-level language debugger including C compiler, assembler and integrated development environment
- The STVP Flash programming software

The STM8 also comes with starter kits, evaluation boards and low-cost in-circuit debugging/programming tools.

Single wire data interface (SWIM) and debug module

The debug module with its single wire data interface (SWIM) permits non-intrusive real-time in-circuit debugging and fast memory programming.

The Single wire interface is used for direct access to the debugging module and memory programming. The interface can be activated in all device operation modes.

The non-intrusive debugging module features a performance close to a full-featured emulator. Beside memory and peripherals, CPU operation can also be monitored in real-time by means of shadow registers.

Bootloader

A bootloader is available to reprogram the Flash memory using the USART1, USART2,

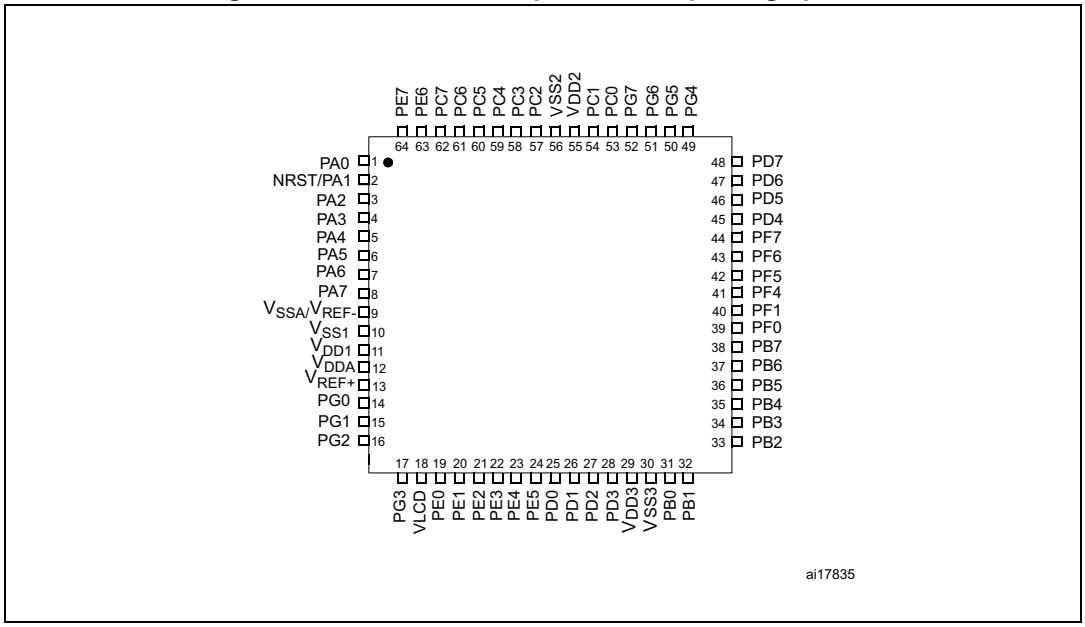
USART3 (USARTs in asynchronous mode), SPI1 or SPI2 interfaces. The reference document for the bootloader is *UM0560: STM8 bootloader user manual*.

The bootloader is used to download application software into the device memories, including RAM, program and data memory, using standard serial interfaces. It is a complementary solution to programming via the SWIM debugging interface.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

4 Pin description

Figure 3. STM8L052R8 64-pin LQFP64 package pinout



深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 3. Legend/abbreviation for *Table 4*

Type	I= input, O = output, S = power supply	
Level	FT	Five-volt tolerant
	TT	3.6 V tolerant
	Output	HS = high sink/source (20 mA)
Port and control configuration	Input	float = floating, wpu = weak pull-up
	Output	T = true open drain, OD = open drain, PP = push pull
Reset state	Bold X (pin state after reset release). Unless otherwise specified, the pin state is the same during the reset phase (i.e. “under reset”) and after internal reset release (i.e. at reset state).	

Table 4. High density value line STM8L05xxx pin description

Pin number	Pin name	Type	I/O level	Input			Output			Main function (after reset)	Default alternate function
LQFP64				floating	wpu	Ext. interrupt	High sink/source	OD	PP		
2	NRST/PA1(1)	I/O	-	-	X	-	HS	X	X	**Reset**	PA1
3	PA2/OSC_IN/ *[USART1_TX]*(8)/ *[SPI1_MISO]*(8)	I/O	-	X	X	X	HS	X	X	**Port A2**	HSE oscillator input / *[USART1 transmit] / [SPI1 master in- slave out]*
4	PA3/OSC_OUT/*[USART1_RX]*(8)/*[SPI1_MOSI]*(8)	I/O	-	X	X	X	HS	X	X	**Port A3**	HSE oscillator output / *[USART1 receive]/ [SPI1 master out/slave in]/*
5	PA4/TIM2_BKIN/ *[TIM2_ETR]*(8)/ LCD_COM0/ADC1_IN2	I/O	FT(2)	X	X	X	HS	X	X	**Port A4**	Timer 2 - break input */[Timer 2 - trigger]/* LCD COM 0 / ADC1 input 2
6	PA5/TIM3_BKIN/ *[TIM3_ETR]*(8)/ LCD_COM1/ADC1_IN1	I/O	FT(2)	X	X	X	HS	X	X	**Port A5**	Timer 3 - break input */[Timer 3 - trigger]/* LCD_COM 1 / ADC1 input 1
7	PA6/*[ADC1_TRIG]*/ LCD_COM2/ADC1_IN0	I/O	FT(2)	X	X	X	HS	X	X	**Port A6**	*[ADC1 - trigger]* / LCD_COM2 / ADC1 input 0
8	PA7/LCD_SEG0(2) /TIM5_CH1	I/O	FT(2)	X	X	X	HS	X	X	**Port A7**	LCD segment 0/ TIM5 channel 1
31	PB0(3)/TIM2_CH1/ LCD_SEG10/ADC1_IN18	I/O	FT(2)	X	X	X	HS	X	X	**Port B0**	Timer 2 - channel 1 / LCD segment 10 / ADC1_IN18

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 4. High density value line STM8L05xxx pin description (continued)

Pin number	Pin name	Type	I/O level	Input			Output			Main function (after reset)	Default alternate function
LQFP64				floating	wpu	Ext. interrupt	High sink/source	OD	PP		
32	PB1/TIM3_CH1/ LCD_SEG11/ ADC1_IN17	I/O	FT(2)	X	X	X	HS	X	X	**Port B1**	Timer 3 - channel 1 / LCD segment 11 / ADC1_IN17
33	PB2/ TIM2_CH2/ LCD_SEG12/ ADC1_IN16	I/O	FT(2)	X	X	X	HS	X	X	**Port B2**	Timer 2 - channel 2 / LCD segment 12 / ADC1_IN16
34	PB3/TIM2_ETR/ LCD_SEG13/ ADC1_IN15	I/O	FT(2)	X	X	X	HS	X	X	**Port B3**	Timer 2 - trigger / LCD segment 13 /ADC1_IN15
35	PB4(3)/*[SPI1_NSS]*(8)/ LCD_SEG14/ ADC1_IN14	I/O	FT(2)	X(3)	X(3)	X	HS	X	X	**Port B4**	*[SPI1 master/slave select]* / LCD segment 14 / ADC1_IN14
36	PB5/*[SPI1_SCK]*(8)/ LCD_SEG15/ ADC1_IN13	I/O	FT(2)	X	X	X	HS	X	X	**Port B5**	*[SPI1 clock]* / LCD segment 15 / ADC1_IN13
37	PB6/[*SPI1_MOSI]*(8)/ LCD_SEG16/ ADC1_IN12	I/O	FT(2)	X	X	X	HS	X	X	**Port B6**	*[SPI1 master out/slave in]*/ LCD segment 16 / ADC1_IN12
38	PB7/*[SPI1_MISO]*(8)/ LCD_SEG17/ ADC1_IN11	I/O	FT(2)	X	X	X	HS	X	X	**Port B7**	*[SPI1 master in- slave out]* /LCD segment 17 / ADC1_IN11
53	PC0(2)/I2C1_SDA	I/O	FT(2)	X	-	X		T(4)		**Port C0**	I2C1 data
54	PC1(2)/I2C1_SCL	I/O	FT(2)	X	-	X		T(4)		**Port C1**	I2C1 clock
57	PC2/USART1_RX/ LCD_SEG22/ADC1_IN6/ VREFINT	I/O	FT(2)	X	X	X	HS	X	X	**Port C2**	USART1 receive / LCD segment 22 / ADC1_IN6 /Internal voltage reference output
58	PC3/USART1_TX/ LCD_SEG23/ ADC1_IN5	I/O	FT(2)	X	X	X	HS	X	X	**Port C3**	USART1 transmit / LCD segment 23 / ADC1_IN5
59	PC4/USART1_CK/ I2C1_SMB/CCO/ ADC1_IN4	I/O	FT(2)	X	X	X	HS	X	X	**Port C4**	USART1 synchronous clock / I2C1_SMB / Configurable clock output / ADC1_IN4

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 4. High density value line STM8L05xxx pin description (continued)

Pin number	Pin name	Type	I/O level	Input			Output			Main function (after reset)	Default alternate function
LQFP64				floating	wpu	Ext. interrupt	High sink/source	OD	PP		
60	PC5/OSC32_IN /*[SPI1_NSS]*(8)/ *[USART1_TX]*(8)	I/O	FT(2)	X	X	X	HS	X	X	**Port C5**	LSE oscillator input / *[SPI1 master/slave select]* / *[USART1 transmit]*
61	PC6/OSC32_OUT/ *[SPI1_SCK]*(8)/ *[USART1_RX]*(8)	I/O	FT(2)	X	X	X	HS	X	X	**Port C6**	LSE oscillator output / *[SPI1 clock]* / *[USART1 receive]*
62	PC7/ADC1_IN3	I/O	FT(2)	X	X	X	HS	X	X	**Port C7**	ADC1_IN3
25	PD0/TIM3_CH2/ *[ADC1_TRIG]*(8)/ LCD_SEG7/ADC1_IN22/	I/O	FT(2)	X	X	X	HS	X	X	**Port D0**	Timer 3 - channel 2 / *[ADC1_Trigger]* / LCD segment 7 / ADC1_IN22
26	PD1/TIM3_ETR/ LCD_COM3/ ADC1_IN21	I/O	FT(2)	X	X	X	HS	X	X	**Port D1**	Timer 3 - trigger / LCD_COM3 / ADC1_IN21
27	PD2/TIM1_CH1 /LCD_SEG8/ ADC1_IN20	I/O	FT(2)	X	X	X	HS	X	X	**Port D2**	Timer 1 - channel 1 / LCD segment 8 / ADC1_IN20
28	PD3/ TIM1_ETR/ LCD_SEG9/ADC1_IN19	I/O	FT(2)	X	X	X	HS	X	X	**Port D3**	Timer 1 - trigger / LCD segment 9 / ADC1_IN19
45	PD4/TIM1_CH2 /LCD_SEG18/ ADC1_IN10	I/O	FT(2)	X	X	X	HS	X	X	**Port D4**	Timer 1 - channel 2 / LCD segment 18 / ADC1_IN10
46	PD5/TIM1_CH3 /LCD_SEG19/ ADC1_IN9	I/O	FT(2)	X	X	X	HS	X	X	**Port D5**	Timer 1 - channel 3 / LCD segment 19 / ADC1_IN9
47	PD6/TIM1_BKIN /LCD_SEG20/ ADC1_IN8/RTC_CALIB/ /VREFINT	I/O	FT(2)	X	X	X	HS	X	X	**Port D6**	Timer 1 - break input / LCD segment 20 / ADC1_IN8 / RTC calibration / Internal voltage reference output
48	PD7/TIM1_CH1N /LCD_SEG21/ ADC1_IN7/RTC_ALARM/V REFINT	I/O	FT(2)	X	X	X	HS	X	X	**Port D7**	Timer 1 - inverted channel 1/ LCD segment 21 / ADC1_IN7 / RTC alarm / Internal voltage reference output

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 4. High density value line STM8L05xxx pin description (continued)

Pin number	Pin name	Type	I/O level	Input			Output			Main function (after reset)	Default alternate function
LQFP64				floating	wpu	Ext. interrupt	High sink/source	OD	PP		
49	PG4/SPI2_NSS	I/O	FT(2)	**X**	X	X	HS	X	X	**Port G4**	SPI2 master/slave select
50	PG5/SPI2_SCK	I/O	FT(2)	**X**	X	X	HS	X	X	**Port G5**	SPI2 clock
51	PG6/SPI2_MOSI	I/O	FT(2)	**X**	X	X	HS	X	X	**Port G6**	SPI2 master out- slave in
52	PG7/SPI2_MISO	I/O	FT(2)	**X**	X	X	HS	X	X	**Port G7**	SPI2 master in- slave out
19	PE0(2)/LCD_SEG1/TIM5_CH2/RTC_TAMP1	I/O	FT(2)	X	X	X	HS	X	X	**Port E0**	LCD segment 1/Timer 5 channel 2/RTC tamper 1
20	PE1/TIM1_CH2N/ LCD_SEG2/RTC_TAMP2	I/O	FT(2)	X	X	X	HS	X	X	**Port E1**	Timer 1 - inverted channel 2 / LCD segment 2/ RTC tamper 2
21	PE2/TIM1_CH3N/ LCD_SEG3/RTC_TAMP3/ *[CCO]*	I/O	FT(2)	X	X	X	HS	X	X	**Port E2**	Timer 1 - inverted channel 3 / LCD segment 3/ RTC tamper 3 / *[Configurable clock output]*
22	PE3/LCD_SEG4 /USART2_RX	I/O	FT(2)	X	X	X	HS	X	X	**Port E3**	LCD segment 4 /USART2 receive
23	PE4/LCD_SEG5 /USART2_TX	I/O	FT(2)	X	X	X	HS	X	X	**Port E4**	LCD segment 5 /USART2 transmit
24	PE5/LCD_SEG6/ ADC1_IN23/USART2_CK	I/O	FT(2)	X	X	X	HS	X	X	**Port E5**	LCD segment 6 / ADC1_IN23/USART2 synchronous clock
63	PE6/PVD_IN/TIM5_BKIN	I/O	FT(2)	X	X	X	HS	X	X	**Port E6**	PVD_IN /TIM5 break input
64	PE7 /TIM5_ETR	I/O	FT(2)	X	X	X	HS	X	X	**Port E7**	TIM5 trigger
39	PF0/ADC1_IN24 /*[USART3_TX]*	I/O	-	X	X	X	HS	X	X	**Port F0**	ADC1_IN24/ [*USART3 transmit*]
40	PF1/ADC1_IN25/ *[USART3_RX]*	I/O	-	**X**	X	X	HS	X	X	**Port F1**	ADC1_IN25/ [*USART3 receive]*
41	PF4/LCD_SEG36 /LCD_COM4(5)	I/O	FT(2)	**X**	X	X	HS	X	X	**Port F4**	LCD_SEG36/ LCD COM4(5)

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 4. High density value line STM8L05xxx pin description (continued)

Pin number	Pin name	Type	I/O level	Input			Output			Main function (after reset)	Default alternate function
LQFP64				floating	wpu	Ext. interrupt	High sink/source	OD	PP		
42	PF5/LCD_SEG37/ LCD_COM5(5)	I/O	FT(2)	**X**	X	X	HS	X	X	**Port F5**	LCD_SEG37/ LCD COM5(5)
43	PF6/LCD_SEG38/ LCD_COM6(5)	I/O	FT(2)	**X**	X	X	HS	X	X	**Port F6**	LCD_SEG38/ LCD COM6(5)
44	PF7/LCD_SEG39/ LCD_COM7(5)	I/O	FT(2)	**X**	X	X	HS	X	X	**Port F7**	LCD_SEG39/ LCD COM7(5)
18	VLCD	S	-	-	-	-	-	-	-	LCD booster external capacitor	
11	V_{DD1}	S	-	-	-	-	-	-	-	Digital power supply	
10	V_{SS1}	-	-	-	-	-	-	-	-	I/O ground	
12	V_{DDA}	S	-	-	-	-	-	-	-	Analog supply voltage	
13	V_{REF+}	S	-	-	-	-	-	-	-	ADC1 positive voltage reference	
14	PG0/USART3_RX/ *[TIM2_BKIN]*	I/O	FT(2)	**X**	X	X	HS	X	X	**Port G0**	USART3 receive / *[Timer 2 - break input]*
15	PG1/USART3_TX/ *[TIM3_BKIN]*	I/O	FT(2)	**X**	X	X	HS	X	X	**Port G1**	USART3 transmit / *[Timer 3 -break input]*
16	PG2/USART3_CK	I/O	FT(2)	**X**	X	X	HS	X	X	**Port G2**	USART 3 synchronous clock
17	PG3*[TIM3_ETR]*	I/O	FT(2)	**X**	X	X	HS	X	X	**Port G3**	*[Timer 3 - trigger]*
9	V_{SSA}/V_{REF-}	S	-	-	-	-	-	-	-	Analog ground voltage / ADC1 negative voltage reference	
55	V_{DD2}	S	-	-	-	-	-	-	-	IOs supply voltage	
56	V_{SS2}	S	-	-	-	-	-	-	-	IOs ground voltage	
1	PA0(6)/*[USART1_CK]*(8)/ SWIM/BEEP/IR_TIM (7)	I/O	-	X	X	X	HS	X	X	**Port A0**	*[USART1 synchronous clock]*(8) / SWIM input and output /Beep output / Infrared Timer output
29	V_{DD3}	S	-	-	-	-	-	-	-	IOs supply voltage	
30	V_{SS3}	S	-	-	-	-	-	-	-	IOs ground voltage	

1. At power-up, the PA1/NRST pin is a reset input pin with pull-up. To be used as a general purpose pin (PA1), it can be configured only as output open-drain or push-pull, not as a general purpose input. Refer to Section *Configuring NRST/PA1 pin as general purpose output* in the STM8L15x and STM8L16x reference manual (RM0031).

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

2. In the 5 V tolerant I/Os, protection diode to V_{DD} is not implemented.
3. A pull-up is applied to PB0 and PB4 during the reset phase. These two pins are input floating after reset release.
4. In the open-drain output column, ‘T’ defines a true open-drain I/O (P-buffer, weak pull-up and protection diode to V_{DD} are not implemented).
5. SEG/COM multiplexing available on medium+ and high density devices. SEG signals are available by default (see reference manual for details).
6. The PA0 pin is in input pull-up during the reset phase and after reset release.
7. High Sink LED driver capability available on PA0.
8. [ ] Alternate function remapping option (if the same alternate function is shown twice, it indicates an exclusive choice not a duplication of the function).

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

4.1 System configuration options

As shown in *Table 4: High density value line STM8L05xxx pin description*, some alternate functions can be remapped on different I/O ports by programming one of the two remapping registers described in the “Routing interface (RI) and system configuration controller” section in the STM8L15x and STM8L16x reference manual (RM0031).

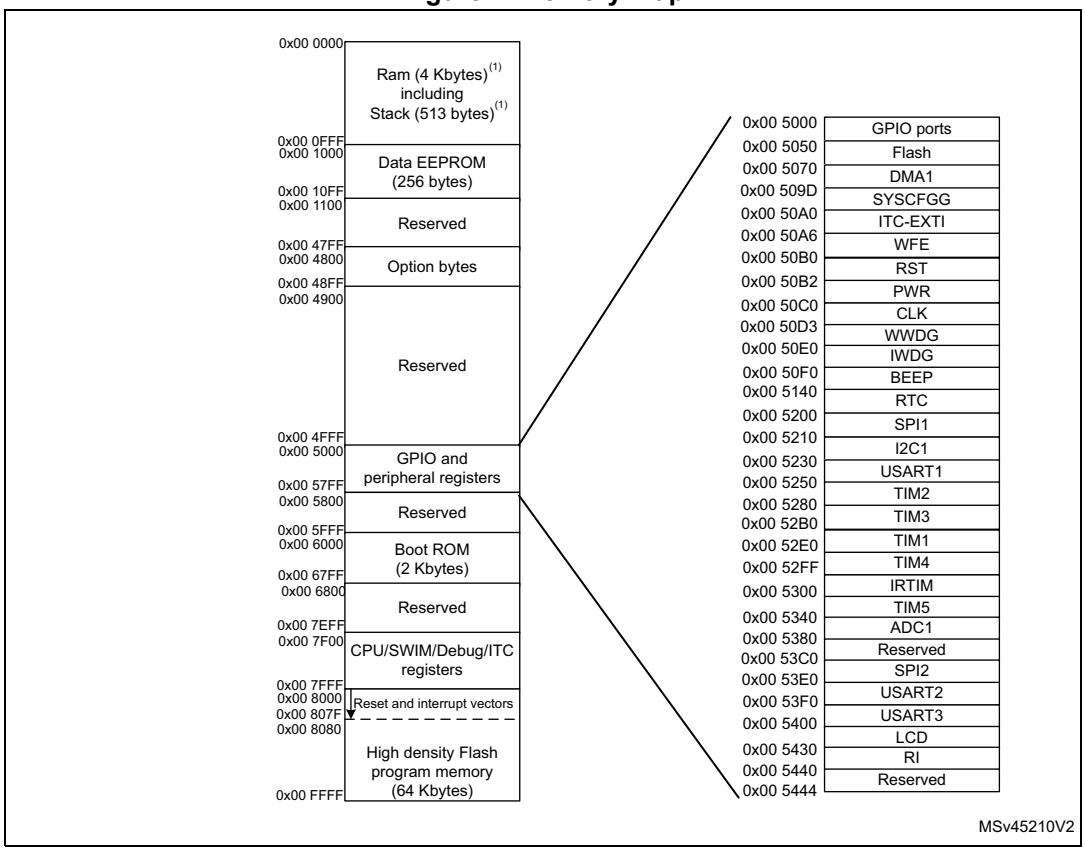
深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

5 Memory and register map

5.1 Memory mapping

The memory map is shown in *Figure 4*.

Figure 4. Memory map



1. *Table 5* lists the boundary addresses for each memory size. The top of the stack is at the RAM end address.
   Refer to *Table 7* for an overview of hardware register mapping, to *Table 6* for details on I/O port hardware registers, and to *Table 8* for information on CPU/SWIM/debug module controller registers.

Table 5. Flash and RAM boundary addresses

Memory area	Size	Start address	End address
RAM	4 Kbytes	0x00 0000	0x00 0FFF
Flash program memory	64 Kbytes	0x00 8000	0x01 7FFF

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

5.2 Register map

Table 6. I/O port hardware register map

Address	Block	Register label	Register name	Reset status
0x00 5000	Port A	PA_ODR	Port A data output latch register	0x00
0x00 5001		PA_IDR	Port A input pin value register	0xXX
0x00 5002		PA_DDR	Port A data direction register	0x00
0x00 5003		PA_CR1	Port A control register 1	0x01
0x00 5004		PA_CR2	Port A control register 2	0x00
0x00 5005	Port B	PB_ODR	Port B data output latch register	0x00
0x00 5006		PB_IDR	Port B input pin value register	0xXX
0x00 5007		PB_DDR	Port B data direction register	0x00
0x00 5008		PB_CR1	Port B control register 1	0x00
0x00 5009		PB_CR2	Port B control register 2	0x00
0x00 500A	Port C	PC_ODR	Port C data output latch register	0x00
0x00 500B		PC_IDR	Port C input pin value register	0xXX
0x00 500C		PC_DDR	Port C data direction register	0x00
0x00 500D		PC_CR1	Port C control register 1	0x00
0x00 500E		PC_CR2	Port C control register 2	0x00
0x00 500F	Port D	PD_ODR	Port D data output latch register	0x00
0x00 5010		PD_IDR	Port D input pin value register	0xXX
0x00 5011		PD_DDR	Port D data direction register	0x00
0x00 5012		PD_CR1	Port D control register 1	0x00
0x00 5013		PD_CR2	Port D control register 2	0x00
0x00 5014	Port E	PE_ODR	Port E data output latch register	0x00
0x00 5015		PE_IDR	Port E input pin value register	0xXX
0x00 5016		PE_DDR	Port E data direction register	0x00
0x00 5017		PE_CR1	Port E control register 1	0x00
0x00 5018		PE_CR2	Port E control register 2	0x00
0x00 5019	Port F	PF_ODR	Port F data output latch register	0x00
0x00 501A		PF_IDR	Port F input pin value register	0xXX
0x00 501B		PF_DDR	Port F data direction register	0x00
0x00 501C		PF_CR1	Port F control register 1	0x00
0x00 501D		PF_CR2	Port F control register 2	0x00

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 6. I/O port hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 501E	Port G	PG_ODR	Port F data output latch register	0x00
0x00 501F		PG_IDR	Port G input pin value register	0xXX
0x00 5020		PG_DDR	Port G data direction register	0x00
0x00 5021		PG_CR1	Port G control register 1	0x00
0x00 5022		PG_CR2	Port G control register 2	0x00
0x00 5023 to 0x00 502C	Reserved area (10 bytes)			

Table 7. General hardware register map

Address	Block	Register label	Register name	Reset status
0x00 502E to 0x00 5049	Reserved area (27 bytes)			
0x00 5050	Flash	FLASH_CR1	Flash control register 1	0x00
0x00 5051		FLASH_CR2	Flash control register 2	0x00
0x00 5052		FLASH _PUKR	Flash program memory unprotection key register	0x00
0x00 5053		FLASH _DUKR	Data EEPROM unprotection key register	0x00
0x00 5054		FLASH _IAPSR	Flash in-application programming status register	0x00
0x00 5055 to 0x00 506F	Reserved area (27 bytes)			

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5070	DMA1	DMA1_GCSR	DMA1 global configuration & status register	0xFC
0x00 5071		DMA1_GIR1	DMA1 global interrupt register 1	0x00
0x00 5072 to 0x00 5074		Reserved area (3 bytes)		
0x00 5075		DMA1_C0CR	DMA1 channel 0 configuration register	0x00
0x00 5076		DMA1_C0SPR	DMA1 channel 0 status & priority register	0x00
0x00 5077		DMA1_C0NDTR	DMA1 number of data to transfer register (channel 0)	0x00
0x00 5078		DMA1_C0PARH	DMA1 peripheral address high register (channel 0)	0x52
0x00 5079		DMA1_C0PARL	DMA1 peripheral address low register (channel 0)	0x00
0x00 507A		Reserved area (1 byte)		
0x00 507B		DMA1_C0M0ARH	DMA1 memory 0 address high register (channel 0)	0x00
0x00 507C		DMA1_C0M0ARL	DMA1 memory 0 address low register (channel 0)	0x00
0x00 507D 0x00 507E		Reserved area (2 bytes)		
0x00 507F		DMA1_C1CR	DMA1 channel 1 configuration register	0x00
0x00 5080		DMA1_C1SPR	DMA1 channel 1 status & priority register	0x00
0x00 5081		DMA1_C1NDTR	DMA1 number of data to transfer register (channel 1)	0x00
0x00 5082		DMA1_C1PARH	DMA1 peripheral address high register (channel 1)	0x52
0x00 5083		DMA1_C1PARL	DMA1 peripheral address low register (channel 1)	0x00

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5084	DMA1	Reserved area (1 byte)		
0x00 5085		DMA1_C1M0ARH	DMA1 memory 0 address high register (channel 1)	0x00
0x00 5086		DMA1_C1M0ARL	DMA1 memory 0 address low register (channel 1)	0x00
0x00 5087 0x00 5088		Reserved area (2 bytes)		
0x00 5089		DMA1_C2CR	DMA1 channel 2 configuration register	0x00
0x00 508A		DMA1_C2SPR	DMA1 channel 2 status & priority register	0x00
0x00 508B		DMA1_C2NDTR	DMA1 number of data to transfer register (channel 2)	0x00
0x00 508C		DMA1_C2PARH	DMA1 peripheral address high register (channel 2)	0x52
0x00 508D		DMA1_C2PARL	DMA1 peripheral address low register (channel 2)	0x00
0x00 508E		Reserved area (1 byte)		
0x00 508F		DMA1_C2M0ARH	DMA1 memory 0 address high register (channel 2)	0x00
0x00 5090		DMA1_C2M0ARL	DMA1 memory 0 address low register (channel 2)	0x00
0x00 5091 0x00 5092		Reserved area (2 bytes)		
0x00 5093		DMA1_C3CR	DMA1 channel 3 configuration register	0x00
0x00 5094		DMA1_C3SPR	DMA1 channel 3 status & priority register	0x00
0x00 5095		DMA1_C3NDTR	DMA1 number of data to transfer register (channel 3)	0x00
0x00 5096		DMA1_C3PARH_ C3M1ARH	DMA1 peripheral address high register (channel 3)	0x40
0x00 5097		DMA1_C3PARL_ C3M1ARL	DMA1 peripheral address low register (channel 3)	0x00
0x00 5098		Reserved area (1 byte)		
0x00 5099		DMA1_C3M0ARH	DMA1 memory 0 address high register (channel 3)	0x00
0x00 509A		DMA1_C3M0ARL	DMA1 memory 0 address low register (channel 3)	0x00
0x00 509B to 0x00 509C		Reserved area (2 bytes)		

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 509D	SYSCFG SYSCFG	SYSCFG_RMPCR3	Remapping register 3	0x00
0x00 509E		SYSCFG_RMPCR1	Remapping register 1	0x00
0x00 509F		SYSCFG_RMPCR2	Remapping register 2	0x00
0x00 50A0	ITC - EXTI	EXTI_CR1	External interrupt control register 1	0x00
0x00 50A1		EXTI_CR2	External interrupt control register 2	0x00
0x00 50A2		EXTI_CR3	External interrupt control register 3	0x00
0x00 50A3		EXTI_SR1	External interrupt status register 1	0x00
0x00 50A4		EXTI_SR2	External interrupt status register 2	0x00
0x00 50A5		EXTI_CONF1	External interrupt port select register 1	0x00
0x00 50A6	WFE	WFE_CR1	WFE control register 1	0x00
0x00 50A7		WFE_CR2	WFE control register 2	0x00
0x00 50A8		WFE_CR3	WFE control register 3	0x00
0x00 50A9		WFE_CR4	WFE control register 4	0x00
0x00 50AA	ITC - EXTI	EXTI_CR4	External interrupt control register 4	0x00
0x00 50AB		EXTI_CONF2	External interrupt port select register 2	0x00
0x00 50A9 to 0x00 50AF	Reserved area (7 bytes)			
0x00 50B0	RST	RST_CR	Reset control register	0x00
0x00 50B1		RST_SR	Reset status register	0x01
0x00 50B2	PWR	PWR_CSR1	Power control and status register 1	0x00
0x00 50B3		PWR_CSR2	Power control and status register 2	0x00
0x00 50B4 to 0x00 50BF	Reserved area (12 bytes)			

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 50C0	CLK	CLK_CKDIVR	Clock master divider register	0x03
0x00 50C1		CLK_CRTCR	Clock RTC register	0x00(1)
0x00 50C2		CLK_ICKR	Internal clock control register	0x11
0x00 50C3		CLK_PCKENR1	Peripheral clock gating register 1	0x00
0x00 50C4		CLK_PCKENR2	Peripheral clock gating register 2	0x00
0x00 50C5		CLK_CCOR	Configurable clock control register	0x00
0x00 50C6		CLK_ECKR	External clock control register	0x00
0x00 50C7		CLK_SCSR	System clock status register	0x01
0x00 50C8		CLK_SWR	System clock switch register	0x01
0x00 50C9		CLK_SWCR	Clock switch control register	0xX0
0x00 50CA		CLK_CSSR	Clock security system register	0x00
0x00 50CB		CLK_CBEEPR	Clock BEEP register	0x00
0x00 50CC		CLK_HSICALR	HSI calibration register	0xXX
0x00 50CD		CLK_HSITRIMR	HSI clock calibration trimming register	0x00
0x00 50CE		CLK_HSIUNLCKR	HSI unlock register	0x00
0x00 50CF		CLK_REGCSR	Main regulator control status register	0bxx11100x
0x00 50D0		CLK_PCKENR3	Peripheral clock gating register 3	0x00
0x00 50D1 to 0x00 50D2	Reserved area (2 bytes)			
0x00 50D3	WWDG	WWDG_CR	WWDG control register	0x7F
0x00 50D4		WWDG_WR	WWDR window register	0x7F
0x00 50D5 to 00 50DF	Reserved area (11 bytes)			
0x00 50E0	IWDG	IWDG_KR	IWDG key register	0xXX
0x00 50E1		IWDG_PR	IWDG prescaler register	0x00
0x00 50E2		IWDG_RLR	IWDG reload register	0xFF
0x00 50E3 to 0x00 50EF	Reserved area (13 bytes)			
0x00 50F0	BEEP	BEEP_CSR1	BEEP control/status register 1	0x00
0x00 50F1 0x00 50F2		Reserved area (2 bytes)		
0x00 50F3		BEEP_CSR2	BEEP control/status register 2	0x1F
0x00 50F4 to 0x00 513F	Reserved area (76 bytes)			

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5140	RTC	RTC_TR1	Time register 1	0x00
0x00 5141		RTC_TR2	Time register 2	0x00
0x00 5142		RTC_TR3	Time register 3	0x00
0x00 5143		Reserved area (1 byte)		
0x00 5144		RTC_DR1	Date register 1	0x01
0x00 5145		RTC_DR2	Date register 2	0x21
0x00 5146		RTC_DR3	Date register 3	0x00
0x00 5147		Reserved area (1 byte)		
0x00 5148		RTC_CR1	Control register 1	0x00(1)
0x00 5149		RTC_CR2	Control register 2	0x00(1)
0x00 514A		RTC_CR3	Control register 3	0x00(1)
0x00 514B		Reserved area (1 byte)		
0x00 514C		RTC_ISR1	Initialization and status register 1	0x01
0x00 514D		RTC_ISR2	Initialization and Status register 2	0x00
0x00 514E 0x00 514F		Reserved area (2 bytes)		
0x00 5150		RTC_SPRERH(1)	Synchronous prescaler register high	0x00(1)
0x00 5151		RTC_SPRERL(1)	Synchronous prescaler register low	0xFF(1)
0x00 5152		RTC_APRER(1)	Asynchronous prescaler register	0x7F(1)
0x00 5153		Reserved area (1 byte)		
0x00 5154		RTC_WUTRH(1)	Wakeup timer register high	0xFF(1)
0x00 5155		RTC_WUTRL(1)	Wakeup timer register low	0xFF(1)
0x00 5156		Reserved area (1 bytes)		
0x00 5157		RTC_SSRL	Subsecond register low	0x00
0x00 5158		RTC_SSRH	Subsecond register high	0x00
0x00 5159		RTC_WPR	Write protection register	0x00
0x00 515A		RTC_SHIFTRH	Shift register high	0x00
0x00 515B		RTC_SHIFTRL	Shift register low	0x00
0x00 515C		RTC_ALRMAR1	Alarm A register 1	0x00(1)
0x00 515D		RTC_ALRMAR2	Alarm A register 2	0x00(1)
0x00 515E		RTC_ALRMAR3	Alarm A register 3	0x00(1)
0x00 515F		RTC_ALRMAR4	Alarm A register 4	0x00(1)
0x00 5160 to 0x00 5163	Reserved area (4 bytes)			

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5164	RTC	RTC_ALRMASSRH	Alarm A subsecond register high	0x00(1)
0x00 5165		RTC_ALRMASSRL	Alarm A subsecond register low	0x00(1)
0x00 5166		RTC_ALRMASSMSKR	Alarm A masking register	0x00(1)
0x00 5167 to 0x00 5169	Reserved area (3 bytes)			
0x00 516A	RTC	RTC_CALRH	Calibration register high	0x00(1)
0x00 516B		RTC_CALRL	Calibration register low	0x00(1)
0x00 516C		RTC_TCR1	Tamper control register 1	0x00(1)
0x00 516D		RTC_TCR2	Tamper control register 2	0x00(1)
0x00 516E to 0x00 518A	Reserved area			
0x00 5190	CSSLSE	CSSLSE_CSR	CSS on LSE control and status register	0x00(1)
0x00 519A to 0x00 51FF	Reserved area			
0x00 5200	SPI1	SPI1_CR1	SPI1 control register 1	0x00
0x00 5201		SPI1_CR2	SPI1 control register 2	0x00
0x00 5202		SPI1_ICR	SPI1 interrupt control register	0x00
0x00 5203		SPI1_SR	SPI1 status register	0x02
0x00 5204		SPI1_DR	SPI1 data register	0x00
0x00 5205		SPI1_CRCPR	SPI1 CRC polynomial register	0x07
0x00 5206		SPI1_RXCRCR	SPI1 Rx CRC register	0x00
0x00 5207		SPI1_TXCRCR	SPI1 Tx CRC register	0x00
0x00 5208 to 0x00 520F	Reserved area (8 bytes)			

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5210	I2C1	I2C1_CR1	I2C1 control register 1	0x00
0x00 5211		I2C1_CR2	I2C1 control register 2	0x00
0x00 5212		I2C1_FREQR	I2C1 frequency register	0x00
0x00 5213		I2C1_OARL	I2C1 own address register low	0x00
0x00 5214		I2C1_OARH	I2C1 own address register high	0x00
0x00 5215		I2C1_OARH	I2C1 own address register for dual mode	0x00
0x00 5216		I2C1_DR	I2C1 data register	0x00
0x00 5217		I2C1_SR1	I2C1 status register 1	0x00
0x00 5218		I2C1_SR2	I2C1 status register 2	0x00
0x00 5219		I2C1_SR3	I2C1 status register 3	0x0x
0x00 521A		I2C1_ITR	I2C1 interrupt control register	0x00
0x00 521B		I2C1_CCRL	I2C1 clock control register low	0x00
0x00 521C		I2C1_CCRH	I2C1 clock control register high	0x00
0x00 521D		I2C1_TRISER	I2C1 TRISE register	0x02
0x00 521E		I2C1_PECR	I2C1 packet error checking register	0x00
0x00 521F to 0x00 522F	Reserved area (17 bytes)			
0x00 5230	USART1	USART1_SR	USART1 status register	0xC0
0x00 5231		USART1_DR	USART1 data register	0xXX
0x00 5232		USART1_BRR1	USART1 baud rate register 1	0x00
0x00 5233		USART1_BRR2	USART1 baud rate register 2	0x00
0x00 5234		USART1_CR1	USART1 control register 1	0x00
0x00 5235		USART1_CR2	USART1 control register 2	0x00
0x00 5236		USART1_CR3	USART1 control register 3	0x00
0x00 5237		USART1_CR4	USART1 control register 4	0x00
0x00 5238		USART1_CR5	USART1 control register 5	0x00
0x00 5239		USART1_GTR	USART1 guard time register	0x00
0x00 523A		USART1_PSCR	USART1 prescaler register	0x00
0x00 523B to 0x00 524F	Reserved area (21 bytes)			

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5250	TIM2	TIM2_CR1	TIM2 control register 1	0x00
0x00 5251		TIM2_CR2	TIM2 control register 2	0x00
0x00 5252		TIM2_SMCR	TIM2 Slave mode control register	0x00
0x00 5253		TIM2_ETR	TIM2 external trigger register	0x00
0x00 5254		TIM2_DER	TIM2 DMA1 request enable register	0x00
0x00 5255		TIM2_IER	TIM2 interrupt enable register	0x00
0x00 5256		TIM2_SR1	TIM2 status register 1	0x00
0x00 5257		TIM2_SR2	TIM2 status register 2	0x00
0x00 5258		TIM2_EGR	TIM2 event generation register	0x00
0x00 5259		TIM2_CCMR1	TIM2 capture/compare mode register 1	0x00
0x00 525A		TIM2_CCMR2	TIM2 capture/compare mode register 2	0x00
0x00 525B		TIM2_CCER1	TIM2 capture/compare enable register 1	0x00
0x00 525C		TIM2_CNTRH	TIM2 counter high	0x00
0x00 525D		TIM2_CNTRL	TIM2 counter low	0x00
0x00 525E		TIM2_PSCR	TIM2 prescaler register	0x00
0x00 525F		TIM2_ARRH	TIM2 auto-reload register high	0xFF
0x00 5260		TIM2_ARRL	TIM2 auto-reload register low	0xFF
0x00 5261		TIM2_CCR1H	TIM2 capture/compare register 1 high	0x00
0x00 5262		TIM2_CCR1L	TIM2 capture/compare register 1 low	0x00
0x00 5263		TIM2_CCR2H	TIM2 capture/compare register 2 high	0x00
0x00 5264		TIM2_CCR2L	TIM2 capture/compare register 2 low	0x00
0x00 5265		TIM2_BKR	TIM2 break register	0x00
0x00 5266		TIM2_OISR	TIM2 output idle state register	0x00
0x00 5267 to 0x00 527F	Reserved area (25 bytes)			

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5280	TIM3	TIM3_CR1	TIM3 control register 1	0x00
0x00 5281		TIM3_CR2	TIM3 control register 2	0x00
0x00 5282		TIM3_SMCR	TIM3 Slave mode control register	0x00
0x00 5283		TIM3_ETR	TIM3 external trigger register	0x00
0x00 5284		TIM3_DER	TIM3 DMA1 request enable register	0x00
0x00 5285		TIM3_IER	TIM3 interrupt enable register	0x00
0x00 5286		TIM3_SR1	TIM3 status register 1	0x00
0x00 5287		TIM3_SR2	TIM3 status register 2	0x00
0x00 5288		TIM3_EGR	TIM3 event generation register	0x00
0x00 5289		TIM3_CCMR1	TIM3 Capture/Compare mode register 1	0x00
0x00 528A		TIM3_CCMR2	TIM3 Capture/Compare mode register 2	0x00
0x00 528B		TIM3_CCER1	TIM3 Capture/Compare enable register 1	0x00
0x00 528C		TIM3_CNTRH	TIM3 counter high	0x00
0x00 528D		TIM3_CNTRL	TIM3 counter low	0x00
0x00 528E		TIM3_PSCR	TIM3 prescaler register	0x00
0x00 528F		TIM3_ARRH	TIM3 Auto-reload register high	0xFF
0x00 5290		TIM3_ARRL	TIM3 Auto-reload register low	0xFF
0x00 5291		TIM3_CCR1H	TIM3 Capture/Compare register 1 high	0x00
0x00 5292		TIM3_CCR1L	TIM3 Capture/Compare register 1 low	0x00
0x00 5293		TIM3_CCR2H	TIM3 Capture/Compare register 2 high	0x00
0x00 5294		TIM3_CCR2L	TIM3 Capture/Compare register 2 low	0x00
0x00 5295		TIM3_BKR	TIM3 break register	0x00
0x00 5296		TIM3_OISR	TIM3 output idle state register	0x00
0x00 5297 to 0x00 52AF	Reserved area (25 bytes)			

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 52B0	TIM1	TIM1_CR1	TIM1 control register 1	0x00
0x00 52B1		TIM1_CR2	TIM1 control register 2	0x00
0x00 52B2		TIM1_SMCR	TIM1 Slave mode control register	0x00
0x00 52B3		TIM1_ETR	TIM1 external trigger register	0x00
0x00 52B4		TIM1_DER	TIM1 DMA1 request enable register	0x00
0x00 52B5		TIM1_IER	TIM1 Interrupt enable register	0x00
0x00 52B6		TIM1_SR1	TIM1 status register 1	0x00
0x00 52B7		TIM1_SR2	TIM1 status register 2	0x00
0x00 52B8		TIM1_EGR	TIM1 event generation register	0x00
0x00 52B9		TIM1_CCMR1	TIM1 Capture/Compare mode register 1	0x00
0x00 52BA		TIM1_CCMR2	TIM1 Capture/Compare mode register 2	0x00
0x00 52BB		TIM1_CCMR3	TIM1 Capture/Compare mode register 3	0x00
0x00 52BC		TIM1_CCMR4	TIM1 Capture/Compare mode register 4	0x00
0x00 52BD		TIM1_CCER1	TIM1 Capture/Compare enable register 1	0x00
0x00 52BE		TIM1_CCER2	TIM1 Capture/Compare enable register 2	0x00
0x00 52BF		TIM1_CNTRH	TIM1 counter high	0x00
0x00 52C0		TIM1_CNTRL	TIM1 counter low	0x00
0x00 52C1		TIM1_PSCRH	TIM1 prescaler register high	0x00
0x00 52C2		TIM1_PSCRL	TIM1 prescaler register low	0x00
0x00 52C3		TIM1_ARRH	TIM1 Auto-reload register high	0xFF
0x00 52C4		TIM1_ARRL	TIM1 Auto-reload register low	0xFF
0x00 52C5		TIM1_RCR	TIM1 Repetition counter register	0x00
0x00 52C6		TIM1_CCR1H	TIM1 Capture/Compare register 1 high	0x00
0x00 52C7		TIM1_CCR1L	TIM1 Capture/Compare register 1 low	0x00
0x00 52C8		TIM1_CCR2H	TIM1 Capture/Compare register 2 high	0x00
0x00 52C9		TIM1_CCR2L	TIM1 Capture/Compare register 2 low	0x00
0x00 52CA		TIM1_CCR3H	TIM1 Capture/Compare register 3 high	0x00
0x00 52CB		TIM1_CCR3L	TIM1 Capture/Compare register 3 low	0x00
0x00 52CC		TIM1_CCR4H	TIM1 Capture/Compare register 4 high	0x00
0x00 52CD		TIM1_CCR4L	TIM1 Capture/Compare register 4 low	0x00
0x00 52CE		TIM1_BKR	TIM1 break register	0x00
0x00 52CF		TIM1_DTR	TIM1 dead-time register	0x00
0x00 52D0		TIM1_OISR	TIM1 output idle state register	0x00
0x00 52D1		TIM1_DCR1	DMA1 control register 1	0x00

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 52D2	TIM1	TIM1_DCR2	TIM1 DMA1 control register 2	0x00
0x00 52D3		TIM1_DMA1R	TIM1 DMA1 address for burst mode	0x00
0x00 52D4 to 0x00 52DF	Reserved area (12 bytes)			
0x00 52E0	TIM4	TIM4_CR1	TIM4 control register 1	0x00
0x00 52E1		TIM4_CR2	TIM4 control register 2	0x00
0x00 52E2		TIM4_SMCR	TIM4 Slave mode control register	0x00
0x00 52E3		TIM4_DER	TIM4 DMA1 request enable register	0x00
0x00 52E4		TIM4_IER	TIM4 Interrupt enable register	0x00
0x00 52E5		TIM4_SR1	TIM4 status register 1	0x00
0x00 52E6		TIM4_EGR	TIM4 Event generation register	0x00
0x00 52E7		TIM4_CNTR	TIM4 counter	0x00
0x00 52E8		TIM4_PSCR	TIM4 prescaler register	0x00
0x00 52E9		TIM4_ARR	TIM4 Auto-reload register	0x00
0x00 52EA to 0x00 52FE	Reserved area (21 bytes)			
0x00 52FF	IRTIM	IR_CR	Infrared control register	0x00
0x00 5300	TIM5	TIM5_CR1	TIM5 control register 1	0x00
0x00 5301		TIM5_CR2	TIM5 control register 2	0x00
0x00 5302		TIM5_SMCR	TIM5 Slave mode control register	0x00
0x00 5303		TIM5_ETR	TIM5 external trigger register	0x00
0x00 5304		TIM5_DER	TIM5 DMA1 request enable register	0x00
0x00 5305		TIM5_IER	TIM5 interrupt enable register	0x00
0x00 5306		TIM5_SR1	TIM5 status register 1	0x00
0x00 5307		TIM5_SR2	TIM5 status register 2	0x00
0x00 5308		TIM5_EGR	TIM5 event generation register	0x00
0x00 5309		TIM5_CCMR1	TIM5 Capture/Compare mode register 1	0x00
0x00 530A		TIM5_CCMR2	TIM5 Capture/Compare mode register 2	0x00
0x00 530B		TIM5_CCER1	TIM5 Capture/Compare enable register 1	0x00
0x00 530C		TIM5_CNTRH	TIM5 counter high	0x00
0x00 530D		TIM5_CNTRL	TIM5 counter low	0x00
0x00 530E		TIM5_PSCR	TIM5 prescaler register	0x00
0x00 530F		TIM5_ARRH	TIM5 Auto-reload register high	0xFF
0x00 5310		TIM5_ARRL	TIM5 Auto-reload register low	0xFF

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5311	TIM5	TIM5_CCR1H	TIM5 Capture/Compare register 1 high	0x00
0x00 5312		TIM5_CCR1L	TIM5 Capture/Compare register 1 low	0x00
0x00 5313		TIM5_CCR2H	TIM5 Capture/Compare register 2 high	0x00
0x00 5314		TIM5_CCR2L	TIM5 Capture/Compare register 2 low	0x00
0x00 5315		TIM5_BKR	TIM5 break register	0x00
0x00 5316		TIM5_OISR	TIM5 output idle state register	0x00
0x00 5317 to 0x00 533F	Reserved area			
0x00 5340	ADC1	ADC1_CR1	ADC1 configuration register 1	0x00
0x00 5341		ADC1_CR2	ADC1 configuration register 2	0x00
0x00 5342		ADC1_CR3	ADC1 configuration register 3	0x1F
0x00 5343		ADC1_SR	ADC1 status register	0x00
0x00 5344		ADC1_DRH	ADC1 data register high	0x00
0x00 5345		ADC1_DRL	ADC1 data register low	0x00
0x00 5346		ADC1_HTRH	ADC1 high threshold register high	0x0F
0x00 5347		ADC1_HTRL	ADC1 high threshold register low	0xFF
0x00 5348		ADC1_LTRH	ADC1 low threshold register high	0x00
0x00 5349		ADC1_LTRL	ADC1 low threshold register low	0x00
0x00 534A		ADC1_SQR1	ADC1 channel sequence 1 register	0x00
0x00 534B		ADC1_SQR2	ADC1 channel sequence 2 register	0x00
0x00 534C		ADC1_SQR3	ADC1 channel sequence 3 register	0x00
0x00 534D		ADC1_SQR4	ADC1 channel sequence 4 register	0x00
0x00 534E		ADC1_TRIGR1	ADC1 trigger disable 1	0x00
0x00 534F		ADC1_TRIGR2	ADC1 trigger disable 2	0x00
0x00 5350		ADC1_TRIGR3	ADC1 trigger disable 3	0x00
0x00 5351		ADC1_TRIGR4	ADC1 trigger disable 4	0x00
0x00 5352 to 0x00 53BF	Reserved area (110 bytes)			

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 53C0	SPI2	SPI2_CR1	SPI2 control register 1	0x00
0x00 53C1		SPI2_CR2	SPI2 control register 2	0x00
0x00 53C2		SPI2_ICR	SPI2 interrupt control register	0x00
0x00 53C3		SPI2_SR	SPI2 status register	0x02
0x00 53C4		SPI2_DR	SPI2 data register	0x00
0x00 53C5		SPI2_CRCPR	SPI2 CRC polynomial register	0x07
0x00 53C6		SPI2_RXCRCR	SPI2 Rx CRC register	0x00
0x00 53C7		SPI2_TXCRCR	SPI2 Tx CRC register	0x00
0x00 53C8 to 0x00 53DF	Reserved area			
0x00 53E0	USART2	USART2_SR	USART2 status register	0xC0
0x00 53E1		USART2_DR	USART2 data register	0xXX
0x00 53E2		USART2_BRR1	USART2 baud rate register 1	0x00
0x00 53E3		USART2_BRR2	USART2 baud rate register 2	0x00
0x00 53E4		USART2_CR1	USART2 control register 1	0x00
0x00 53E5		USART2_CR2	USART2 control register 2	0x00
0x00 53E6		USART2_CR3	USART2 control register 3	0x00
0x00 53E7		USART2_CR4	USART2 control register 4	0x00
0x00 53E8		USART2_CR5	USART2 control register 5	0x00
0x00 53E9		USART2_GTR	USART2 guard time register	0x00
0x00 53EA		USART2_PSCR	USART2 prescaler register	0x00
0x00 53EB to 0x00 53EF	Reserved area			
0x00 53F0	USART3	USART3_SR	USART3 status register	0xC0
0x00 53F1		USART3_DR	USART3 data register	0xXX
0x00 53F2		USART3_BRR1	USART3 baud rate register 1	0x00
0x00 53F3		USART3_BRR2	USART3 baud rate register 2	0x00
0x00 53F4		USART3_CR1	USART3 control register 1	0x00
0x00 53F5		USART3_CR2	USART3 control register 2	0x00
0x00 53F6		USART3_CR3	USART3 control register 3	0x00
0x00 53F7		USART3_CR4	USART3 control register 4	0x00
0x00 53F8		USART3_CR5	USART3 control register 5	0x00
0x00 53F9		USART3_GTR	USART3 guard time register	0x00
0x00 53FA		USART3_PSCR	USART3 prescaler register	0x00

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 53FB to 0x00 53FF	Reserved area			
0x00 5400	LCD	LCD_CR1	LCD control register 1	0x00
0x00 5401		LCD_CR2	LCD control register 2	0x00
0x00 5402		LCD_CR3	LCD control register 3	0x00
0x00 5403		LCD_FRQ	LCD frequency selection register	0x00
0x00 5404		LCD_PM0	LCD Port mask register 0	0x00
0x00 5405		LCD_PM1	LCD Port mask register 1	0x00
0x00 5406		LCD_PM2	LCD Port mask register 2	0x00
0x00 5407		Reserved area		
0x00 5408		LCD_PM4	LCD Port mask register 4	0x00
0x00 5409 to 0x00 540B	LCD	Reserved area (3 bytes)		
0x00 540C		LCD_RAM0	LCD display memory 0	0x00
0x00 540D		LCD_RAM1	LCD display memory 1	0x00
0x00 540E		LCD_RAM2	LCD display memory 2	0x00
0x00 540F		LCD_RAM3	LCD display memory 3	0x00
0x00 5410		LCD_RAM4	LCD display memory 4	0x00
0x00 5411		LCD_RAM5	LCD display memory 5	0x00
0x00 5412		LCD_RAM6	LCD display memory 6	0x00
0x00 5413		LCD_RAM7	LCD display memory 7	0x00
0x00 5414		LCD_RAM8	LCD display memory 8	0x00
0x00 5415		LCD_RAM9	LCD display memory 9	0x00
0x00 5416		LCD_RAM10	LCD display memory 10	0x00
0x00 5417		LCD_RAM11	LCD display memory 11	0x00
0x00 5418		LCD_RAM12	LCD display memory 12	0x00
0x00 5419		LCD_RAM13	LCD display memory 13	0x00
0x00 541A		Reserved area		
0x00 541B		LCD_RAM15	LCD display memory 15	0x00
0x00 541C		Reserved area		
0x00 541D		LCD_RAM17	LCD display memory 17	0x00
0x00 541E		Reserved area		
0x00 541F		LCD_RAM19	LCD display memory 19	0x00
0x00 5420		Reserved area		
0x00 5421		LCD_RAM21	LCD display memory 21	0x00

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 7. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5422 to 0x00 542E	Reserved area			
0x00 542F	LCD	LCD_CR4	LCD control register 4	0x00
0x00 5430	RI	Reserved area (1 byte)		0x00
0x00 5431		RI_ICR1	Timer input capture routing register 1	0x00
0x00 5432		RI_ICR2	Timer input capture routing register 2	0x00
0x00 5433		RI_IOIR1	I/O input register 1	0xXX
0x00 5434		RI_IOIR2	I/O input register 2	0xXX
0x00 5435		RI_IOIR3	I/O input register 3	0xXX
0x00 5436		RI_IOCMR1	I/O control mode register 1	0x00
0x00 5437		RI_IOCMR2	I/O control mode register 2	0x00
0x00 5438		RI_IOCMR3	I/O control mode register 3	0x00
0x00 5439		RI_IOSR1	I/O switch register 1	0x00
0x00 543A		RI_IOSR2	I/O switch register 2	0x00
0x00 543B		RI_IOSR3	I/O switch register 3	0x00
0x00 543C		RI_IOGCR	I/O group control register	0x3F
0x00 543D		RI_ASCR1	Analog switch register 1	0x00
0x00 543E		RI_ASCR2	Analog switch register 2	0x00
0x00 543F		RI_RCR	Resistor control register 1	0x00
0x00 5440 to 0x00 5444	Reserved area (5 bytes)			

1. These registers are not impacted by a system reset. They are reset at power-on.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 8. CPU/SWIM/debug module/interrupt controller registers

Address	Block	Register Label	Register Name	Reset Status
0x00 7F00	CPU(1)	A	Accumulator	0x00
0x00 7F01		PCE	Program counter extended	0x00
0x00 7F02		PCH	Program counter high	0x00
0x00 7F03		PCL	Program counter low	0x00
0x00 7F04		XH	X index register high	0x00
0x00 7F05		XL	X index register low	0x00
0x00 7F06		YH	Y index register high	0x00
0x00 7F07		YL	Y index register low	0x00
0x00 7F08		SPH	Stack pointer high	0x03
0x00 7F09		SPL	Stack pointer low	0xFF
0x00 7F0A		CCR	Condition code register	0x28
0x00 7F0B to 0x00 7F5F	CPU	Reserved area (85 bytes)		
0x00 7F60		CFG_GCR	Global configuration register	0x00
0x00 7F70	ITC-SPR	ITC_SPR1	Interrupt Software priority register 1	0xFF
0x00 7F71		ITC_SPR2	Interrupt Software priority register 2	0xFF
0x00 7F72		ITC_SPR3	Interrupt Software priority register 3	0xFF
0x00 7F73		ITC_SPR4	Interrupt Software priority register 4	0xFF
0x00 7F74		ITC_SPR5	Interrupt Software priority register 5	0xFF
0x00 7F75		ITC_SPR6	Interrupt Software priority register 6	0xFF
0x00 7F76		ITC_SPR7	Interrupt Software priority register 7	0xFF
0x00 7F77		ITC_SPR8	Interrupt Software priority register 8	0xFF
0x00 7F78 to 0x00 7F79	Reserved area (2 bytes)			
0x00 7F80	SWIM	SWIM_CSR	SWIM control status register	0x00
0x00 7F81 to 0x00 7F8F	Reserved area (15 bytes)			

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 8. CPU/SWIM/debug module/interrupt controller registers (continued)

Address	Block	Register Label	Register Name	Reset Status
0x00 7F90	DM	DM_BK1RE	DM breakpoint 1 register extended byte	0xFF
0x00 7F91		DM_BK1RH	DM breakpoint 1 register high byte	0xFF
0x00 7F92		DM_BK1RL	DM breakpoint 1 register low byte	0xFF
0x00 7F93		DM_BK2RE	DM breakpoint 2 register extended byte	0xFF
0x00 7F94		DM_BK2RH	DM breakpoint 2 register high byte	0xFF
0x00 7F95		DM_BK2RL	DM breakpoint 2 register low byte	0xFF
0x00 7F96		DM_CR1	DM Debug module control register 1	0x00
0x00 7F97		DM_CR2	DM Debug module control register 2	0x00
0x00 7F98		DM_CSR1	DM Debug module control/status register 1	0x10
0x00 7F99		DM_CSR2	DM Debug module control/status register 2	0x00
0x00 7F9A		DM_ENFCTR	DM enable function register	0xFF
0x00 7F9B to 0x00 7F9F	Reserved area (5 bytes)			

1. Accessible by debug module only

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

6 Interrupt vector mapping

Table 9. Interrupt mapping

IRQ No.	Source block	Description	Wakeup from Halt mode	Wakeup from Active-halt mode	Wakeup from Wait (WFI mode)	Wakeup from Wait (WFE mode)(1)	Vector address
	RESET	Reset	Yes	Yes	Yes	Yes	0x00 8000
	TRAP	Software interrupt	-	-	-	-	0x00 8004
0	TLI(2)	External Top level Interrupt	-	-	-	-	0x00 8008
1	FLASH	EOP/WR_PG_DIS	-	-	Yes	Yes(5)	0x00 800C
2	DMA1 0/1	DMA1 channels 0/1	-	-	Yes	Yes(5)	0x00 8010
3	DMA1 2/3	DMA1 channels 2/3	-	-	Yes	Yes(5)	0x00 8014
4	RTC/LSE_ CSS	RTC alarm interrupt/LSE CSS interrupt	Yes	Yes	Yes	Yes	0x00 8018
5	EXTI E/F/ PVD(3)	PortE/F interrupt/PVD interrupt	Yes	Yes	Yes	Yes(5)	0x00 801C
6	EXTIB/G	External interrupt port B/G	Yes	Yes	Yes	Yes(5)	0x00 8020
7	EXTID/H	External interrupt port D	Yes	Yes	Yes	Yes(5)	0x00 8024
8	EXTI0	External interrupt 0	Yes	Yes	Yes	Yes(5)	0x00 8028
9	EXTI1	External interrupt 1	Yes	Yes	Yes	Yes(5)	0x00 802C
10	EXTI2	External interrupt 2	Yes	Yes	Yes	Yes(5)	0x00 8030
11	EXTI3	External interrupt 3	Yes	Yes	Yes	Yes(5)	0x00 8034
12	EXTI4	External interrupt 4	Yes	Yes	Yes	Yes(5)	0x00 8038
13	EXTI5	External interrupt 5	Yes	Yes	Yes	Yes(5)	0x00 803C
14	EXTI6	External interrupt 6	Yes	Yes	Yes	Yes(5)	0x00 8040
15	EXTI7	External interrupt 7	Yes	Yes	Yes	Yes(5)	0x00 8044
16	LCD	LCD interrupt	-	-	Yes	Yes	0x00 8048
17	CLK/TIM1	system clock switch/ CSS interrupt/ TIM 1 break	-	-	Yes	Yes(5)	0x00 804C
18	ADC1	ACD1	Yes	Yes	Yes	Yes(5)	0x00 8050
19	TIM2/USART2	TIM2 update/overflow/ trigger/break USART2 transmission complete/transmit data register empty interrupt	-	-	Yes	Yes(5)	0x00 8054
20	TIM2/USART2	capture/ compare/USART2 interrupt	-	-	Yes	Yes(5)	0x00 8058

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 9. Interrupt mapping (continued)

IRQ No.	Source block	Description	Wakeup from Halt mode	Wakeup from Active-halt mode	Wakeup from Wait (WFI mode)	Wakeup from Wait (WFE mode)(1)	Vector address
21	TIM3/USART3	TIM3 update/overflow/ trigger/break USART3 transmission complete/transmit data register empty interrupt	-	-	Yes	Yes(5)	0x00 805C
22	TIM3/USART3	TIM3 capture/compareUSART3 Receive register data full/overrun/idle line detected/parity error/ interrupt	-	-	Yes	Yes(5)	0x00 8060
23	TIM1	Update /overflow/trigger/ COM	-	-	-	Yes(5)	0x00 8064
24	TIM1	Capture/compare	-	-	-	Yes(5)	0x00 8068
25	TIM4	TIM4 update/overflow/ trigger	-	-	Yes	Yes(5)	0x00 806C
26	SPI1	End of Transfer	Yes	Yes	Yes	Yes(5)	0x00 8070
27	USART1/TIM5	USART1 transmission complete/transmit data register empty/ TIM5 update/overflow/ trigger/break	-	-	Yes	Yes(5)	0x00 8074
28	USART1/TIM5	USART1 received data ready/overrun error/ idle line detected/parity error/TIM5 capture/compare	-	-	Yes	Yes(5)	0x00 8078
29	I^2C1/SPI2	I^2C1 interrupt(4)/SPI2	Yes	Yes	Yes	Yes(5)	0x00 807C

1. The Low power wait mode is entered when executing a WFE instruction in Low power run mode.
2. The TLI interrupt is the logic OR between TIM2 overflow interrupt, and TIM4 overflow interrupts.
3. The interrupt from PVD is logically OR-ed with Port E and F interrupts. Register EXTI_CONF allows to select between Port E and Port F interrupt (see *External interrupt port select register (EXTI_CONF)* in the RM0031).
4. The device is woken up from Halt or Active-halt mode only when the address received matches the interface address.
5. In WFE mode, this interrupt is served if it has been previously enabled. After processing the interrupt, the processor goes back to WFE mode. When this interrupt is configured as a wakeup event, the CPU wakes up and resumes processing.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

7 Option bytes

Option bytes contain configurations for device hardware features as well as the memory protection of the device. They are stored in a dedicated memory block.

All option bytes can be modified in ICP mode (with SWIM) by accessing the EEPROM address. See *Table 10* for details on option byte addresses.

The option bytes can also be modified ‘on the fly’ by the application in IAP mode, except for the ROP, UBC and PCODESIZE values which can only be taken into account when they are modified in ICP mode (with the SWIM).

Refer to the STM8Lxx Flash programming manual (PM0054) and STM8 SWIM and Debug Manual (UM0320) for information on SWIM programming procedures.

Table 10. Option byte addresses

Address	Option name	Option byte No.	Option bits								Factory default setting
			7	6	5	4	3	2	1	0	
00 4800	Read-out protection (ROP)	OPT0	ROP[7:0]								0x00
00 4802	UBC (User Boot code size)	OPT1	UBC[7:0]								0x00
00 4807	PCODESIZE	OPT2	PCODE[7:0]								0x00
00 4808	Independent watchdog option	OPT3 [3:0]	Reserved				WWDG_HALT	WWDG_HW	IWDG_HALT	IWDG_HW	0x00
00 4809	Number of stabilization clock cycles for HSE and LSE oscillators	OPT4	Reserved				LSECNT[1:0]		HSECNT[1:0]		0x00
00 480A	Brownout reset (BOR)	OPT5 [3:0]	Reserved				BOR_TH			BOR_ON	0x01
00 480B	Bootloader option bytes (OPTBL)	OPTBL [15:0]	OPTBL[15:0]								0x00
00 480C											0x00

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 11. Option byte description

Option byte no.	Option description
OPT0	**ROP[7:0]** Memory readout protection (ROP) 0xAA: Disable readout protection (write access via SWIM protocol) Refer to Readout protection section in the STM8L reference manual (RM0031).
OPT1	**UBC[7:0]** Size of the user boot code area UBC[7:0] Size of the user boot code area 0x00: No UBC 0x01: Page 0 reserved for the UBC and write protected. ... 0xFF: Page 0 to 254 reserved for the UBC and write-protected. Refer to User boot code section in the STM8L reference manual (RM0031).
OPT2	**PCODESIZE[7:0]** Size of the proprietary code area 0x00: No proprietary code area 0x01: Page 0 reserved for the proprietary code and read/write protected. ... 0xFF: Page 0 to 254 reserved for the proprietary code and read/write protected. Refer to Proprietary code area (PCODE) section in the STM8L reference manual (RM0031) for more details.
OPT3	**IWDG_HW:** Independent watchdog 0: Independent watchdog activated by software 1: Independent watchdog activated by hardware
	IWDG_HALT: Independent watchdog off in Halt/Active-halt 0: Independent watchdog continues running in Halt/Active-halt mode 1: Independent watchdog stopped in Halt/Active-halt mode
	WWDG_HW: Window watchdog 0: Window watchdog activated by software 1: Window watchdog activated by hardware
	WWDG_HALT: Window window watchdog reset on Halt/Active-halt 0: Window watchdog stopped in Halt mode 1: Window watchdog generates a reset when MCU enters Halt mode
OPT4	**HSECNT**: Number of HSE oscillator stabilization clock cycles 0x00 - 1 clock cycle 0x01 - 16 clock cycles 0x10 - 512 clock cycles 0x11 - 4096 clock cycles
	LSECNT: Number of LSE oscillator stabilization clock cycles 0x00 - 1 clock cycle 0x01 - 16 clock cycles 0x10 - 512 clock cycles 0x11 - 4096 clock cycles

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 11. Option byte description (continued)

Option byte no.	Option description
OPT5	**BOR_ON**: 0: Brownout reset off 1: Brownout reset on
	BOR_TH[3:1]: Brownout reset thresholds. Refer to *Table 16* for details on the thresholds according to the value of BOR_TH bits.
OPTBL	**OPTBL[15:0]**: This option is checked by the boot ROM code after reset. Depending on the content of addresses 00 480B, 00 480C and 0x8000 (reset vector) the CPU jumps to the bootloader or to the reset vector. Refer to the UM0560 bootloader user manual for more details.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8 Electrical parameters

8.1 Parameter conditions

Unless otherwise specified, all voltages are referred to V_{SS}.

8.1.1 Minimum and maximum values

Unless otherwise specified the minimum and maximum values are guaranteed in the worst conditions of ambient temperature, supply voltage and frequencies by tests in production on 100% of the devices with an ambient temperature at T_A= 25 °C and T_A = T_A max (given by the selected temperature range).

Data based on characterization results, design simulation and/or technology characteristics are indicated in the table footnotes and are not tested in production. Based on characterization, the minimum and maximum values refer to sample tests and represent the mean value plus or minus three times the standard deviation (mean±3Σ).

8.1.2 Typical values

Unless otherwise specified, typical data are based on T_A = 25 °C, V_{DD} = 3 V. They are given only as design guidelines and are not tested.

Typical ADC accuracy values are determined by characterization of a batch of samples from a standard diffusion lot over the full temperature range, where 95% of the devices have an error less than or equal to the value indicated (mean±2Σ).

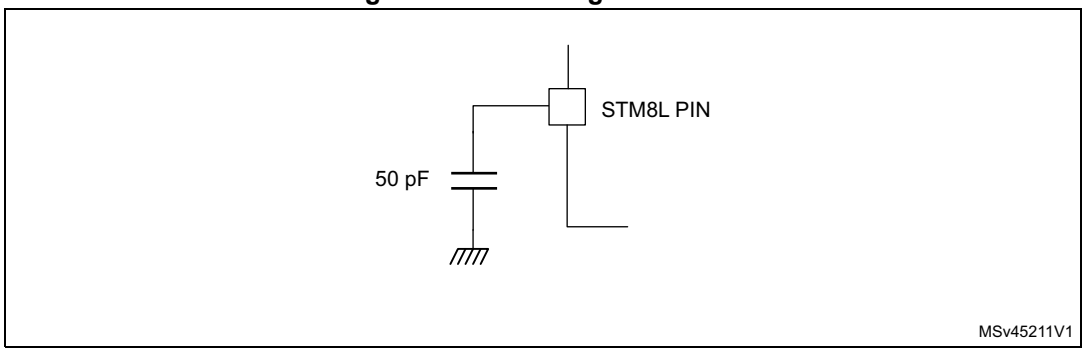
8.1.3 Typical curves

Unless otherwise specified, all typical curves are given only as design guidelines and are not tested.

8.1.4 Loading capacitor

The loading conditions used for pin parameter measurement are shown in *Figure 5*.

Figure 5. Pin loading conditions

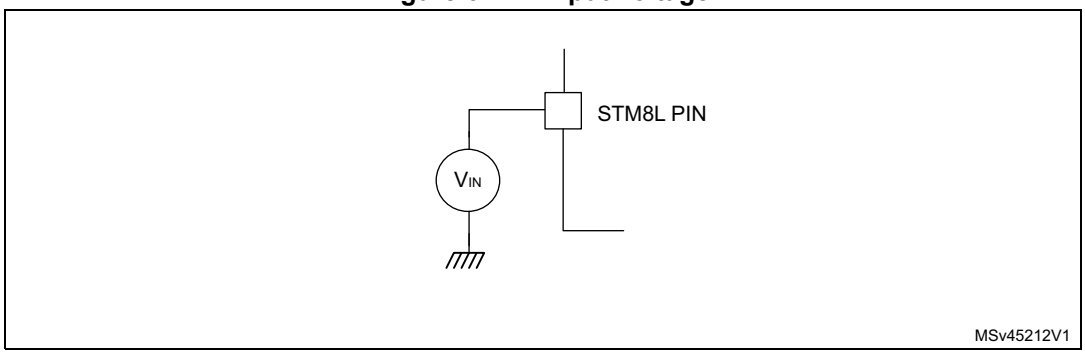


深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8.1.5 Pin input voltage

The input voltage measurement on a pin of the device is described in *Figure 6*.

Figure 6. Pin input voltage



8.2 Absolute maximum ratings

Stresses above the absolute maximum ratings listed in *Table 12: Voltage characteristics*, *Table 13: Current characteristics* and *Table 14: Thermal characteristics* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

The device's mission profile (application conditions) is compliant with the JEDEC JESD47 Qualification Standard, the extended mission profiles are available on demand.

Table 12. Voltage characteristics

Symbol	Ratings	Min	Max	Unit
V_{DD}- V_{SS}	External supply voltage (including V_{DDA})(1)	- 0.3	4.0	V
V_{IN}(2)	Input voltage on true open-drain pins (PC0 and PC1)	V_{SS} - 0.3	V_{DD} + 4.0	
	Input voltage on five-volt tolerant (FT) pins	V_{SS} - 0.3	V_{DD} + 4.0	
	Input voltage on any other pin	V_{SS} - 0.3	4.0	
V_{ESD}	Electrostatic discharge voltage	see *Absolute maximum ratings (electrical sensitivity) on page 105*		

1. All power (V_{DD1}, V_{DD2}, V_{DD3}, V_{DD4}, V_{DDA}) and ground (V_{SS1}, V_{SS2}, V_{SS3}, V_{SS4}, V_{SSA}) pins must always be connected to the external power supply.
2. V_{IN} maximum must always be respected. Refer to *Table 13.* for maximum allowed injected current values.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 13. Current characteristics

Symbol	Ratings	Max.	Unit
I_{VDD}	Total current into V_{DD} power line (source)	80	mA
I_{VSS}	Total current out of V_{SS} ground line (sink)	80	
I_{IO}	Output current sunk by IR_TIM pin (with high sink LED driver capability)	80	
	Output current sunk by any other I/O and control pin	25	
	Output current sourced by any I/Os and control pin	- 25	
$I_{INJ(PIN)}$	Injected current on true open-drain pins (PC0 and PC1)(1)	- 5 / +0	
	Injected current on five-volt tolerant (FT) pins(1)	- 5 / +0	
	Injected current on any other pin (2)	- 5 / +5	
$\Sigma I_{INJ(PIN)}$	Total injected current (sum of all I/O and control pins) (3)	± 25	

1. Positive injection is not possible on these I/Os. A negative injection is induced by $V_{IN}<V_{SS}$. $I_{INJ(PIN)}$ must never be exceeded. Refer to *Table 12.* for maximum allowed input voltage values.
2. A positive injection is induced by $V_{IN}>V_{DD}$ while a negative injection is induced by $V_{IN}<V_{SS}$. $I_{INJ(PIN)}$ must never be exceeded. Refer to *Table 12.* for maximum allowed input voltage values.
3. When several inputs are submitted to a current injection, the maximum $\Sigma I_{INJ(PIN)}$ is the absolute sum of the positive and negative injected currents (instantaneous values).

Table 14. Thermal characteristics

Symbol	Ratings	Value	Unit
T_{STG}	Storage temperature range	-65 to +150	° C
T_J	Maximum junction temperature	150	

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8.3 Operating conditions

Subject to general operating conditions for V_{DD} and T_A.

8.3.1 General operating conditions

Table 15. General operating conditions

Symbol	Parameter	Conditions	Min.	Max.	Unit
f_{SYSCLK}(1)	System clock frequency	1.8 V ≤V_{DD} < 3.6 V	0	16	MHz
V_{DD}	Standard operating voltage	-	1.8	3.6	V
V_{DDA}	Analog operating voltage	Must be at the same potential as V_{DD}	1.8	3.6	V
P_D(2)	Power dissipation at T_A= 85 °C	LQFP64	-	288	mW
T_A	Temperature range	1.8 V ≤V_{DD} < 3.6 V	-40	85	°C
T_J	Junction temperature range	-40 °C ≤T_A < 85 °C	-40	105(3)	

1. $f_{SYSCLK} = f_{CPU}$
2. To calculate $P_{Dmax}(T_A)$, use the formula $P_{Dmax}=(T_{Jmax} - T_A)/\Theta_{JA}$ with T_{Jmax} in this table and Θ_{JA} in “Thermal characteristics” table.
3. T_{Jmax} is given by the test limit. Above this value the product behavior is not guaranteed.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8.3.2 Embedded reset and power control block characteristics

Table 16. Embedded reset and power control block characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
t_{VDD}	V_{DD} rise time rate	BOR detector enabled	0(1)	-	∞(1)	µs/V
		BOR detector disabled	0(1)	-	1(1)	ms/V
	V_{DD} fall time rate	BOR detector enabled	20(1)	-	∞(1)	µs/V
		BOR detector disabled	Reset below voltage functional range			
t_{TEMP}	Reset release delay	V_{DD} rising BOR detector enabled	-	3	-	ms
		V_{DD} rising BOR detector disabled	-	1	-	
V_{POR}	Power-on reset threshold	Rising edge	1.3(2)	1.5	1.65	V
V_{PDR}	Power-down reset threshold	Falling edge	1.3(2)	1.5	1.65	
V_{BOR0}	Brown-out reset threshold 0 (BOR_TH[2:0]=000)	Falling edge	1.67	1.7	1.74	
		Rising edge	1.69	1.75	1.80	
V_{BOR1}	Brown-out reset threshold 1 (BOR_TH[2:0]=001)	Falling edge	1.87	1.93	1.97	
		Rising edge	1.96	2.04	2.07	
V_{BOR2}	Brown-out reset threshold 2 (BOR_TH[2:0]=010)	Falling edge	2.22	2.3	2.35	
		Rising edge	2.31	2.41	2.44	
V_{BOR3}	Brown-out reset threshold 3 (BOR_TH[2:0]=011)	Falling edge	2.45	2.55	2.60	
		Rising edge	2.54	2.66	2.7	
V_{BOR4}	Brown-out reset threshold 4 (BOR_TH[2:0]=100)	Falling edge	2.68	2.80	2.85	
		Rising edge	2.78	2.90	2.95	

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

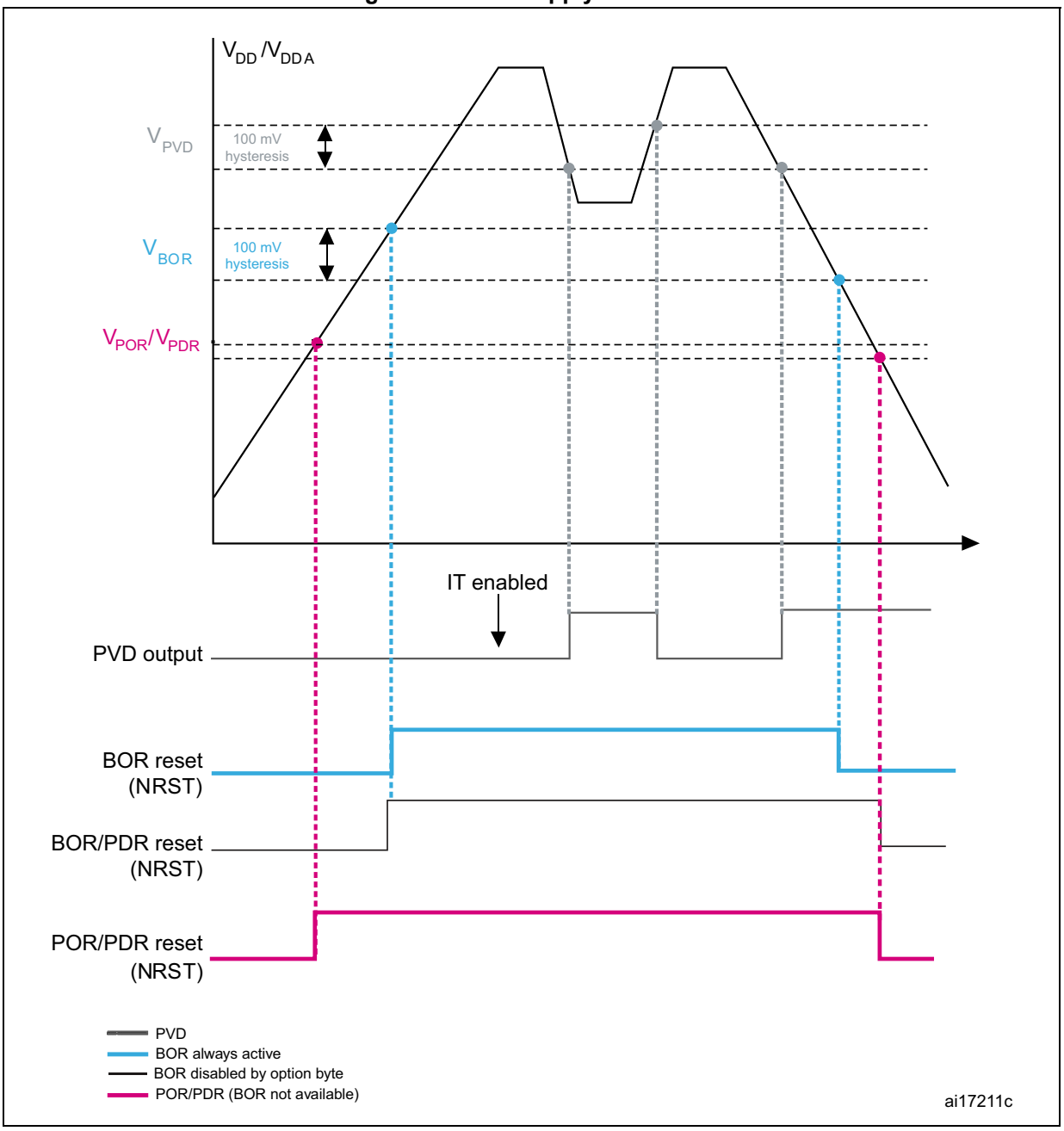
Table 16. Embedded reset and power control block characteristics (continued)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{PVD0}	PVD threshold 0	Falling edge	1.80	1.84	1.88	V
		Rising edge	1.88	1.94	1.99	
V_{PVD1}	PVD threshold 1	Falling edge	1.98	2.04	2.09	
		Rising edge	2.08	2.14	2.18	
V_{PVD2}	PVD threshold 2	Falling edge	2.2	2.24	2.28	
		Rising edge	2.28	2.34	2.38	
V_{PVD3}	PVD threshold 3	Falling edge	2.39	2.44	2.48	
		Rising edge	2.47	2.54	2.58	
V_{PVD4}	PVD threshold 4	Falling edge	2.57	2.64	2.69	
		Rising edge	2.68	2.74	2.79	
V_{PVD5}	PVD threshold 5	Falling edge	2.77	2.83	2.88	
		Rising edge	2.87	2.94	2.99	
V_{PVD6}	PVD threshold 6	Falling edge	2.97	3.05	3.09	
		Rising edge	3.08	3.15	3.20	
Vhyst	Hysteresis voltage	BOR0 threshold	-	40	-	mV
		All BOR and PVD thresholds excepting BOR0	-	100	-	

1. Guaranteed by design.
2. Guaranteed by characterization results.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 7. Power supply thresholds



深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8.3.3 Supply current characteristics

Total current consumption

The MCU is placed under the following conditions:

- All I/O pins in input mode with a static value at V_{DD} or V_{SS} (no load)
- All peripherals are disabled except if explicitly mentioned.

In the following table, data are based on characterization results, unless otherwise specified.

Subject to general operating conditions for V_{DD} and T_A.

Table 17. Total current consumption in Run mode

Symbol	Parameter	Conditions[1]			Typ.	Max.		Unit
						55°C	85 °C	
$I_{DD(RUN)}$	Supply current in run mode[2]	All peripherals OFF, code executed from RAM, V_{DD} from 1.8 V to 3.6 V	HSI RC osc. (16 MHz)[3]	f_{CPU} = 125 kHz	0.22	0.28	0.39	mA
				f_{CPU} = 1 MHz	0.32	0.38	0.49	
				f_{CPU} = 4 MHz	0.59	0.65	0.76	
				f_{CPU} = 8 MHz	0.93	0.99	1.1	
				f_{CPU} = 16 MHz	1.62	1.68	1.79[4]	
			HSE external clock (f_{CPU}=f_{HSE})[5]	f_{CPU} = 125 kHz	0.21	0.25	0.35	
				f_{CPU} = 1 MHz	0.3	0.34	0.44	
				f_{CPU} = 4 MHz	0.57	0.61	0.71	
				f_{CPU} = 8 MHz	0.95	0.99	1.09	
				f_{CPU} = 16 MHz	1.73	1.77	1.87[4]	
			LSI RC osc. (typ. 38 kHz)	f_{CPU} = f_{LSI}	0.029	0.035	0.039	
			LSE external clock (32.768 kHz)	f_{CPU} = f_{LSE}	0.028	0.034	0.038	

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

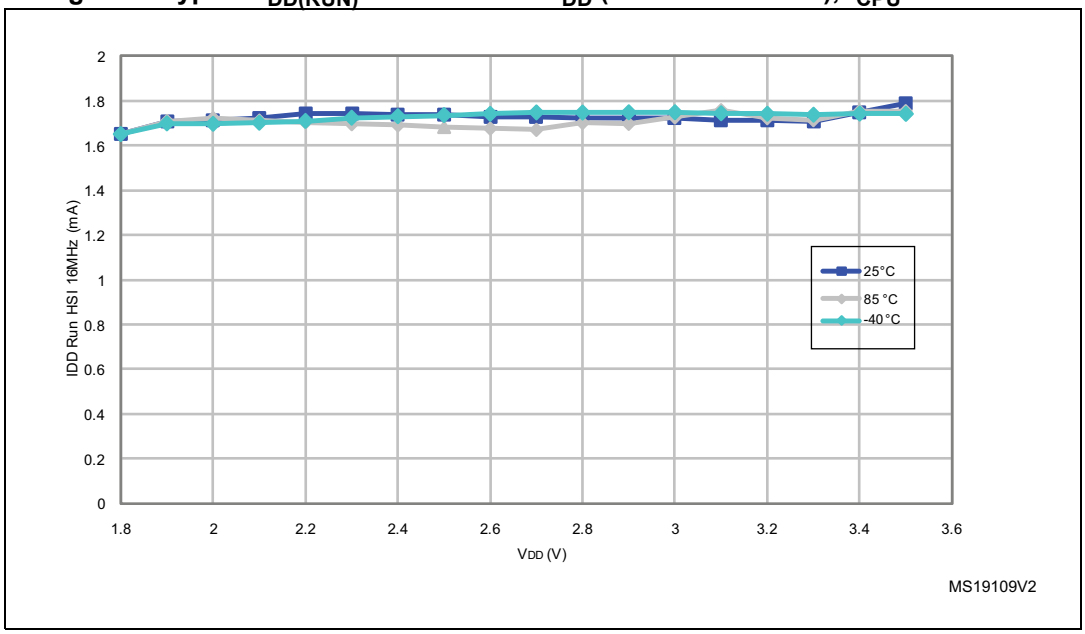
Table 17. Total current consumption in Run mode (continued)

Symbol	Parameter	Conditions[1]			Typ.	Max.		Unit
						55°C	85 °C	
$I_{DD(RUN)}$	Supply current in Run mode	All peripherals OFF, code executed from Flash, V_{DD} from 1.8 V to 3.6 V	HSI RC osc.[6]	f_{CPU} = 125 kHz	0.35	0.46	0.48	mA
				f_{CPU} = 1 MHz	0.54	0.65	0.67	
				f_{CPU} = 4 MHz	1.16	1.27	1.29	
				f_{CPU} = 8 MHz	1.97	2.08	2.1	
				f_{CPU} = 16 MHz	3.54	3.65	3.67	
			HSE external clock (f_{CPU}=f_{HSE}) [5]	f_{CPU} = 125 kHz	0.35	0.44	0.46	
				f_{CPU} = 1 MHz	0.53	0.62	0.64	
				f_{CPU} = 4 MHz	1.13	1.22	1.24	
				f_{CPU} = 8 MHz	2	2.09	2.11	
				f_{CPU} = 16 MHz	3.69	3.78	3.8	
			LSI RC osc.	f_{CPU} = f_{LSI}	0.110	0.123	0.130	
			LSE external clock (32.768 kHz)[7]	f_{CPU} = f_{LSE}	0.100	0.101	0.104	

1. All peripherals OFF, V_{DD} from 1.8 V to 3.6 V, HSI internal RC osc., f_{CPU}=f_{SYSCLK}
2. CPU executing typical data processing
3. The run from RAM consumption can be approximated with the linear formula: I_{DD}(run_from_RAM) = Freq. * 95 µA/MHz + 250 µA
4. Tested in production.
5. Oscillator bypassed (HSEBYP = 1 in CLK_ECKCR). When configured for external crystal, the HSE consumption ($I_{DD\ HSE}$) must be added. Refer to *Table 28*.
6. The run from Flash consumption can be approximated with the linear formula: I_{DD}(run_from_Flash) = Freq. * 200 µA/MHz + 330 µA
7. Oscillator bypassed (LSEBYP = 1 in CLK_ECKCR). When configured for external crystal, the LSE consumption ($I_{DD\ LSE}$) must be added. Refer to *Table 29*

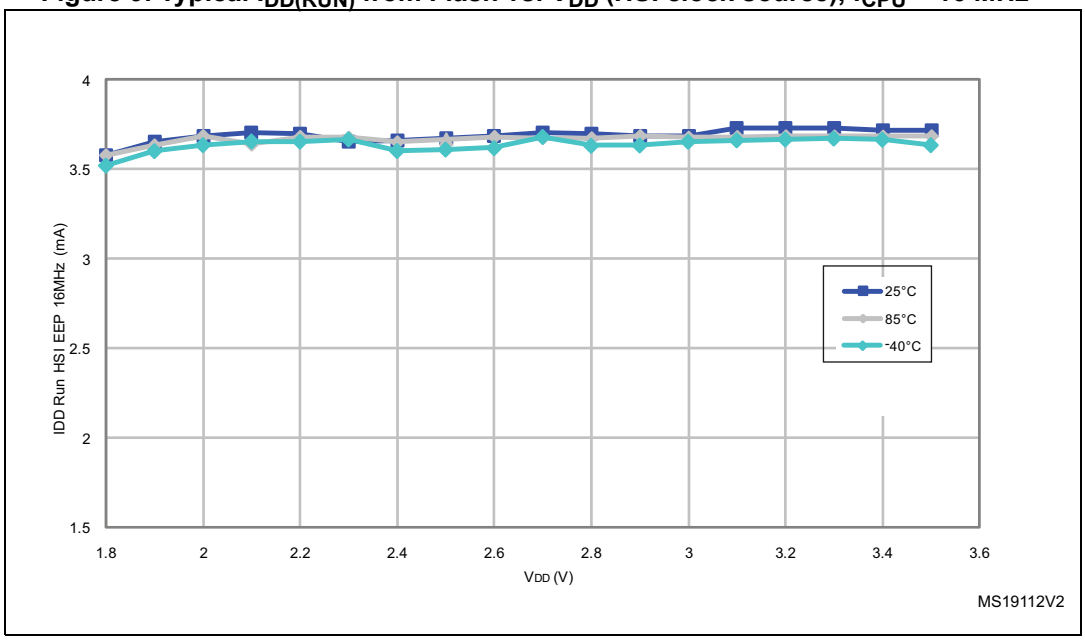
深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 8. Typical $I_{DD(RUN)}$ from RAM vs. V_{DD} (HSI clock source), f_{CPU} =16 MHz 1)



1. Typical current consumption measured with code executed from RAM.

Figure 9. Typical $I_{DD(RUN)}$ from Flash vs. V_{DD} (HSI clock source), f_{CPU} = 16 MHz1)



1. Typical current consumption measured with code executed from Flash.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

In the following table, data are based on characterization results, unless otherwise specified.

Table 18. Total current consumption in Wait mode

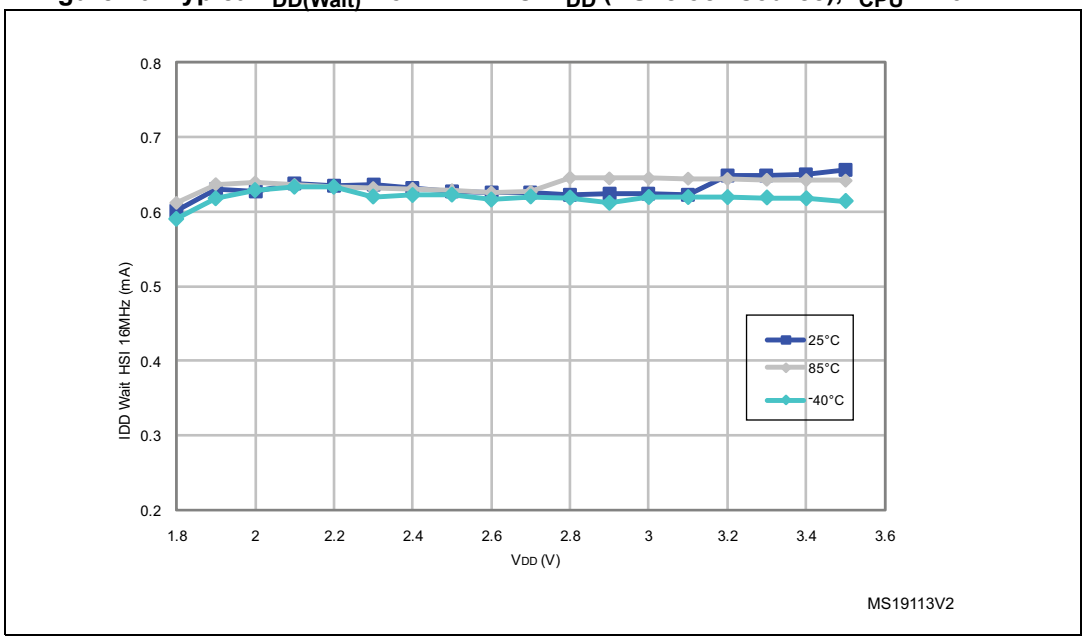
Symbol	Parameter	Conditions(1)			Typ	Max		Unit
						55°C	85 °C	
$I_{DD(Wait)}$	Supply current in Wait mode	CPU not clocked, all peripherals OFF, code executed from RAM with Flash in I_{DDQ} mode,(2) V_{DD} from 1.8 V to 3.6 V	HSI	f_{CPU} = 125 kHz	0.21	0.29	0.33	mA
				f_{CPU} = 1 MHz	0.25	0.33	0.37	
				f_{CPU} = 4 MHz	0.32	0.4	0.44	
				f_{CPU} = 8 MHz	0.42	0.496	0.54	
				f_{CPU} = 16 MHz	0.66	0.736	0.78(3)	
			HSE external clock (f_{CPU}=f_{HSE})(4)	f_{CPU} = 125 kHz	0.19	0.21	0.3	
				f_{CPU} = 1 MHz	0.2	0.23	0.32	
				f_{CPU} = 4 MHz	0.27	0.3	0.39	
				f_{CPU} = 8 MHz	0.37	0.4	0.49	
				f_{CPU} = 16 MHz	0.63	0.66	0.75(3)	
			LSI	f_{CPU} = f_{LSI}	0.028	0.037	0.039	
			LSE(5) external clock (32.768 kHz)	f_{CPU} = f_{LSE}	0.027	0.035	0.038	
		CPU not clocked, all peripherals OFF, code executed from Flash, V_{DD} from 1.8 V to 3.6 V	HSI	f_{CPU} = 125 kHz	0.27	0.36	0.42	mA
				f_{CPU} = 1 MHz	0.29	0.38	0.44	
				f_{CPU} = 4 MHz	0.37	0.46	0.52	
				f_{CPU} = 8 MHz	0.45	0.55	0.61	
				f_{CPU} = 16 MHz	0.69	0.79	0.85	
			HSE(4) external clock (f_{CPU}= HSE)	f_{CPU} = 125 kHz	0.23	0.29	0.32	
				f_{CPU} = 1 MHz	0.24	0.31	0.34	
				f_{CPU} = 4 MHz	0.32	0.39	0.42	
				f_{CPU} = 8 MHz	0.42	0.49	0.51	
				f_{CPU} = 16 MHz	0.7	0.77	0.79	
			LSI	f_{CPU} = f_{LSI}	0.037	0.085	0.105	
			LSE(5) external clock (32.768 kHz)	f_{CPU} = f_{LSE}	0.036	0.082	0.095	

1. All peripherals OFF, V_{DD} from 1.8 V to 3.6 V, HSI internal RC osc., f_{CPU} = f_{SYSCLK}
2. Flash is configured in I_{DDQ} mode in Wait mode by setting the EPM or WAITM bit in the Flash_CR1 register.
3. Tested in production.
4. Oscillator bypassed (HSEBYP = 1 in CLK_ECKCR). When configured for external crystal, the HSE consumption ($I_{DD\ HSE}$) must be added. Refer to *Table 28*.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

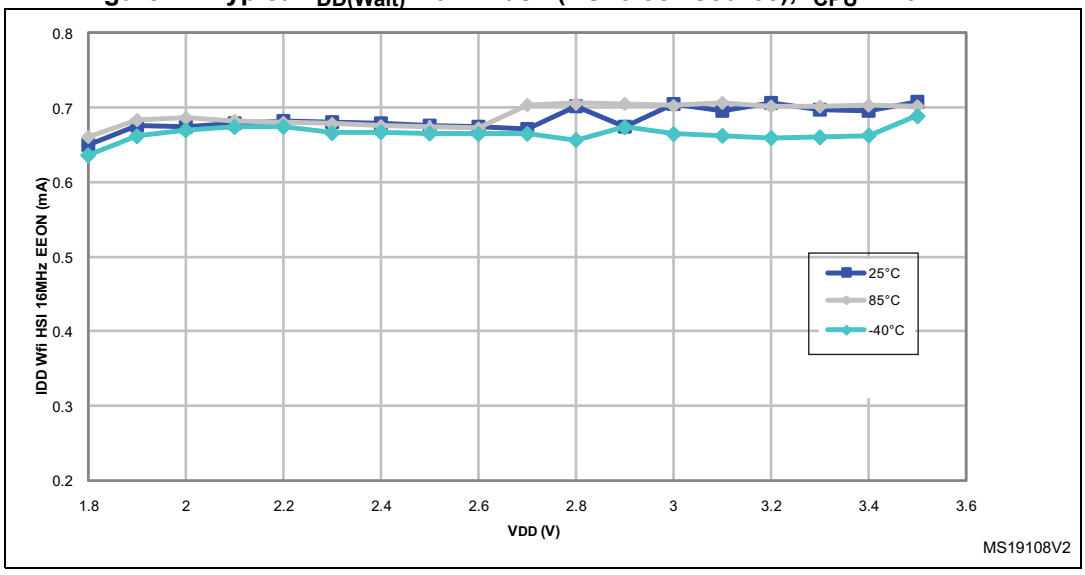
5. Oscillator bypassed (LSEBYP = 1 in CLK_ECKCR). When configured for external crystal, the LSE consumption ($I_{DD\ HSE}$) must be added. Refer to *Table 29*

Figure 10. Typical $I_{DD(Wait)}$ from RAM vs. V_{DD} (HSI clock source), f_{CPU} = 16 MHz 1)



1. Typical current consumption measured with code executed from RAM.

Figure 11. Typical $I_{DD(Wait)}$ from Flash (HSI clock source), f_{CPU} = 16 MHz 1)



1. Typical current consumption measured with code executed from Flash.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

In the following table, data are based on characterization results, unless otherwise specified.

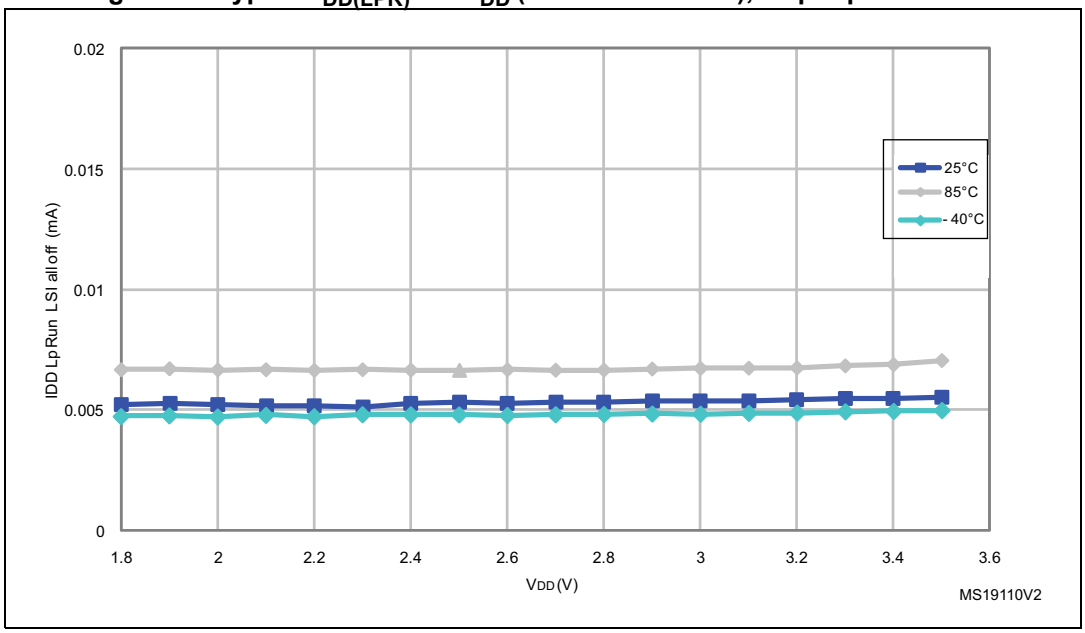
Table 19. Total current consumption and timing in Low power run mode at V_{DD} = 1.8 V to 3.6 V

Symbol	Parameter	Conditions[1]			Typ.	Max.	Unit
$I_{DD(LPR)}$	Supply current in Low power run mode	LSI RC osc. (at 38 kHz)	all peripherals OFF	T_A = -40 °C to 25 °C	5.86	6.38	µA
				T_A = 55 °C	6.52	7.06	
				T_A = 85 °C	7.68	8.7	
			with TIM2 active[2]	T_A = -40 °C to 25 °C	6.2	6.73	
				T_A = 55 °C	6.86	7.41	
				T_A = 85 °C	9.71	10.81	
		LSE [3] external clock (32.768 kHz)	all peripherals OFF	T_A = -40 °C to 25 °C	5.42	5.94	
				T_A = 55 °C	5.9	6.52	
				T_A = 85 °C	6.14	6.8	
			with TIM2 active [2]	T_A = -40 °C to 25 °C	5.87	6.48	
				T_A = 55 °C	6.44	6.95	
				T_A = 85 °C	6.7	7.65	

1. No floating I/Os
2. Timer 2 clock enabled and counter running
3. Oscillator bypassed (LSEBYP = 1 in CLK_ECKCR). When configured for external crystal, the LSE consumption ($I_{DD\ LSE}$) must be added. Refer to *Table 29*

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 12. Typical $I_{DD(LPR)}$ vs. V_{DD} (LSI clock source), all peripherals OFF



深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

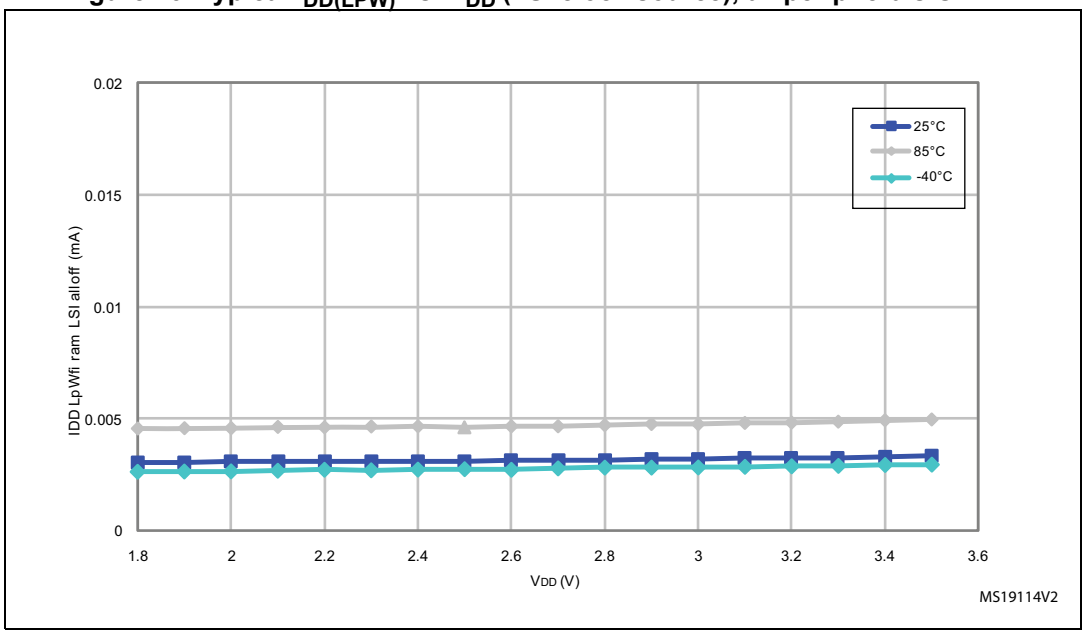
In the following table, data are based on characterization results, unless otherwise specified.

Table 20. Total current consumption in Low power wait mode at V_{DD} = 1.8 V to 3.6 V

Symbol	Parameter	Conditions(1)			Typ.	Max.	Unit
$I_{DD(LPW)}$	Supply current in Low power wait mode	LSI RC osc. (at 38 kHz)	all peripherals OFF	T_A = -40 °C to 25 °C	3.03	3.41	µA
				T_A = 55 °C	3.38	3.78	
				T_A = 85 °C	4.6	5.34	
			with TIM2 active(2)	T_A = -40 °C to 25 °C	3.78	4.21	
				T_A = 55 °C	4.13	4.57	
				T_A = 85 °C	5.29	6.08	
		LSE external clock(3) (32.768 kHz)	all peripherals OFF	T_A = -40 °C to 25 °C	2.46	2.89	
				T_A = 55 °C	2.58	3.07	
				T_A = 85 °C	3.32	4.05	
			with TIM2 active (2)	T_A = -40 °C to 25 °C	2.88	3.29	
				T_A = 55 °C	2.97	3.42	
				T_A = 85 °C	3.69	4.55	

1. No floating I/Os.
2. Timer 2 clock enabled and counter is running.
3. Oscillator bypassed (LSEBYP = 1 in CLK_ECKCR). When configured for external crystal, the LSE consumption ($I_{DD\ LSE}$) must be added. Refer to *Table 29*.

Figure 13. Typical $I_{DD(LPW)}$ vs. V_{DD} (LSI clock source), all peripherals OFF (1)



1. Typical current consumption measured with code executed from RAM.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

In the following table, data are based on characterization results, unless otherwise specified.

Table 21. Total current consumption and timing in Active-halt mode at V_{DD} = 1.8 V to 3.6 V

Symbol	Parameter	Conditions[1]			Typ.	Max.	Unit
$I_{DD(AH)}$	Supply current in Active-halt mode	LSI RC (at 38 kHz)	LCD OFF[2]	T_A = -40 °C to 25 °C	0.92	2.25	µA
				T_A = 55 °C	1.32	3.44	
				T_A = 85 °C	1.63	3.87	
			LCD ON (static duty/ external V_{LCD}) [3]	T_A = -40 °C to 25 °C	1.56	3.6	
				T_A = 55 °C	1.64	3.8	
				T_A = 85 °C	2.12	5.03	
			LCD ON (1/4 duty/ external V_{LCD}) [4]	T_A = -40 °C to 25 °C	1.92	4.56	
				T_A = 55 °C	2.1	4.97	
				T_A = 85 °C	2.6	6.14	
			LCD ON (1/4 duty/ internal V_{LCD}) [5]	T_A = -40 °C to 25 °C	4.2	9.88	
				T_A = 55 °C	4.39	10.32	
				T_A = 85 °C	4.84	11.5	
$I_{DD(AH)}$	Supply current in Active-halt mode	LSE external clock (32.768 kHz) [6]	LCD OFF[7]	T_A = -40 °C to 25 °C	0.54	1.35	µA
				T_A = 55 °C	0.61	1.44	
				T_A = 85 °C	0.91	2.27	
			LCD ON (static duty/ external V_{LCD}) [3]	T_A = -40 °C to 25 °C	0.91	2.13	
				T_A = 55 °C	1.05	2.55	
				T_A = 85 °C	1.42	3.65	
			LCD ON (1/4 duty/ external V_{LCD}) [4]	T_A = -40 °C to 25 °C	1.6	2.84	
				T_A = 55 °C	1.76	4.37	
				T_A = 85 °C	2.14	5.23	
			LCD ON (1/4 duty/ internal V_{LCD}) [5]	T_A = -40 °C to 25 °C	3.89	9.15	
				T_A = 55 °C	3.89	9.15	
				T_A = 85 °C	4.25	10.49	
$I_{DD(WUFAH)}$	Supply current during wakeup time from Active-halt mode (using HSI)	-	-	-	2.4	-	mA

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 21. Total current consumption and timing in Active-halt mode at V_{DD} = 1.8 V to 3.6 V (continued)

Symbol	Parameter	Conditions[1]			Typ.	Max.	Unit
$t_{WU_HSI(AH)}$[8][9]	Wakeup time from Active-halt mode to Run mode (using HSI)	-	-	-	4.7	7	µs
$t_{WU_LSI(AH)}$[8][9]	Wakeup time from Active-halt mode to Run mode (using LSI)	-	-	-	150	-	µs

1. No floating I/O, unless otherwise specified.
2. RTC enabled. Clock source = LSI
3. RTC enabled, LCD enabled with external V_{LCD} = 3 V, static duty, division ratio = 256, all pixels active, no LCD connected.
4. RTC enabled, LCD enabled with external V_{LCD}, 1/4 duty, 1/3 bias, division ratio = 64, all pixels active, no LCD connected.
5. LCD enabled with internal LCD booster V_{LCD} = 3 V, 1/4 duty, 1/3 bias, division ratio = 64, all pixels active, no LCD connected.
6. Oscillator bypassed (LSEBYP = 1 in CLK_ECKCR). When configured for external crystal, the LSE consumption ($I_{DD\ LSE}$) must be added. Refer to *Table 29*
7. RTC enabled. Clock source = LSE
8. Wakeup time until start of interrupt vector fetch. The first word of interrupt routine is fetched 4 CPU cycles after t_{WU}.
9. ULP=0 or ULP=1 and FWU=1 in the PWR_CSR2 register.

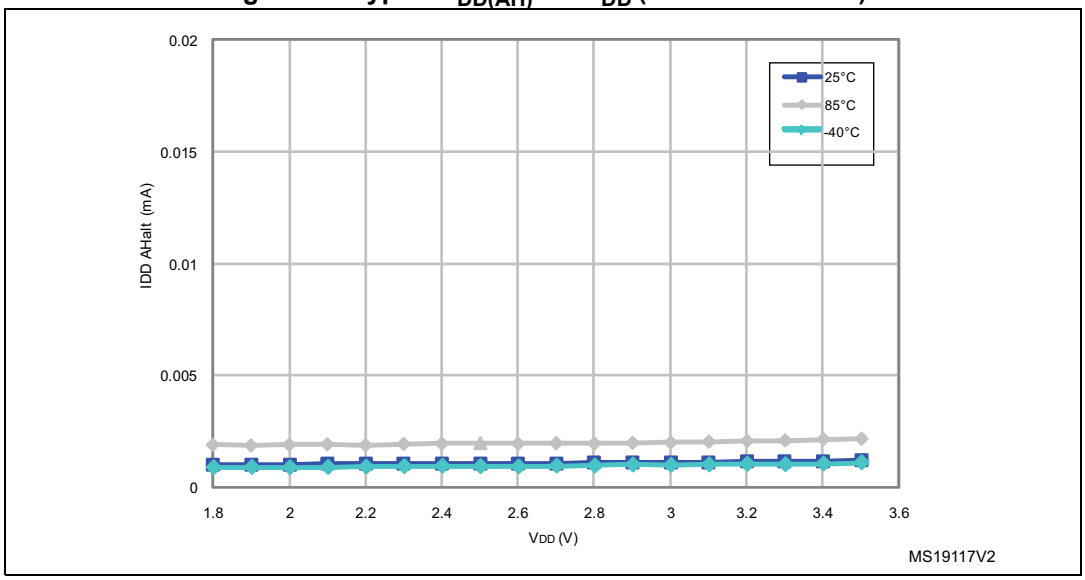
Table 22. Typical current consumption in Active-halt mode, RTC clocked by LSE external crystal

Symbol	Parameter	Condition[1]		Typ.	Unit
$I_{DD(AH)}$[2]	Supply current in Active-halt mode	V_{DD} = 1.8 V	LSE	1.2	µA
			LSE/32[3]	0.9	
		V_{DD} = 3 V	LSE	1.4	
			LSE/32[3]	1.1	
		V_{DD} = 3.6 V	LSE	1.6	
			LSE/32[3]	1.3	

1. No floating I/O, unless otherwise specified.
2. Based on measurements on bench with 32.768 kHz external crystal oscillator.
3. RTC clock is LSE divided by 32.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 14. Typical $I_{DD(AH)}$ vs. V_{DD} (LSI clock source)



深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

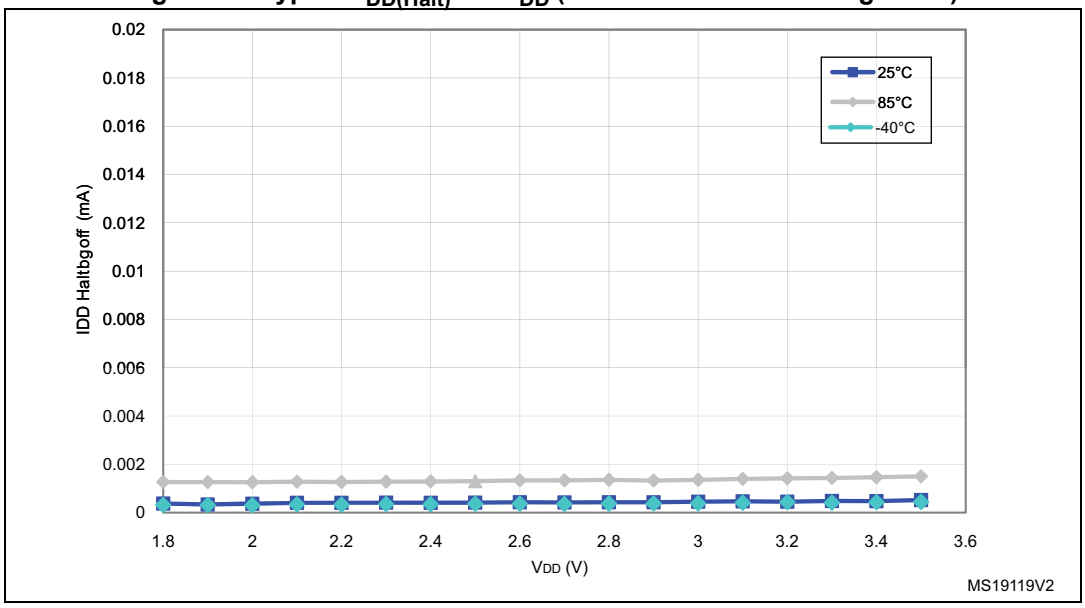
In the following table, data are based on characterization results, unless otherwise specified.

Table 23. Total current consumption and timing in Halt mode at V_{DD} = 1.8 to 3.6 V

Symbol	Parameter	Condition(1)	Typ.	Max.	Unit
$I_{DD(Halt)}$	Supply current in Halt mode (Ultra low power ULP bit =1 in the PWR_CSR2 register)	T_A = -40 °C to 25 °C	400	1600(2)	nA
		T_A = 55 °C	810	2400	
		T_A = 85 °C	1600	4500(2)	
$I_{DD(WUHalt)}$	Supply current during wakeup time from Halt mode (using HSI)	-	2.4	-	mA
$t_{WU_HSI(Halt)}$(3)(4)	Wakeup time from Halt to Run mode (using HSI)	-	4.7	7	µs
$t_{WU_LSI(Halt)}$(3)(4)	Wakeup time from Halt mode to Run mode (using LSI)	-	150	-	µs

1. T_A = -40 to 85 °C, no floating I/O, unless otherwise specified
2. Tested in production
3. ULP=0 or ULP=1 and FWU=1 in the PWR_CSR2 register
4. Wakeup time until start of interrupt vector fetch.
   The first word of interrupt routine is fetched 4 CPU cycles after t_{WU}

Figure 15. Typical $I_{DD(Halt)}$ vs. V_{DD} (internal reference voltage OFF)



深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Current consumption of on-chip peripherals

Table 24. Peripheral current consumption

Symbol	Parameter		Typ. V_{DD} = 3.0 V	Unit
$I_{DD(ALL)}$	Peripherals ON (1)		63	
$I_{DD(TIM1)}$	TIM1 supply current(2)		10	µA/MHz
$I_{DD(TIM2)}$	TIM2 supply current (2)		7	
$I_{DD(TIM3)}$	TIM3 supply current (2)		7	
$I_{DD(TIM5)}$	TIM5 supply current (2)		7	
$I_{DD(TIM4)}$	TIM4 timer supply current (2)		3	
$I_{DD(USART1)}$	USART1 supply current (3)		5	
$I_{DD(USART2)}$	USART2 supply current (3)		5	
$I_{DD(USART3)}$	USART3 supply current (3)		5	
$I_{DD(SPI1)}$	SPI1 supply current (3)		3	
$I_{DD(SPI2)}$	SPI2 supply current (3)		3	
$I_{DD(I2C1)}$	I^2C1 supply current (3)		4	
$I_{DD(DMA1)}$	DMA1 supply current		3	
$I_{DD(WWDG)}$	WWDG supply current		1	
$I_{DD(ADC1)}$	ADC1 supply current(4)		1500	µA
$I_{DD(PVD/BOR)}$	Power voltage detector and brownout Reset unit supply current (5)		2.6	
$I_{DD(BOR)}$	Brownout Reset unit supply current (5)		2.4	
$I_{DD(IDWDG)}$	Independent watchdog supply current	including LSI supply current	0.45	
		excluding LSI supply current	0.05	

1. Peripherals listed above the $I_{DD(ALL)}$ parameter ON: TIM1, TIM2, TIM3, TIM4, TIM5, USART1, USART2, USART3, SPI1, SPI2, I2C1, DMA1, WWDG.
2. Data based on a differential I_{DD} measurement between all peripherals OFF and a timer counter running at 16 MHz. The CPU is in Wait mode in both cases. No IC/OC programmed, no I/O pins toggling. Not tested in production.
3. Data based on a differential I_{DD} measurement between the on-chip peripheral in reset configuration and not clocked and the on-chip peripheral when clocked and not kept under reset. The CPU is in Wait mode in both cases. No I/O pins toggling. Not tested in production.
4. Data based on a differential I_{DD} measurement between ADC in reset configuration and continuous ADC conversion.
5. Including supply current of internal reference voltage.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 25. Current consumption under external reset

Symbol	Parameter	Conditions		Typ.	Unit
$I_{DD(RST)}$	Supply current under external reset (1)	PB1/PB3/PA5 pins are externally tied to V_{DD}	V_{DD} = 1.8 V	48	µA
			V_{DD} = 3 V	80	
			V_{DD} = 3.6 V	95	

1. All pins except PA0, PB0 and PB4 are floating under reset. PA0, PB0 and PB4 are configured with pull-up under reset. PB1, PB3 and PA5 must be tied externally under reset to avoid the consumption due to their schmitt trigger.

8.3.4 Clock and timing characteristics

HSE external clock (HSEBYP = 1 in CLK_ECKCR)

Subject to general operating conditions for V_{DD} and T_A.

Table 26. HSE external clock characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
f_{HSE_ext} (1)	External clock source frequency	-	1	-	16	MHz
V_{HSEH}	OSC_IN input pin high level voltage		0.7 x V_{DD}	-	V_{DD}	V
V_{HSEL}	OSC_IN input pin low level voltage		V_{SS}	-	0.3 x V_{DD}	
$C_{in(HSE)}$ (1)	OSC_IN input capacitance	-	-	2.6	-	pF
I_{LEAK_HSE}	OSC_IN input leakage current	$V_{SS} < V_{IN} < V_{DD}$	-	-	±1	µA

1. Guaranteed by design.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

LSE external clock (LSEBYP=1 in CLK_ECKCR)

Subject to general operating conditions for V_{DD} and T_A.

Table 27. LSE external clock characteristics

Symbol	Parameter	Min.	Typ.	Max.	Unit
f_{LSE_ext}(1)	External clock source frequency	-	32.768	-	kHz
V_{LSEH}(2)	OSC32_IN input pin high level voltage	0.7 x V_{DD}	-	V_{DD}	V
V_{LSEL}(2)	OSC32_IN input pin low level voltage	V_{SS}	-	0.3 x V_{DD}	
$C_{in(LSE)}$(1)	OSC32_IN input capacitance	-	0.6	-	pF
I_{LEAK_LSE}	OSC32_IN input leakage current	-	-	±1	µA

1. Guaranteed by design.
2. Guaranteed by characterization results.

HSE crystal/ceramic resonator oscillator

The HSE clock can be supplied with a 1 to 16 MHz crystal/ceramic resonator oscillator. All the information given in this paragraph is based on characterization results with specified typical external components. In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time. Refer to the crystal resonator manufacturer for more details (frequency, package, accuracy...).

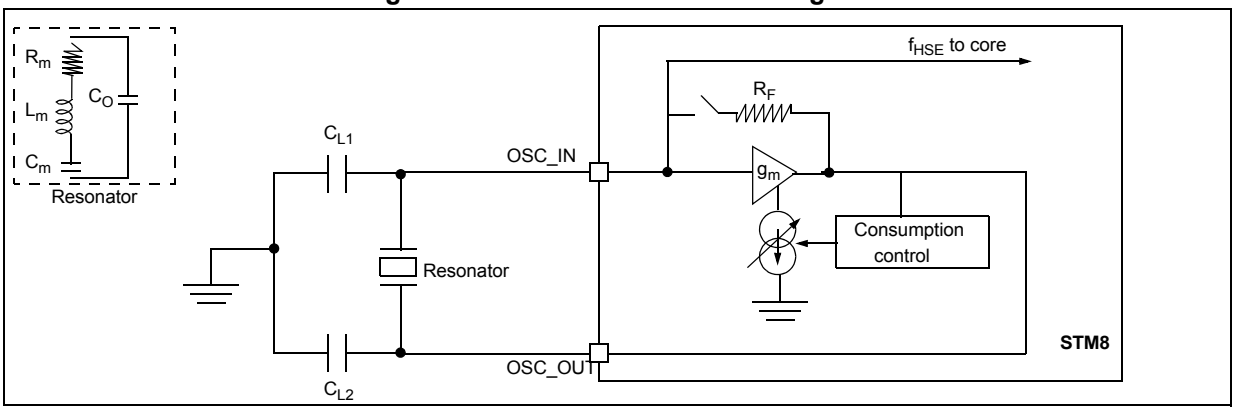
Table 28. HSE oscillator characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
f_{HSE}	High speed external oscillator frequency	-	1		16	MHz
R_F	Feedback resistor	-	-	200	-	kΩ
C(1)(2)	Recommended load capacitance	-	-	20	-	pF
$I_{DD(HSE)}$	HSE oscillator power consumption	C = 20 pF, f_{OSC} = 16 MHz	-	-	2.5 (startup) 0.7 (stabilized)(3)	mA
		C = 10 pF, f_{OSC} =16 MHz	-	-	2.5 (startup) 0.46 (stabilized)(3)	
g_m	Oscillator transconductance	-	3.5(3)	-	-	mA/V
$t_{SU(HSE)}$(4)	Startup time	V_{DD} is stabilized	-	1	-	ms

1. C=C_{L1}=C_{L2} is approximately equivalent to 2 x crystal C_{LOAD}.
2. The oscillator selection can be optimized in terms of supply current using a high quality resonator with small R_m value. Refer to crystal manufacturer for more details
3. Guaranteed by design.
4. $t_{SU(HSE)}$ is the startup time measured from the moment it is enabled (by software) to a stabilized 16 MHz oscillation. This value is measured for a standard crystal resonator and it can vary significantly with the crystal manufacturer.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 16. HSE oscillator circuit diagram



HSE oscillator critical g_m formula

$$g_{mcrit} = (2 \times \Pi \times f_{HSE})^2 \times R_m(2Co + C)^2$$

R_m: Motional resistance (see crystal specification), L_m: Motional inductance (see crystal specification),
C_m: Motional capacitance (see crystal specification), Co: Shunt capacitance (see crystal specification),
C_{L1}=C_{L2}=C: Grounded external capacitance
$g_m >> g_{mcrit}$

LSE crystal/ceramic resonator oscillator

The LSE clock can be supplied with a 32.768 kHz crystal/ceramic resonator oscillator. All the information given in this paragraph is based on characterization results with specified typical external components. In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time. Refer to the crystal resonator manufacturer for more details (frequency, package, accuracy...).

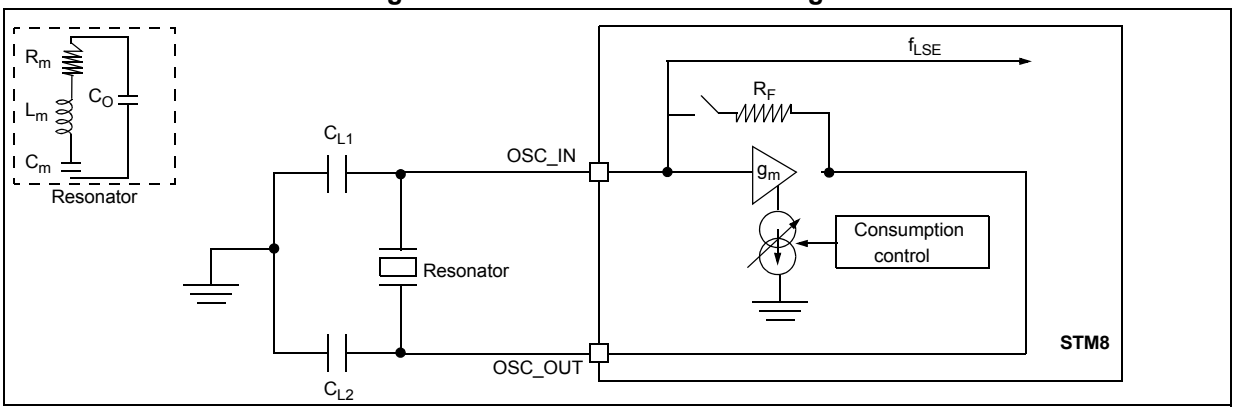
Table 29. LSE oscillator characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
f_{LSE}	Low speed external oscillator frequency	-	-	32.768	-	kHz
R_F	Feedback resistor	ΔV = 200 mV	-	1.2	-	MΩ
$C^{(1)(2)}$	Recommended load capacitance	-	-	8	-	pF
$I_{DD(LSE)}$	LSE oscillator power consumption	V_{DD} = 1.8 V	-	450	-	nA
		V_{DD} = 3 V	-	600	-	
		V_{DD} = 3.6 V	-	750	-	
g_m	Oscillator transconductance	-	$3^{(3)}$	-	-	µA/V
$t_{SU(LSE)}^{(4)}$	Startup time	V_{DD} is stabilized	-	1	-	s

1. C=C_{L1}=C_{L2} is approximately equivalent to 2 x crystal C_{LOAD}.
2. The oscillator selection can be optimized in terms of supply current using a high quality resonator with a small R_m value. Refer to crystal manufacturer for more details.
3. Guaranteed by design.
4. $t_{SU(LSE)}$ is the startup time measured from the moment it is enabled (by software) to a stabilized 32.768 kHz oscillation. This value is measured for a standard crystal resonator and it can vary significantly with the crystal manufacturer.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 17. LSE oscillator circuit diagram



Internal clock sources

Subject to general operating conditions for V_{DD}, and T_A.

High speed internal RC oscillator (HSI)

In the following table, data are based on characterization results, not tested in production, unless otherwise specified.

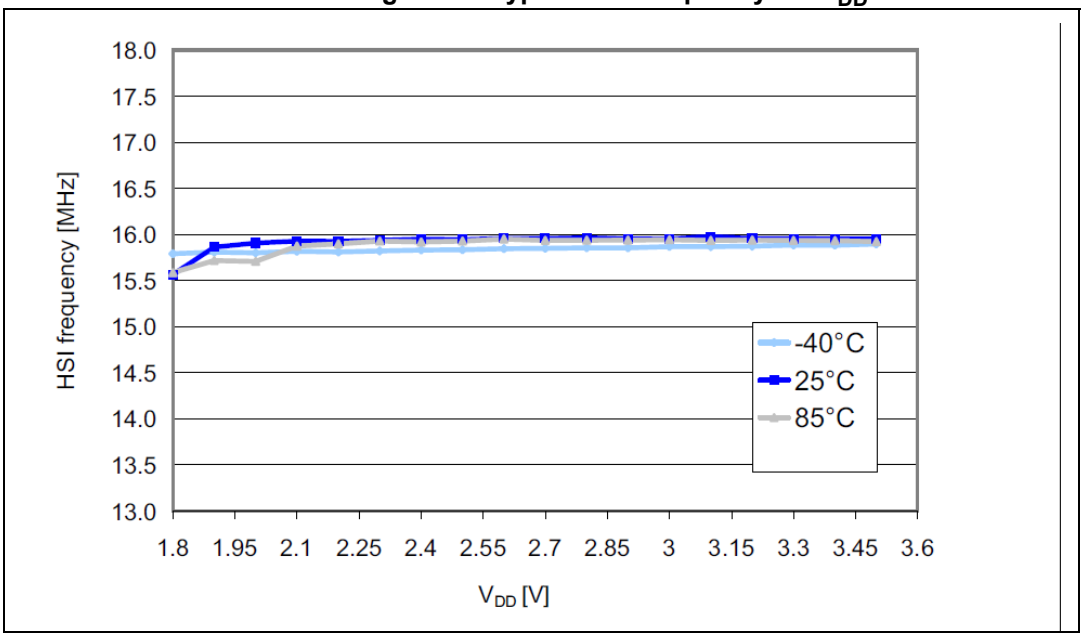
Table 30. HSI oscillator characteristics

Symbol	Parameter	Conditions(1)	Min.	Typ.	Max.	Unit
f_{HSI}	Frequency	V_{DD} = 3.0 V	-	16		MHz
ACC_{HSI}	Accuracy of HSI oscillator (factory calibrated)	V_{DD} = 3.0 V, T_A = 25 °C	-1 (2)	-	1 (2)	%
		1.8 V ≤V_{DD} ≤ 3.6 V, -40 °C ≤T_A ≤ 85 °C	-5	-	5	%
TRIM	HSI user trimming step(3)	Trimming code ≠ multiple of 16	-	0.4	0.7	%
		Trimming code = multiple of 16	-		± 1.5	%
$t_{su(HSI)}$	HSI oscillator setup time (wakeup time)	-	-	3.7	6 (4)	µs
$I_{DD(HSI)}$	HSI oscillator power consumption	-	-	100	140(4)	µA

1. V_{DD} = 3.0 V, T_A = -40 to 85 °C unless otherwise specified.
2. Tested in production.
3. The trimming step differs depending on the trimming code. It is usually negative on the codes which are multiples of 16 (0x00, 0x10, 0x20, 0x30...0xE0). Refer to the AN3101 “STM8L15x internal RC oscillator calibration” application note for more details.
4. Guaranteed by design.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 18. Typical HSI frequency vs. V_{DD}



Low speed internal RC oscillator (LSI)

In the following table, data are based on characterization results, not tested in production.

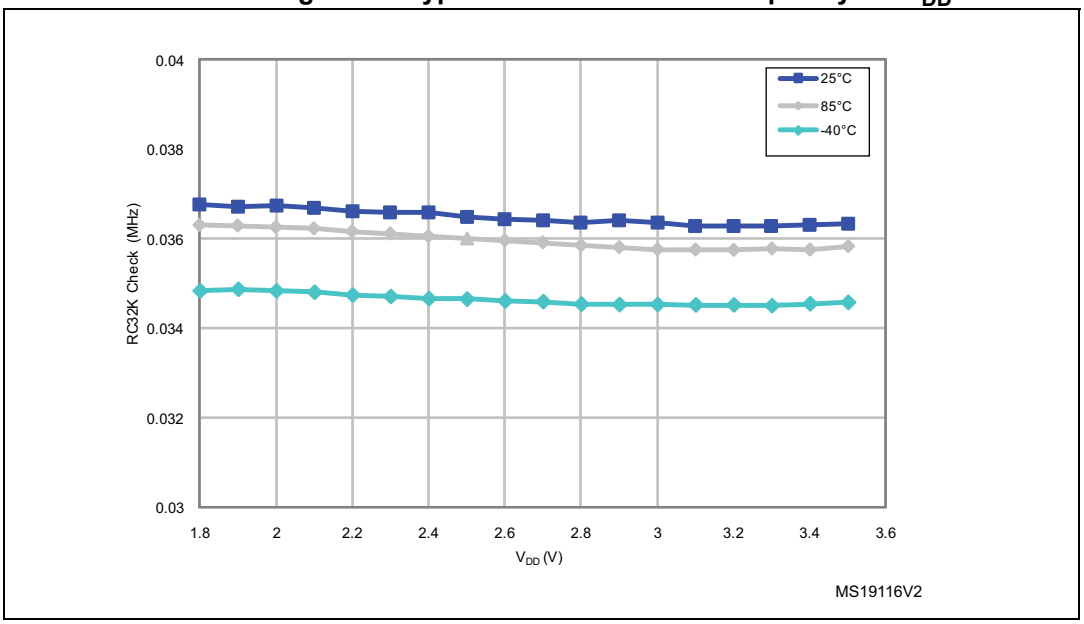
Table 31. LSI oscillator characteristics

Symbol	Parameter	Conditions(1)	Min.	Typ.	Max.	Unit
f_{LSI}	Frequency	-	26	38	56	kHz
$t_{su(LSI)}$	LSI oscillator wakeup time	-	-	-	200(2)	µs
$D_{(LSI)}$	LSI oscillator frequency drift(3)	0 °C ≤T_A ≤85 °C	-12	-	11	%

1. V_{DD} = 1.8 V to 3.6 V, T_A = -40 to 85 °C unless otherwise specified.
2. Guaranteed by design..
3. This is a deviation for an individual part, once the initial frequency has been measured.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 19. Typical LSI clock source frequency vs. V_{DD}



8.3.5 Memory characteristics

T_A = -40 to 85 °C unless otherwise specified.

Table 32. RAM and hardware registers

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{RM}	Data retention mode (1)	Halt mode (or Reset)	1.8	-	-	V

1. Minimum supply voltage without losing data stored in RAM (in Halt mode or under Reset) or in hardware registers (only in Halt mode). Guaranteed by characterization results.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Flash memory

Table 33. Flash program and data EEPROM memory

Symbol	Parameter	Conditions	Min.	Typ.	Max. (1)	Unit
V_{DD}	Operating voltage (all modes, read/write/erase)	f_{SYSCLK} = 16 MHz	1.8	-	3.6	V
t_{prog}	Programming time for 1 or 128 bytes (block) erase/write cycles (on programmed byte)	-	-	6	-	ms
	Programming time for 1 to 128 bytes (block) write cycles (on erased byte)	-	-	3	-	ms
I_{prog}	Programming/ erasing consumption	T_A=+25 °C, V_{DD} = 3.0 V	-	0.7	-	mA
		T_A=+25 °C, V_{DD} = 1.8 V	-		-	
t_{RET} (2)	Data retention (program memory) after 100 erase/write cycles at T_A=-40 to +85 °C	T_{RET}=+85 °C	30(1)	-	-	years
	Data retention (data memory) after 100000 erase/write cycles at T_A=-40 to +85 °C	T_{RET}=+85 °C	30(1)	-	-	
N_{RW} (3)	Erase/write cycles (program memory)	T_A=-40 to +85 °C	100(1)	-	-	cycles
	Erase/write cycles (data memory)		100(1) (4)	-	-	kcycles

1. Guaranteed by characterization results.
2. Conforming to JEDEC JESD22a117
3. The physical granularity of the memory is 4 bytes, so cycling is performed on 4 bytes even when a write/erase operation addresses a single byte.
4. Data based on characterization performed on the whole data memory.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8.3.6 I/O current injection characteristics

As a general rule, current injection to the I/O pins, due to external voltage below V_{SS} or above V_{DD} (for standard pins) should be avoided during normal product operation. However, in order to give an indication of the robustness of the microcontroller in cases when abnormal injection accidentally happens, susceptibility tests are performed on a sample basis during device characterization.

Functional susceptibility to I/O current injection

While a simple application is executed on the device, the device is stressed by injecting current into the I/O pins programmed in floating input mode. While current is injected into the I/O pin, one at a time, the device is checked for functional failures.

The failure is indicated by an out of range parameter: ADC error, out of spec current injection on adjacent pins or other functional failure (for example reset, oscillator frequency deviation, LCD levels, etc.).

The test results are given in the following table.

Table 34. I/O current injection susceptibility

Symbol	Description	Functional susceptibility		Unit
		Negative injection	Positive injection	
I_{INJ}	Injected current on true open-drain pins	-5	+0	mA
	Injected current on all 5 V tolerant (FT) pins	-5	+0	
	Injected current on any other pin	-5	+5	

8.3.7 I/O port pin characteristics

General characteristics

Subject to general operating conditions for V_{DD} and T_A unless otherwise specified. All unused pins must be kept at a fixed voltage: using the output mode of the I/O for example or an external pull-up or pull-down resistor.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 35. I/O static characteristics

Symbol	Parameter	Conditions[1]	Min.	Typ.	Max.	Unit
V_{IL}	Input low level voltage[2]	Input voltage on true open-drain pins (PC0 and PC1)	Vss-0.3	-	0.3 x V_{DD}	V
		Input voltage on five-volt tolerant (FT) pins	Vss-0.3	-	0.3 x V_{DD}	
		Input voltage on any other pin	Vss-0.3	-	0.3 x V_{DD}	
V_{IH}	Input high level voltage [2]	Input voltage on true open-drain pins (PC0 and PC1) with V_{DD} < 2 V	0.70 x V_{DD}	-	5.2	V
		Input voltage on true open-drain pins (PC0 and PC1) with $V_{DD} \geq 2$ V		-	5.5	
		Input voltage on five-volt tolerant (FT) pins with V_{DD} < 2 V	0.70 x V_{DD}	-	5.2	
		Input voltage on five-volt tolerant (FT) pins with $V_{DD} \geq 2$ V		-	5.5	
		Input voltage on any other pin	0.70 x V_{DD}	-	V_{DD}+0.3	
V_{hys}	Schmitt trigger voltage hysteresis [3]	Standard I/Os	-	200	-	mV
		True open drain I/Os	-	200	-	
I_{lkg}	Input leakage current [4]	$V_{SS} \leq V_{IN} \leq V_{DD}$ Standard I/Os	-	-	50 [5]	nA
		$V_{SS} \leq V_{IN} \leq V_{DD}$ True open drain I/Os	-	-	200[5]	
		$V_{SS} \leq V_{IN} \leq V_{DD}$ PA0 with high sink LED driver capability	-	-	200[5]	
R_{PU}	Weak pull-up equivalent resistor[2][6]	$V_{IN}=V_{SS}$	30	45	60	kΩ
C_{IO}	I/O pin capacitance	-	-	5	-	pF

1. V_{DD} = 3.0 V, T_A = -40 to 85 °C unless otherwise specified.
2. Guaranteed by characterization results.
3. Hysteresis voltage between Schmitt trigger switching levels. Based on characterization results, not tested.
4. The max. value may be exceeded if negative current is injected on adjacent pins.
5. Not tested in production.
6. R_{PU} pull-up equivalent resistor based on a resistive transistor (corresponding I_{PU} current characteristics described in *Figure 23*).

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 20. Typical V_{IL} and V_{IH} vs. V_{DD} (standard I/Os)

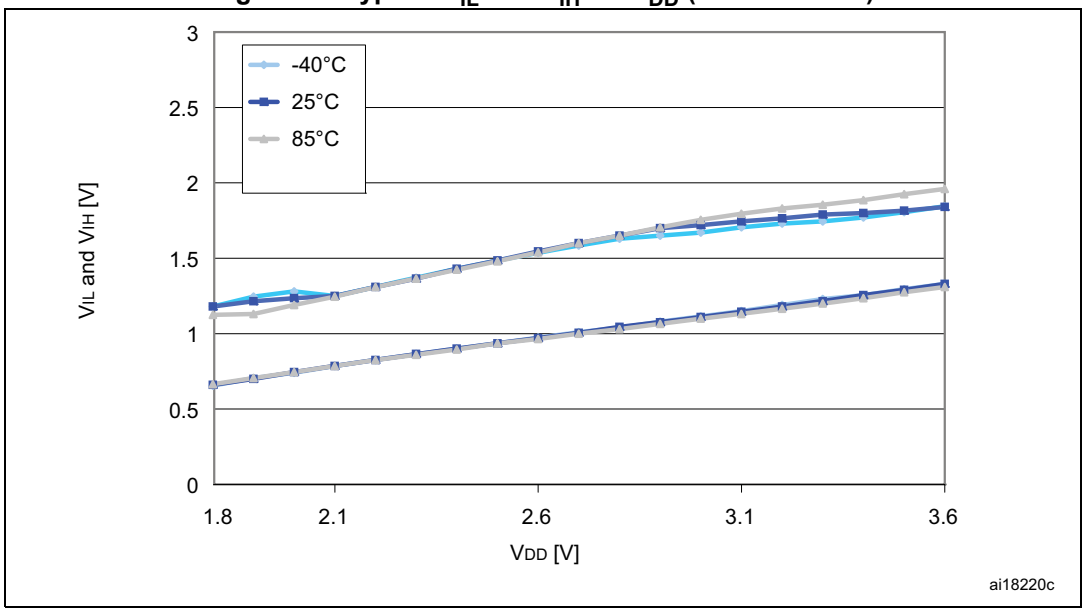
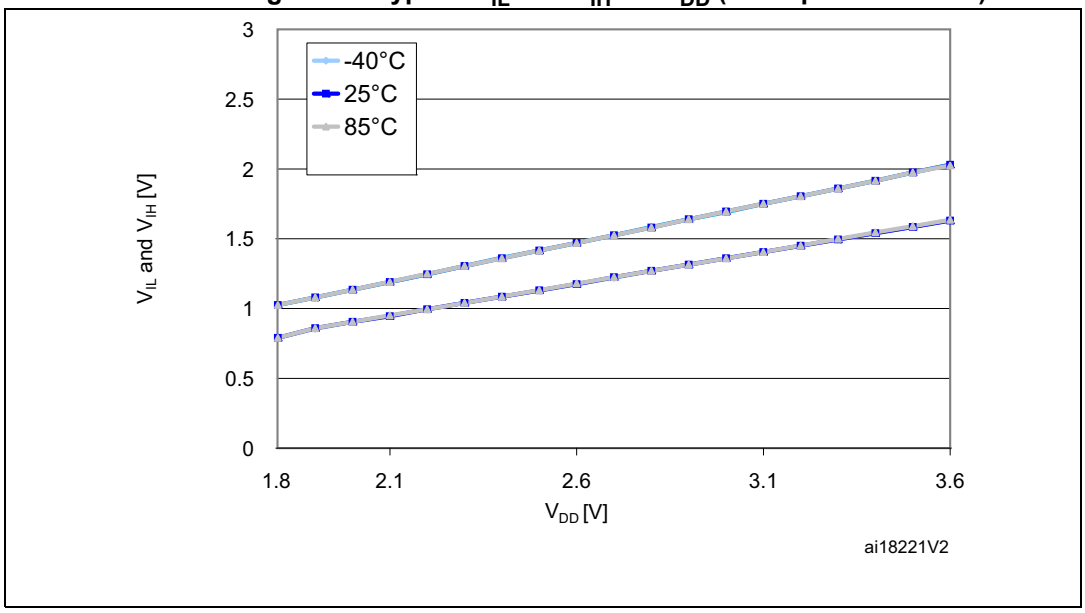


Figure 21. Typical V_{IL} and V_{IH} vs. V_{DD} (true open drain I/Os)



深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 22. Typical pull-up resistance R_{PU} vs. V_{DD} with $V_{IN}=V_{SS}$

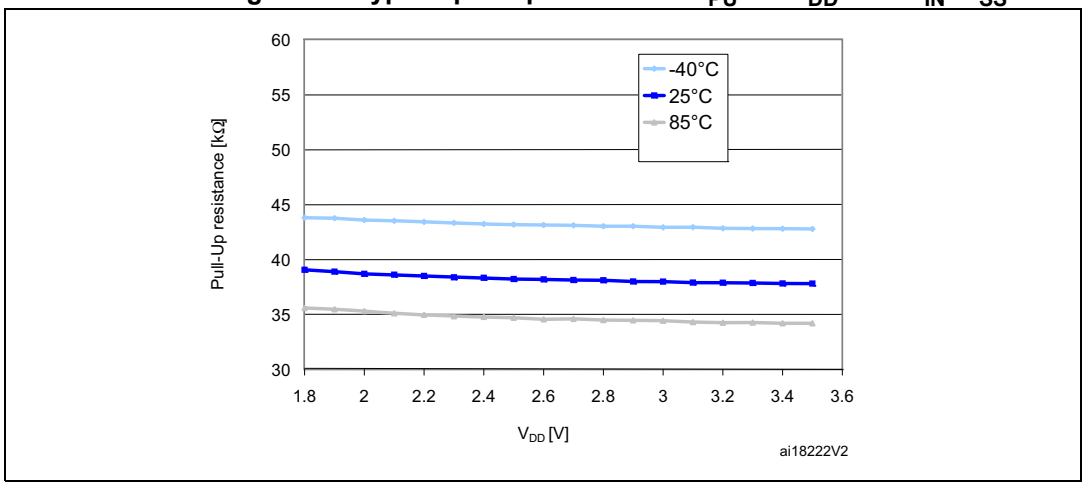
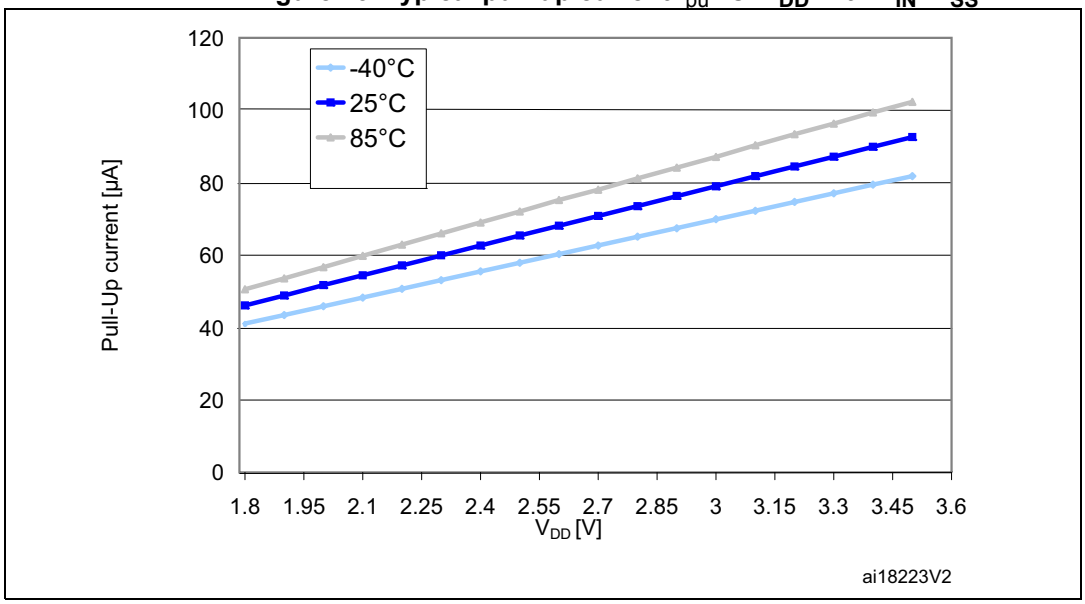


Figure 23. Typical pull-up current I_{DU} vs. V_{DD} with $V_{IN}=V_{SS}$



Output driving current

Subject to general operating conditions for V_{DD} and T_A unless otherwise specified.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 36. Output driving current (high sink ports)

I/O Type	Symbol	Parameter	Conditions	Min.	Max.	Unit
Standard	V_{OL} (1)	Output low level voltage for an I/O pin	I_{IO} = +2 mA, V_{DD} = 3.0 V	-	0.45	V
			I_{IO} = +2 mA, V_{DD} = 1.8 V	-	0.45	V
			I_{IO} = +10 mA, V_{DD} = 3.0 V	-	0.7	V
	V_{OH} (2)	Output high level voltage for an I/O pin	I_{IO} = -2 mA, V_{DD} = 3.0 V	V_{DD}-0.45	-	V
			I_{IO} = -1 mA, V_{DD} = 1.8 V	V_{DD}-0.45	-	V
			I_{IO} = -10 mA, V_{DD} = 3.0 V	V_{DD}-0.7	-	V

1. The I_{IO} current sunk must always respect the absolute maximum rating specified in *Table 13* and the sum of I_{IO} (I/O ports and control pins) must not exceed I_{VSS}.
2. The I_{IO} current sourced must always respect the absolute maximum rating specified in *Table 13* and the sum of I_{IO} (I/O ports and control pins) must not exceed I_{VDD}.

Table 37. Output driving current (true open drain ports)

I/O Type	Symbol	Parameter	Conditions	Min.	Max.	Unit
Open drain	V_{OL} (1)	Output low level voltage for an I/O pin	I_{IO} = +3 mA, V_{DD} = 3.0 V	-	0.45	V
			I_{IO} = +1 mA, V_{DD} = 1.8 V	-	0.45	

1. The I_{IO} current sunk must always respect the absolute maximum rating specified in *Table 13* and the sum of I_{IO} (I/O ports and control pins) must not exceed I_{VSS}.

Table 38. Output driving current (PA0 with high sink LED driver capability)

I/O Type	Symbol	Parameter	Conditions	Min.	Max.	Unit
IR	V_{OL} (1)	Output low level voltage for an I/O pin	I_{IO} = +20 mA, V_{DD} = 2.0 V	-	0.45	V

1. The I_{IO} current sunk must always respect the absolute maximum rating specified in *Table 13* and the sum of I_{IO} (I/O ports and control pins) must not exceed I_{VSS}.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 24. Typical V_{OL} @ V_{DD} = 3.0 V (high sink ports)

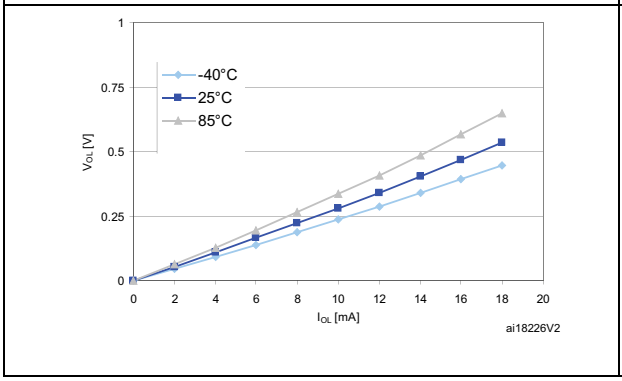


Figure 25. Typical V_{OL} @ V_{DD} = 1.8 V (high sink ports)

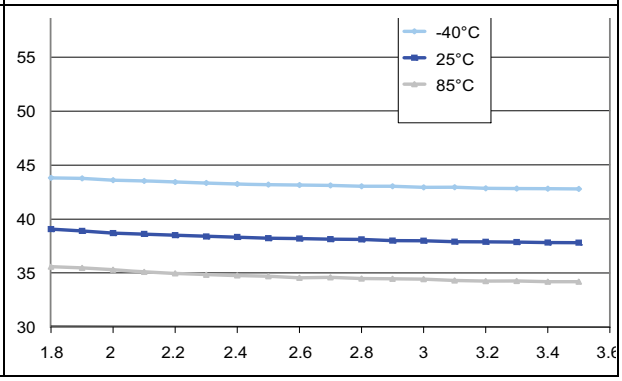


Figure 26. Typical V_{OL} @ V_{DD} = 3.0 V (true open drain ports)

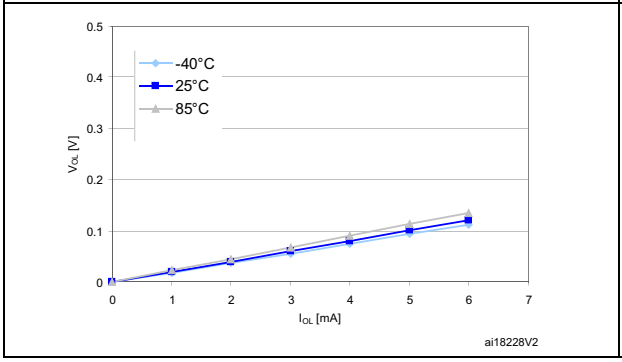


Figure 27. Typical V_{OL} @ V_{DD} = 1.8 V (true open drain ports)

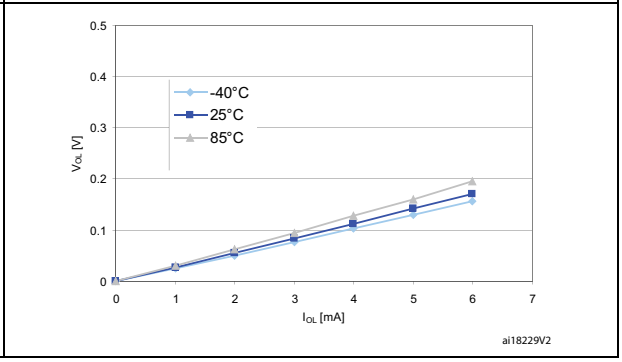


Figure 28. Typical V_{DD} - V_{OH} @ V_{DD} = 3.0 V (high sink ports)

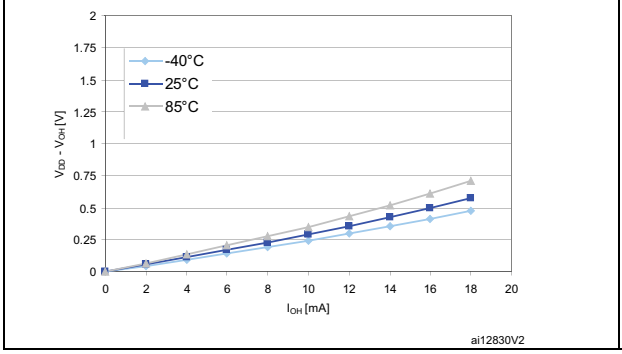
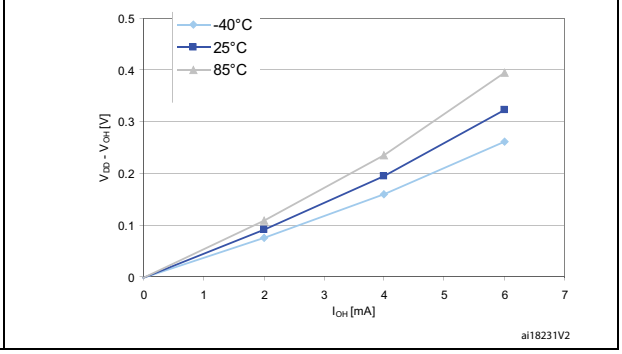


Figure 29. Typical V_{DD} - V_{OH} @ V_{DD} = 1.8 V (high sink ports)



NRST pin

Subject to general operating conditions for V_{DD} and T_A unless otherwise specified.

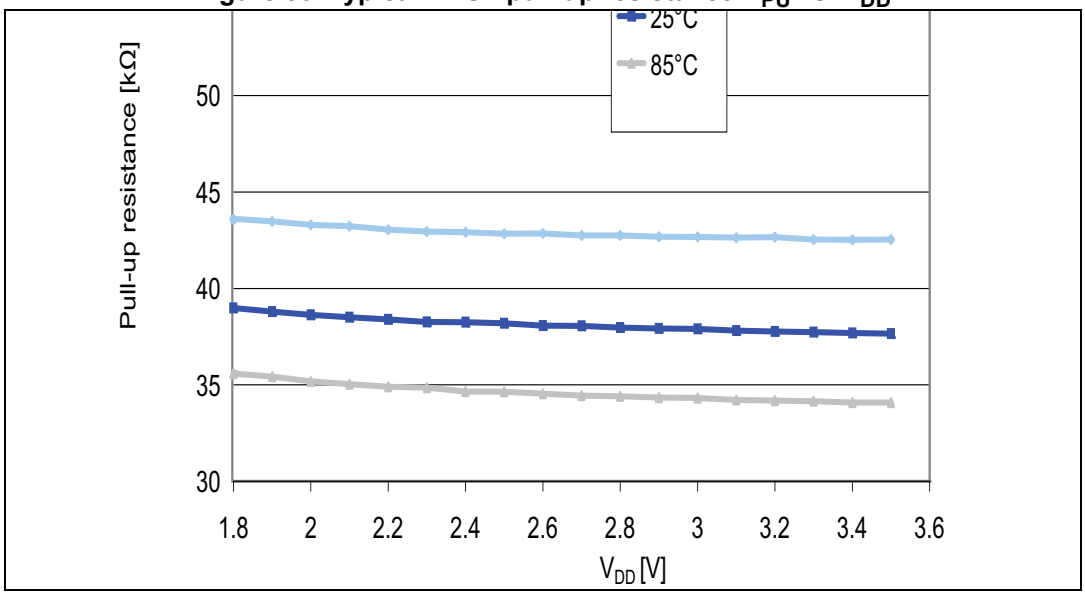
深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 39. $\overline{\text{NRST}}$ pin characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$V_{IL(NRST)}$	NRST input low level voltage (1)	-	V_{SS}	-	0.8	V
$V_{IH(NRST)}$	NRST input high level voltage (1)	-	1.4	-	V_{DD}	
$V_{OL(NRST)}$	NRST output low level voltage (1)	I_{OL} = 2 mA for 2.7 V ≤V_{DD} ≤3.6 V	-	-	0.4	
		I_{OL} = 1.5 mA for V_{DD} < 2.7 V	-	-		
V_{HYST}	NRST input hysteresis(3)	-	10%V_{DD} (2)	-	-	mV
$R_{PU(NRST)}$	NRST pull-up equivalent resistor(1)	-	30	45	60	kΩ
$V_{F(NRST)}$	NRST input filtered pulse (3)	-	-	-	50	ns
$V_{NF(NRST)}$	NRST input not filtered pulse (3)	-	300	-	-	

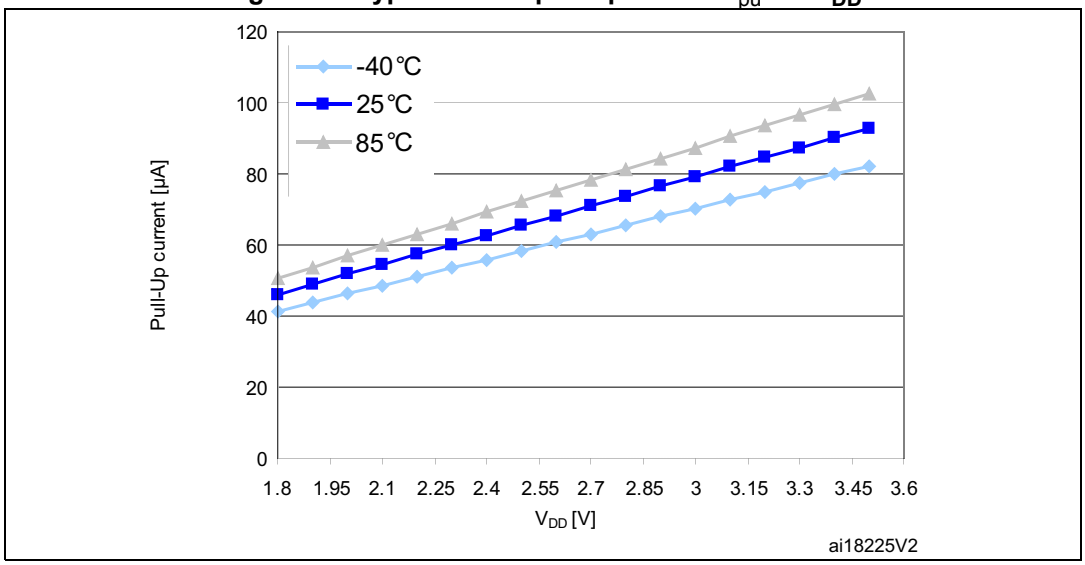
1. Guaranteed by characterization results.
2. 200 mV min.
3. Guaranteed by design.

Figure 30. Typical NRST pull-up resistance R_{PU} vs. V_{DD}



深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

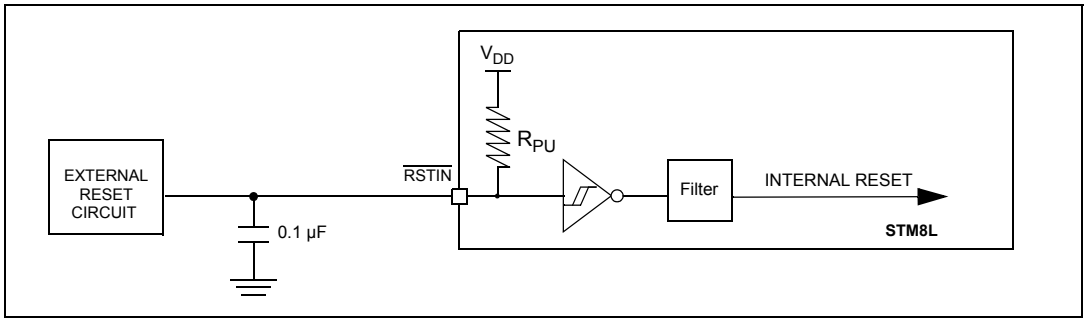
Figure 31. Typical NRST pull-up current I_{pu} vs. V_{DD}



The reset network shown in *Figure 32* protects the device against parasitic resets. The user must ensure that the level on the NRST pin can go below the V_{IL} max. level specified in *Table 39*. Otherwise the reset is not taken into account internally. For power consumption-sensitive applications, the capacity of the external reset capacitor can be reduced to limit the charge/discharge current. If the NRST signal is used to reset the external circuitry, the user must pay attention to the charge/discharge time of the external capacitor to meet the reset timing conditions of the external devices. The minimum recommended capacity is 10 nF.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 32. Recommended NRST pin configuration



深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8.3.8 Communication interfaces

SPI1 - Serial peripheral interface

Unless otherwise specified, the parameters given in *Table 40* are derived from tests performed under ambient temperature, f_{SYSCLK} frequency and V_{DD} supply voltage conditions summarized in *Section 8.3.1*. Refer to I/O port characteristics for more details on the input/output alternate function characteristics (NSS, SCK, MOSI, MISO).

Table 40. SPI1 characteristics

Symbol	Parameter	Conditions(1)	Min.	Max.	Unit
f_{SCK} $1/t_{c(SCK)}$	SPI1 clock frequency	Master mode	0	8	MHz
		Slave mode	0	8	
$t_{r(SCK)}$ $t_{f(SCK)}$	SPI1 clock rise and fall time	Capacitive load: C = 30 pF	-	30	ns
$t_{su(NSS)}$(2)	NSS setup time	Slave mode	4 x $1/f_{SYSCLK}$	-	-
$t_{h(NSS)}$(2)	NSS hold time	Slave mode	80	-	-
$t_{w(SCKH)}$(2) $t_{w(SCKL)}$(2)	SCK high and low time	Master mode, f_{MASTER} = 8 MHz, f_{SCK}= 4 MHz	105	145	-
$t_{su(MI)}$(2) $t_{su(SI)}$(2)	Data input setup time	Master mode	30	-	-
		Slave mode	3	-	-
$t_{h(MI)}$(2) $t_{h(SI)}$(2)	Data input hold time	Master mode	15	-	-
		Slave mode	0	-	-
$t_{a(SO)}$(2)(3)	Data output access time	Slave mode	-	3x $1/f_{SYSCLK}$	-
$t_{dis(SO)}$(2)(4)	Data output disable time	Slave mode	30	-	-
$t_{v(SO)}$(2)	Data output valid time	Slave mode (after enable edge)	-	60	-
$t_{v(MO)}$(2)	Data output valid time	Master mode (after enable edge)	-	20	-
$t_{h(SO)}$(2)	Data output hold time	Slave mode (after enable edge)	15	-	-
$t_{h(MO)}$(2)		Master mode (after enable edge)	1	-	-

1. Parameters are given by selecting 10 MHz I/O output frequency.
2. Values based on design simulation and/or characterization results, and not tested in production.
3. Min. time is for the minimum time to drive the output and max. time is for the maximum time to validate the data.
4. Min. time is for the minimum time to invalidate the output and max. time is for the maximum time to put the data in Hi-Z.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 33. SPI1 timing diagram - slave mode and CPHA=0

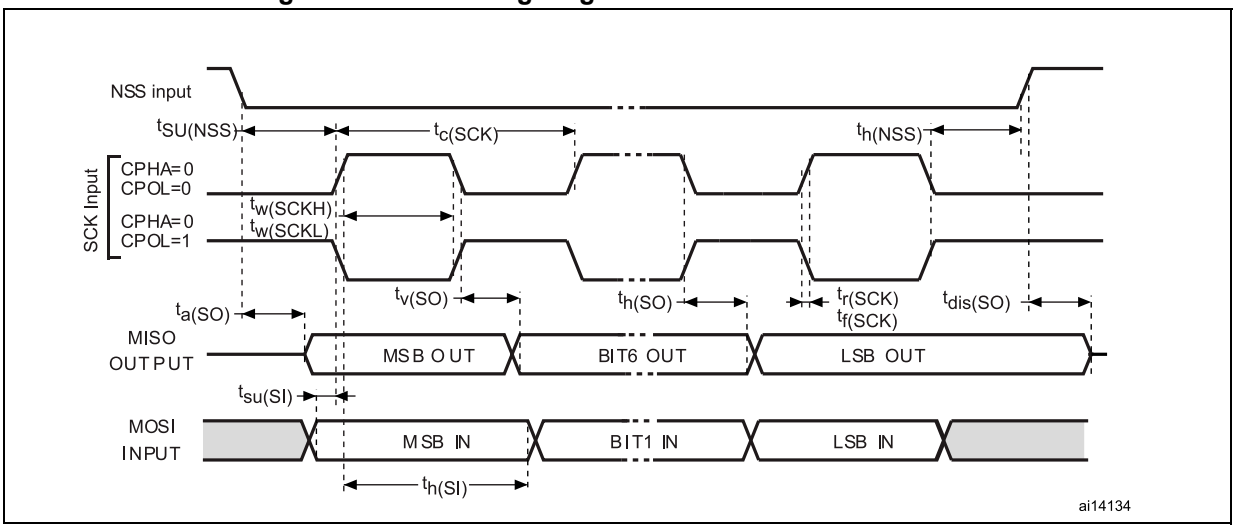
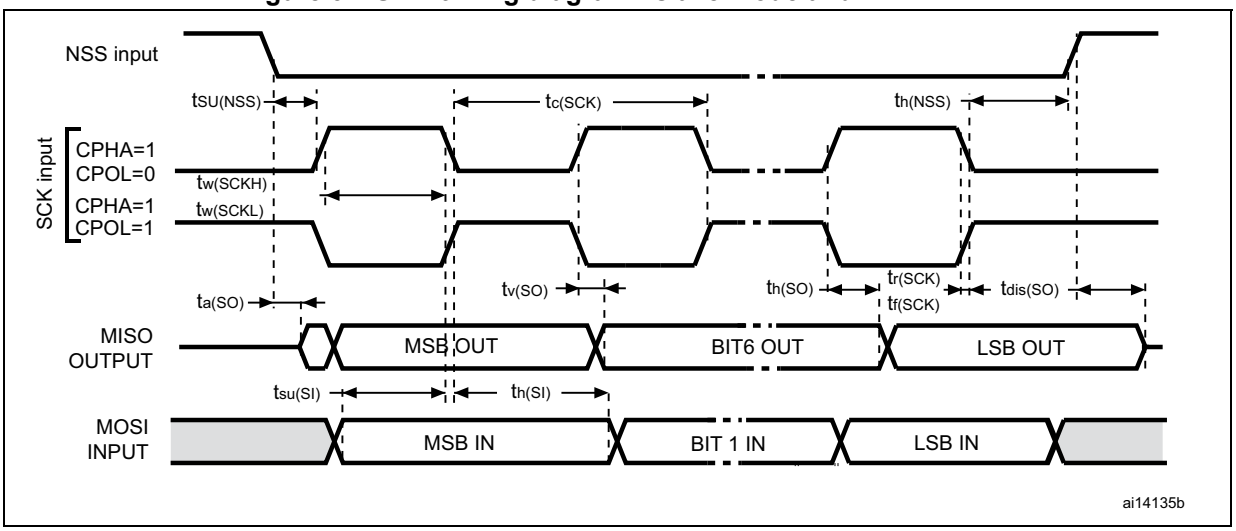


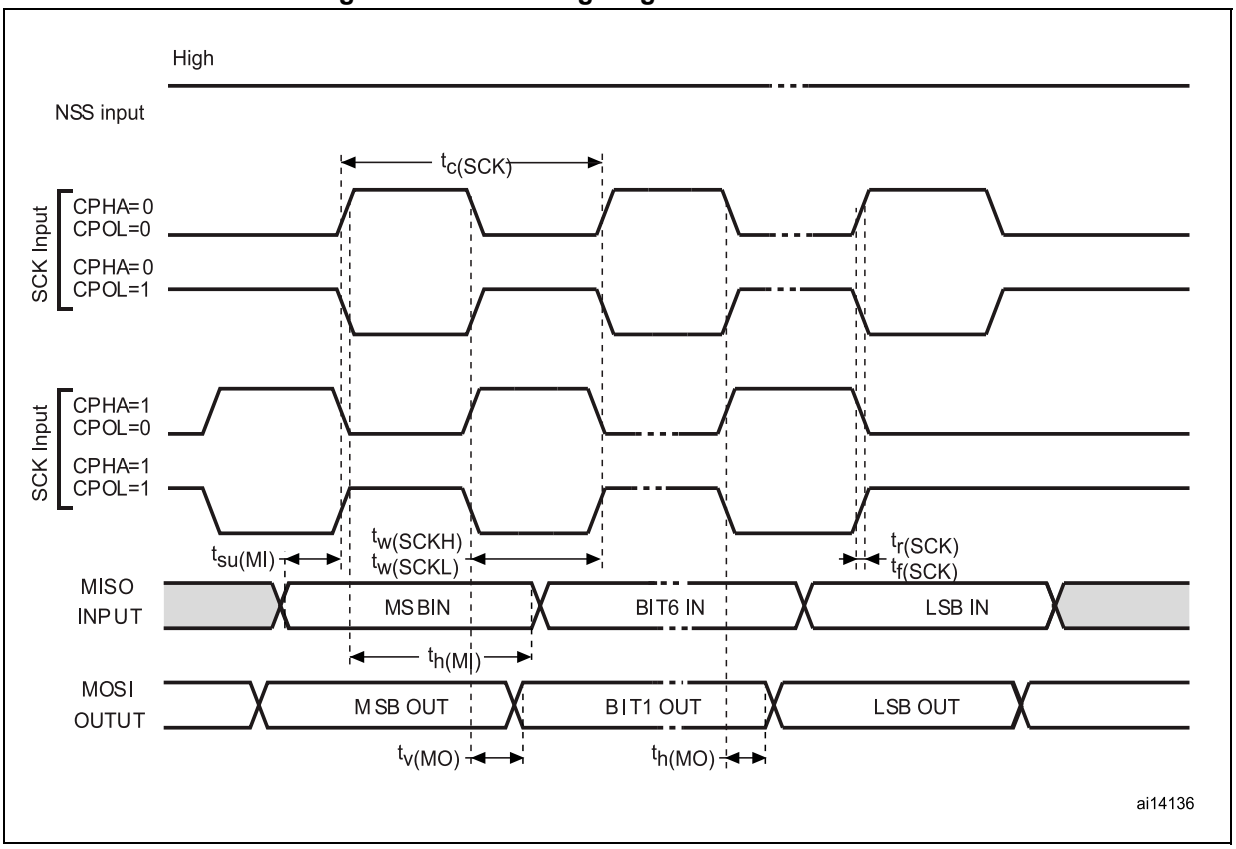
Figure 34. SPI1 timing diagram - slave mode and CPHA=1(1)



1. Measurement points are done at CMOS levels: $0.3V_{DD}$ and $0.7V_{DD}$.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 35. SPI1 timing diagram - master mode(1)



1. Measurement points are done at CMOS levels: $0.3V_{DD}$ and $0.7V_{DD}$.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

I²C - Inter IC control interface

Subject to general operating conditions for V_{DD}, f_{SYSCLK}, and T_A unless otherwise specified.

The STM8L I²C interface (I2C1) meets the requirements of the Standard I²C communication protocol described in the following table with the restriction mentioned below:

Refer to I/O port characteristics for more details on the input/output alternate function characteristics (SDA and SCL).

Table 41. I2C characteristics

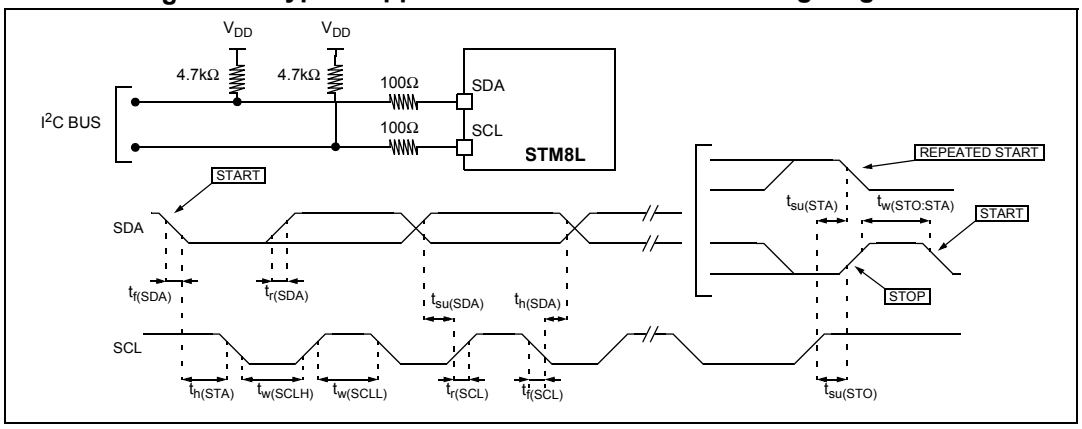
Symbol	Parameter	Standard mode I²C		Fast mode I²C(1)		Unit
		Min.(2)	Max. (2)	Min. (2)	Max. (2)	
$t_{w(SCLL)}$	SCL clock low time	4.7	-	1.3	-	µs
$t_{w(SCLH)}$	SCL clock high time	4.0	-	0.6	-	
$t_{su(SDA)}$	SDA setup time	250	-	100	-	ns
$t_{h(SDA)}$	SDA data hold time	0	-	0	900	
$t_{r(SDA)}$ $t_{r(SCL)}$	SDA and SCL rise time	-	1000	-	300	
$t_{f(SDA)}$ $t_{f(SCL)}$	SDA and SCL fall time	-	300	-	300	
$t_{h(STA)}$	START condition hold time	4.0	-	0.6	-	µs
$t_{su(STA)}$	Repeated START condition setup time	4.7	-	0.6	-	
$t_{su(STO)}$	STOP condition setup time	4.0	-	0.6	-	µs
$t_{w(STO:STA)}$	STOP to START condition time (bus free)	4.7	-	1.3	-	µs
C_b	Capacitive load for each bus line	-	400	-	400	pF

1. f_{SYSCLK} must be at least equal to 8 MHz to achieve max fast I²C speed (400 kHz).
2. Data based on standard I²C protocol requirement, not tested in production.

Note: For speeds around 200 kHz, the achieved speed can have a ±5% tolerance.
For other speed ranges, the achieved speed can have a ±2% tolerance.
The above variations depend on the accuracy of the external components used.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 36. Typical application with I²C bus and timing diagram 1)



1. Measurement points are done at CMOS levels: 0.3 x V_{DD} and 0.7 x V_{DD}

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8.3.9 LCD controller

In the following table, data are guaranteed by design, not tested in production.

Table 42. LCD characteristics

Symbol	Parameter	Min.	Typ.	Max.	Unit
V_{LCD}	LCD external voltage	-	-	3.6	V
V_{LCD0}	LCD internal reference voltage 0	-	2.6	-	
V_{LCD1}	LCD internal reference voltage 1	-	2.7	-	
V_{LCD2}	LCD internal reference voltage 2	-	2.8	-	
V_{LCD3}	LCD internal reference voltage 3	-	3.0	-	
V_{LCD4}	LCD internal reference voltage 4	-	3.1	-	
V_{LCD5}	LCD internal reference voltage 5	-	3.2	-	
V_{LCD6}	LCD internal reference voltage 6	-	3.4	-	
V_{LCD7}	LCD internal reference voltage 7	-	3.5	-	
C_{EXT}	V_{LCD} external capacitance	0.1	1	2	µF
I_{DD}	Supply current(1) at V_{DD} = 1.8 V	-	3	-	µA
	Supply current(1) at V_{DD} = 3 V	-	3	-	
R_{HN}(2)	High value resistive network (low drive)	-	6.6	-	MΩ
R_{LN}(3)	Low value resistive network (high drive)	-	240	-	kΩ
V_{33}	Segment/Common higher level voltage	-	-	V_{LCDx}	V
V_{34}	Segment/Common 3/4 level voltage	-	$3/4V_{LCDx}$	-	
V_{23}	Segment/Common 2/3 level voltage	-	$2/3V_{LCDx}$	-	
V_{12}	Segment/Common 1/2 level voltage	-	$1/2V_{LCDx}$	-	
V_{13}	Segment/Common 1/3 level voltage	-	$1/3V_{LCDx}$	-	
V_{14}	Segment/Common 1/4 level voltage	-	$1/4V_{LCDx}$	-	
V_0	Segment/Common lowest level voltage	0	-	-	

1. LCD enabled with 3 V internal booster (LCD_CR1 = 0x08), 1/4 duty, 1/3 bias, division ratio= 64, all pixels active, no LCD connected.
2. R_{HN} is the total high value resistive network.
3. R_{LN} is the total low value resistive network.

VLCD external capacitor

The application can achieve a stabilized LCD reference voltage by connecting an external capacitor C_{EXT} to the V_{LCD} pin. C_{EXT} is specified in *Table 42*.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8.3.10 Embedded reference voltage

In the following table, data are based on characterization results, not tested in production, unless otherwise specified.

Table 43. Reference voltage characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_{REFINT}	Internal reference voltage consumption	-	-	1.4	-	µA
$T_{S_VREFINT}$(1)(2)	ADC sampling time when reading the internal reference voltage	-	-	5	10	µs
I_{BUF}(1)	Internal reference voltage buffer consumption (used for ADC)	-	-	13.5	25	µA
$V_{REFINT\ out}$	Reference voltage output	-	1.202 (3)	1.224	1.242 (3)	V
I_{LPBUF}(1)	Internal reference voltage low power buffer consumption (used for comparators or output)	-	-	730	1200	nA
I_{REFOUT}(1)(4)	Buffer output current	-	-	-	1	µA
C_{REFOUT}	Reference voltage output load	-	-	-	50	pF
$t_{VREFINT}$(1)	Internal reference voltage startup time	-	-	2	3	ms
t_{BUFEN}(1)(2)	Internal reference voltage buffer startup time once enabled	-	-	-	10	µs
$STAB_{VREFINT}$	Stability of V_{REFINT} over temperature	-40 °C ≤T_A≤ 85 °C	-	20	50	ppm/°C
	Stability of V_{REFINT} over temperature	0 °C ≤T_A≤ 50 °C	-	-	20	ppm/°C
$STAB_{VREFINT}$	Stability of V_{REFINT} after 1000 hours	-	-	-	TBD	ppm

1. Guaranteed by design.
2. Defined when ADC output reaches its final value ±1/2LSB
3. Tested in production at V_{DD} = 3 V ±10 mV.
4. To guarantee less than 1% V_{REFOUT} deviation

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8.3.11 12-bit ADC1 characteristics

In the following table, data are guaranteed by design, not tested in production.

Table 44. ADC1 characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{DDA}	Analog supply voltage	-	1.8	-	3.6	V
V_{REF+}	Reference supply voltage	2.4 V ≤V_{DDA}≤ 3.6 V	2.4	-	V_{DDA}	V
		1.8 V≤V_{DDA}≤ 2.4 V	V_{DDA}			V
V_{REF-}	Lower reference voltage	-	V_{SSA}			V
I_{VDDA}	Current on the V_{DDA} input pin	-	-	1000	1450	µA
I_{VREF+}	Current on the V_{REF+} input pin	-	-	400	700 (peak)(1)	µA
		-	-		450 (average)(1)	µA
V_{AIN}	Conversion voltage range	-	0(2)	-	V_{REF+}	-
T_A	Temperature range	-	-40	-	85	°C
R_{AIN}	External resistance on V_{AIN}	on PF0/1/2/3 fast channels	-	-	50(3)	kΩ
		on all other channels	-	-		
C_{ADC}	Internal sample and hold capacitor	on PF0/1/2/3 fast channels	-	16	-	pF
		on all other channels	-		-	
f_{ADC}	ADC sampling clock frequency	2.4 V≤V_{DDA}≤3.6 V without zooming	0.320	-	16	MHz
		1.8 V≤V_{DDA}≤2.4 V with zooming	0.320	-	8	MHz
f_{CONV}	12-bit conversion rate	V_{AIN} on PF0/1/2/3 fast channels	-	-	1(3)(4)	MHz
		V_{AIN} on all other channels	-	-	760(3)(4)	kHz
f_{TRIG}	External trigger frequency	-	-	-	t_{conv}	$1/f_{ADC}$
t_{LAT}	External trigger latency	-	-	-	3.5	$1/f_{SYSCLK}$

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 44. ADC1 characteristics (continued)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
t_S	Sampling time	V_{AIN} PF0/1/2/3 fast channels V_{DDA} < 2.4 V	0.43(3)(4)	-	-	µs
		V_{AIN} PF0/1/2/3 fast channels 2.4 V ≤V_{DDA}≤ 3.6 V	0.22(3)(4)	-	-	µs
		V_{AIN} on slow channels V_{DDA} < 2.4 V	0.86(3)(4)	-	-	µs
		V_{AIN} on slow channels 2.4 V ≤V_{DDA}≤ 3.6 V	0.41(3)(4)	-	-	µs
t_{conv}	12-bit conversion time	-	12 + t_S			$1/f_{ADC}$
		16 MHz	1(3)			µs
t_{WKUP}	Wakeup time from OFF state	-	-	-	3	µs
t_{IDLE}(5)	Time before a new conversion	-	-	-	∞	s
$t_{VREFINT}$	Internal reference voltage startup time	-	-	-	refer to *Table 43*	ms

1. The current consumption through V_{REF} is composed of two parameters:
   - one constant (max 300 µA)
   - one variable (max 400 µA), only during sampling time + 2 first conversion pulses.
   So, peak consumption is 300+400 = 700 µA and average consumption is 300 + [(4 sampling + 2) /16] x 400 = 450 µA at 1Msps
2. V_{REF-} must be tied to ground.
3. Minimum sampling and conversion time is reached for maximum R_{AIN}= 0.5 kΩ.
4. Value obtained for continuous conversion on fast channel.
5. The time between 2 conversions, or between ADC ON and the first conversion must be lower than t_{IDLE}.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

In the following three tables, data are guaranteed by characterization result, not tested in production.

Table 45. ADC1 accuracy with V_{DDA} = 3.3 V to 2.5 V

Symbol	Parameter	Conditions	Typ.	Max.	Unit
DNL	Differential non linearity	f_{ADC} = 16 MHz	1	1.6	LSB
		f_{ADC} = 8 MHz	1	1.6	
		f_{ADC} = 4 MHz	1	1.5	
INL	Integral non linearity	f_{ADC} = 16 MHz	1.2	2	
		f_{ADC} = 8 MHz	1.2	1.8	
		f_{ADC} = 4 MHz	1.2	1.7	
TUE	Total unadjusted error	f_{ADC} = 16 MHz	2.2	3.0	
		f_{ADC} = 8 MHz	1.8	2.5	
		f_{ADC} = 4 MHz	1.8	2.3	
Offset	Offset error	f_{ADC} = 16 MHz	1.5	2	LSB
		f_{ADC} = 8 MHz	1	1.5	
		f_{ADC} = 4 MHz	0.7	1.2	
Gain	Gain error	f_{ADC} = 16 MHz	1	1.5	
		f_{ADC} = 8 MHz			
		f_{ADC} = 4 MHz			

Table 46. ADC1 accuracy with V_{DDA} = 2.4 V to 3.6 V

Symbol	Parameter	Typ.	Max.	Unit
DNL	Differential non linearity	1	2	LSB
INL	Integral non linearity	1.7	3	LSB
TUE	Total unadjusted error	2	4	LSB
Offset	Offset error	1	2	LSB
Gain	Gain error	1.5	3	LSB

Table 47. ADC1 accuracy with V_{DDA} = V_{REF+} = 1.8 V to 2.4 V

Symbol	Parameter	Typ.	Max.	Unit
DNL	Differential non linearity	1	2	LSB
INL	Integral non linearity	2	3	LSB
TUE	Total unadjusted error	3	5	LSB
Offset	Offset error	2	3	LSB
Gain	Gain error	2	3	LSB

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 37. ADC1 accuracy characteristics

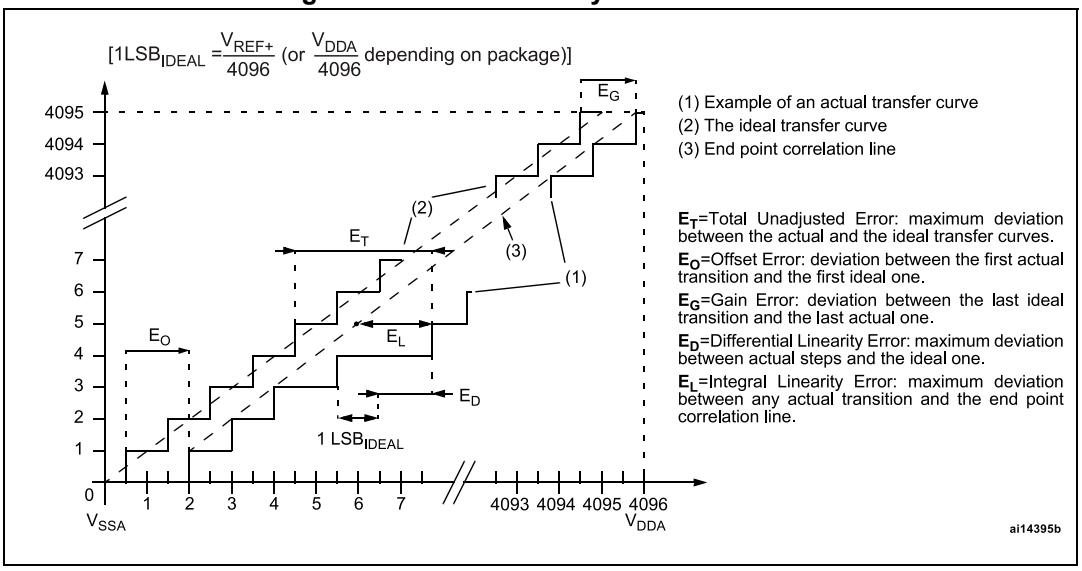
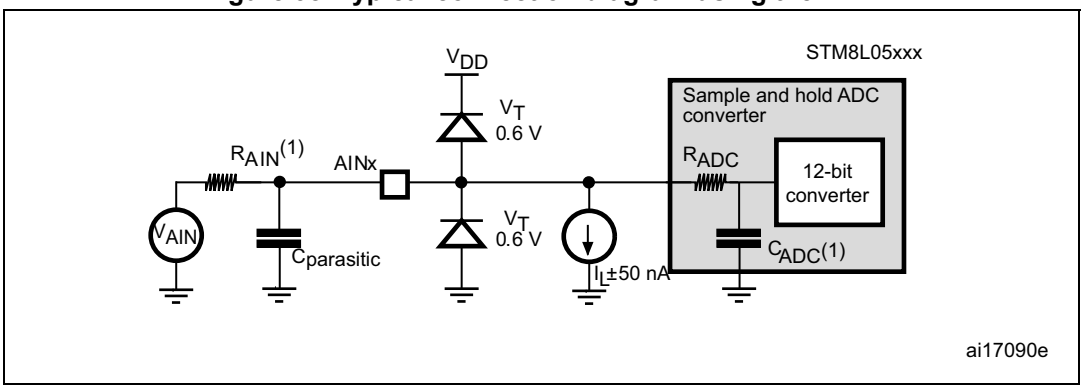


Figure 38. Typical connection diagram using the ADC



1. Refer to *Table 44* for the values of R_{AIN} and C_{ADC}.
2. $C_{parasitic}$ represents the capacitance of the PCB (dependent on soldering and PCB layout quality) plus the pad capacitance (roughly 7 pF). A high $C_{parasitic}$ value will downgrade conversion accuracy. To remedy this, f_{ADC} should be reduced.

General PCB design guidelines

Power supply decoupling should be performed as shown in *Figure 39* or *Figure 40*, depending on whether V_{REF+} is connected to V_{DDA} or not. Good quality ceramic 10 nF capacitors should be used. They should be placed as close as possible to the chip.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Figure 39. Power supply and reference decoupling (V_{REF+} not connected to V_{DDA})

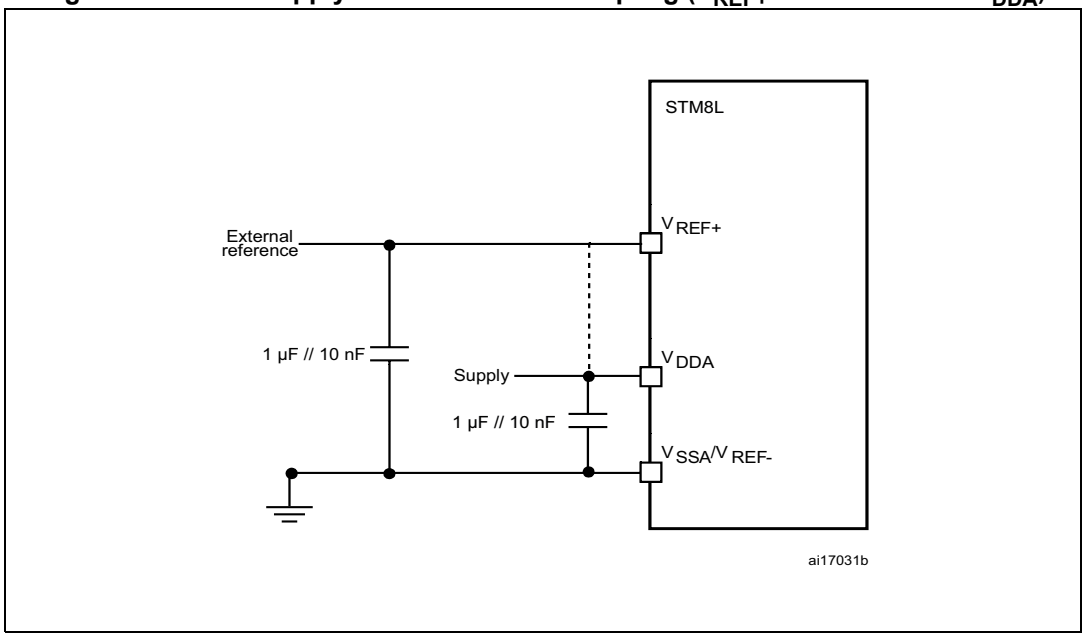
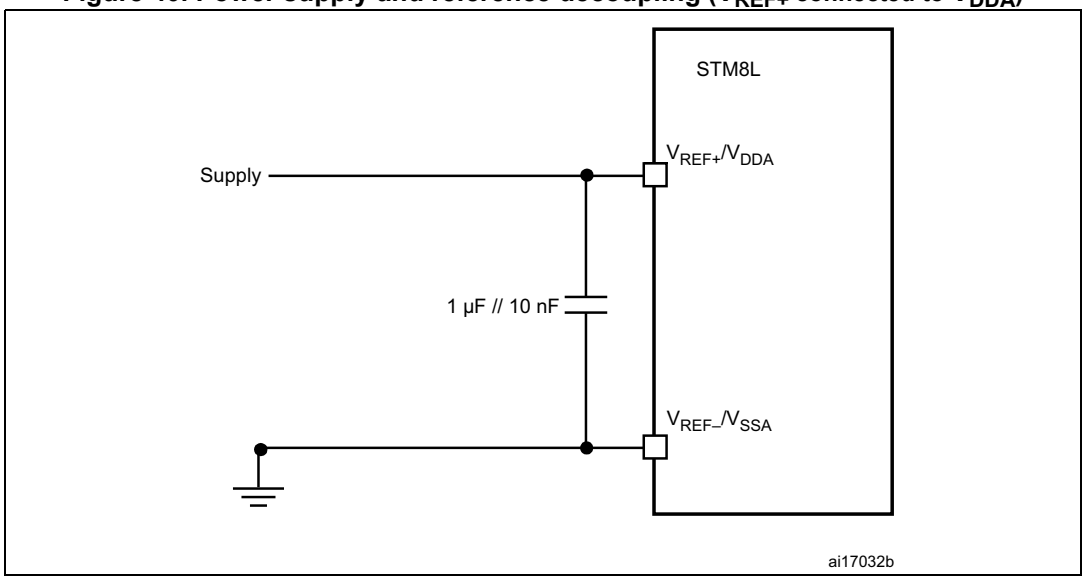


Figure 40. Power supply and reference decoupling (V_{REF+} connected to V_{DDA})



深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8.3.12 EMC characteristics

Susceptibility tests are performed on a sample basis during product characterization.

Functional EMS (electromagnetic susceptibility)

Based on a simple running application on the product (toggling 2 LEDs through I/O ports), the product is stressed by two electromagnetic events until a failure occurs (indicated by the LEDs).

- **ESD**: Electrostatic discharge (positive and negative) is applied on all pins of the device until a functional disturbance occurs. This test conforms with the IEC 61000 standard.
- **FTB**: A burst of fast transient voltage (positive and negative) is applied to V_{DD} and V_{SS} through a 100 pF capacitor, until a functional disturbance occurs. This test conforms with the IEC 61000 standard.

A device reset allows normal operations to be resumed. The test results are given in the table below based on the EMS levels and classes defined in application note AN1709.

Designing hardened software to avoid noise problems

EMC characterization and optimization are performed at component level with a typical application environment and simplified MCU software. It should be noted that good EMC performance is highly dependent on the user application and the software in particular.

Therefore it is recommended that the user applies EMC software optimization and prequalification tests in relation with the EMC level requested for his application.

Prequalification trials:

Most of the common failures (unexpected reset and program counter corruption) can be reproduced by manually forcing a low state on the NRST pin or the Oscillator pins for 1 second.

To complete these trials, ESD stress can be applied directly on the device, over the range of specification values. When unexpected behavior is detected, the software can be hardened to prevent unrecoverable errors occurring (see application note AN1015).

Table 48. EMS data

Symbol	Parameter	Conditions		Level/ Class
V_{FESD}	Voltage limits to be applied on any I/O pin to induce a functional disturbance	V_{DD} = 3.3 V, T_A = +25 °C, f_{CPU}= 16 MHz, conforms to IEC 61000		2B
V_{EFTB}	Fast transient voltage burst limits to be applied through 100 pF on V_{DD} and V_{SS} pins to induce a functional disturbance	V_{DD} = 3.3 V, T_A = +25 °C, f_{CPU} = 16 MHz, conforms to IEC 61000	Using HSI	4A
			Using HSE	2B

Electromagnetic interference (EMI)

Based on a simple application running on the product (toggling 2 LEDs through the I/O ports), the product is monitored in terms of emission. This emission test is in line with the norm IEC61967-2 which specifies the board and the loading of each pin.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 49. EMI data (1)

Symbol	Parameter	Conditions	Monitored frequency band	Max vs. 16 MHz	Unit
S_{EMI}	Peak level	V_{DD} = 3.6 V, T_A = +25 °C, LQFP80 conforming to IEC61967-2	0.1 MHz to 30 MHz	10	dBµV
			30 MHz to 130 MHz	4	
			130 MHz to 1 GHz	1	
			SAE EMI Level	1.5	-

1. Not tested in production.

Absolute maximum ratings (electrical sensitivity)

Based on two different tests (ESD and LU) using specific measurement methods, the product is stressed in order to determine its performance in terms of electrical sensitivity. For more details, refer to the application note AN1181.

Electrostatic discharge (ESD)

Electrostatic discharges (a positive then a negative pulse separated by 1 second) are applied to the pins of each sample according to each pin combination. The sample size depends on the number of supply pins in the device (3 parts*(n+1) supply pin). Two models can be simulated: human body model and charge device model. This test conforms to the JESD22-A114A/A115A standard.

Table 50. ESD absolute maximum ratings

Symbol	Ratings	Conditions	Maximum value (1)	Unit
$V_{ESD(HBM)}$	Electrostatic discharge voltage (human body model)	T_A = +25 °C	2000	V
$V_{ESD(CDM)}$	Electrostatic discharge voltage (charge device model)		750	

1. Guaranteed by characterization results.

Static latch-up

- **LU**: 3 complementary static tests are required on 10 parts to assess the latch-up performance. A supply overvoltage (applied to each power supply pin) and a current injection (applied to each input, output and configurable I/O pin) are performed on each sample. This test conforms to the EIA/JESD 78 IC latch-up standard. For more details, refer to the application note AN1181.

Table 51. Electrical sensitivities

Symbol	Parameter	Class
LU	Static latch-up class	II

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

8.4 Thermal characteristics

The maximum chip junction temperature (T_{Jmax}) must never exceed the values given in *Table 15: General operating conditions on page 59*.

The maximum chip-junction temperature, T_{Jmax}, in degree Celsius, may be calculated using the following equation:

$$T_{Jmax} = T_{Amax} + (P_{Dmax} \times \Theta_{JA})$$

Where:

- T_{Amax} is the maximum ambient temperature in °C
- Θ_{JA} is the package junction-to-ambient thermal resistance in °C/W
- P_{Dmax} is the sum of P_{INTmax} and $P_{I/Omax}$ ($P_{Dmax} = P_{INTmax} + P_{I/Omax}$)
- P_{INTmax} is the product of I_{DD} and V_{DD}, expressed in Watts. This is the maximum chip internal power.
- $P_{I/Omax}$ represents the maximum power dissipation on output pins
  Where:
  $P_{I/Omax} = \Sigma (V_{OL}*I_{OL}) + \Sigma((V_{DD}-V_{OH})*I_{OH})$,
  taking into account the actual V_{OL}/I_{OL} and V_{OH}/I_{OH} of the I/Os at low and high level in the application.

Table 52. Thermal characteristics(1)

Symbol	Parameter	Value	Unit
Θ_{JA}	Thermal resistance junction-ambient LQFP 64- 10 x 10 mm	48	°C/W

1. Thermal resistance is based on JEDEC JESD51-2 with 4-layer PCB in a natural convection environment.

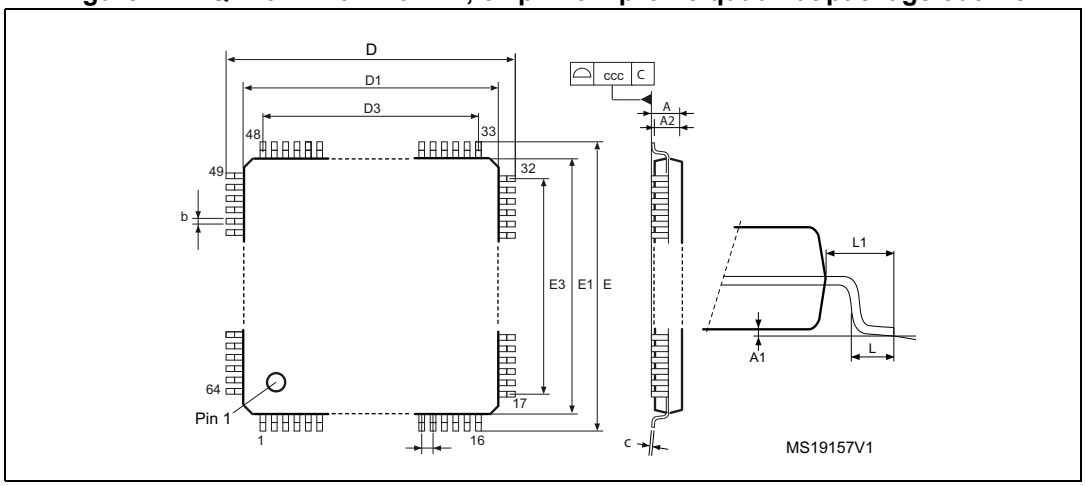
深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

9 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at *www.st.com*. ECOPACK is an ST trademark.

9.1 LQFP64 package information

Figure 41. LQFP64 – 10 x 10 mm, 64 pin low-profile quad flat package outline



1. Drawing is not to scale.

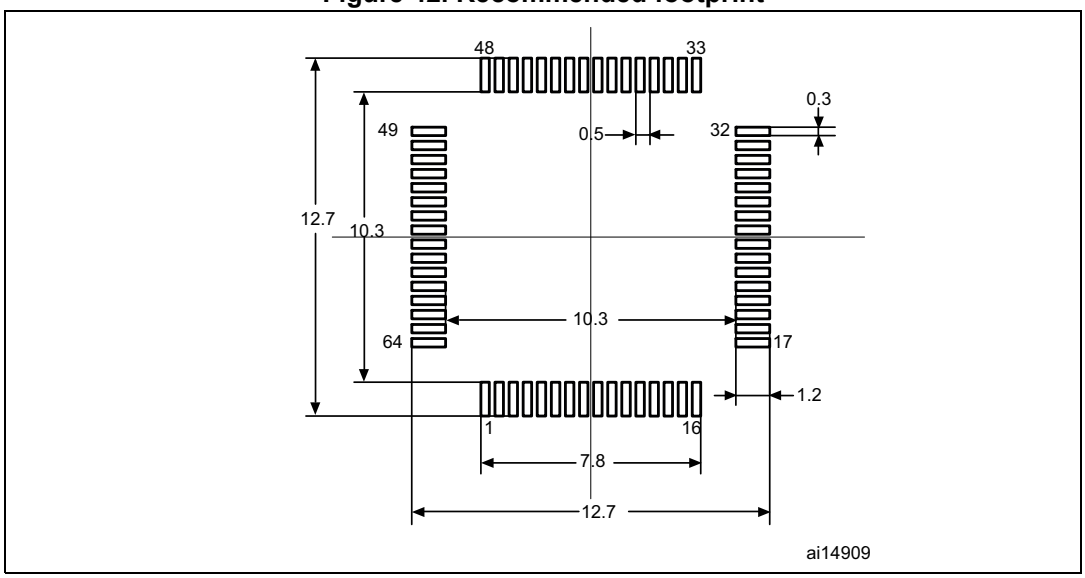
深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

Table 53. LQFP64 – 10 x 10 mm, 64-pin low-profile quad flat package mechanical data

Symbol	millimeters			inches[1]		
	Min	Typ	Max	Min	Typ	Max
A	-	-	1.60	-	-	0.0630
A1	0.05	-	0.15	0.0020	-	0.0059
A2	1.35	1.40	1.45	0.0531	0.0551	0.0571
b	0.17	0.22	0.27	0.0067	0.0087	0.0106
c	0.09		0.20	0.0035	-	0.0079
D	-	12.00	-	-	0.4724	-
D1	-	10.00	-	-	0.3937	-
E	-	12.00	-	-	0.4724	-
E1	-	10.00	-	-	0.3937	-
e	-	0.50	-	-	0.0197	-
θ	0°	3.5°	7°	0°	3.5°	7°
L	0.45	0.60	0.75	0.0177	0.0236	0.0295
L1	-	1.00	-	-	0.0394	-
Number of pins						
N	64					

1. Values in inches are converted from mm and rounded to 4 decimal digits.

Figure 42. Recommended footprint



1. Dimensions are in millimeters.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

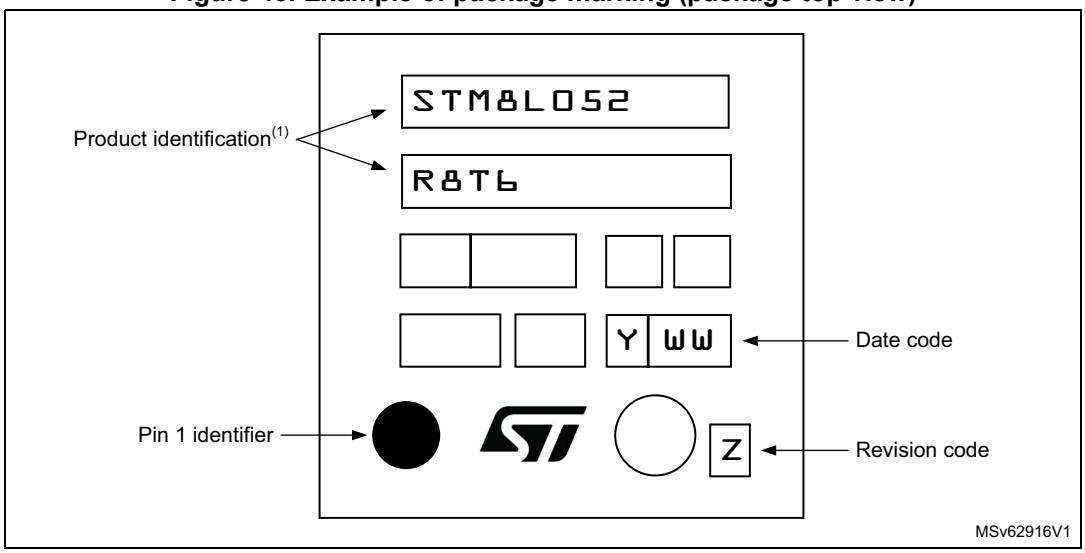
Device marking for LQFP64

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

The printed markings may differ depending on the supply chain.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

Figure 43. Example of package marking (package top view)

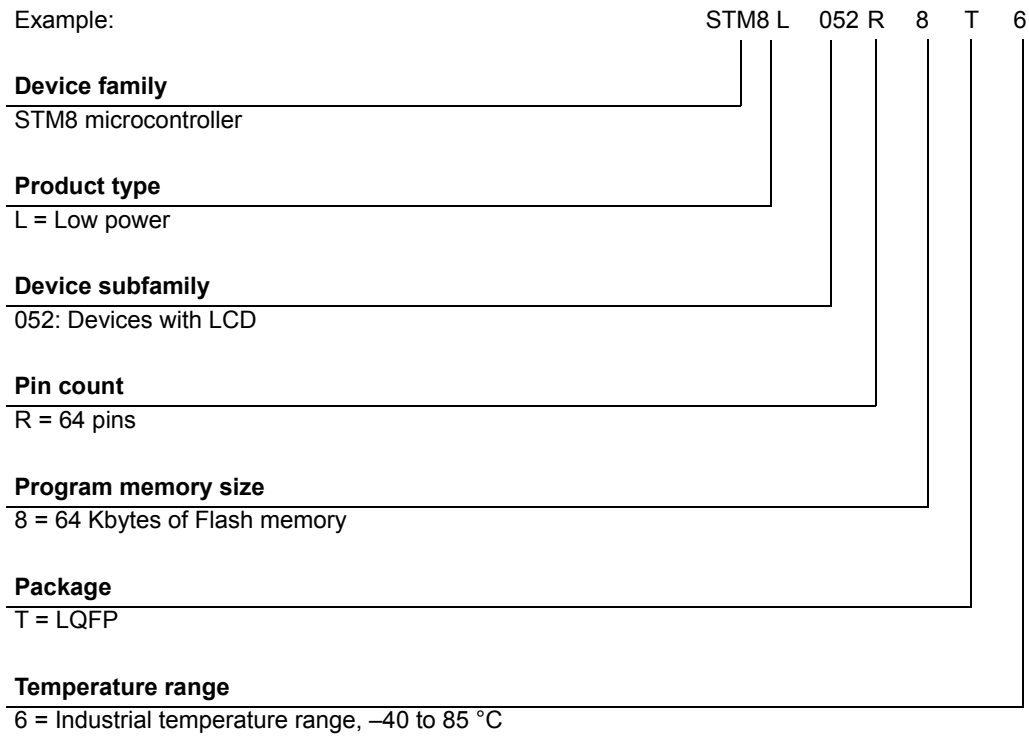


1. Parts marked as “ES” or “E” are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

10 Ordering information

Figure 44. Ordering information



For a list of available options (such as memory size, package) and orderable part numbers or for further information on any aspect of this device, please go to *www.st.com* or contact the nearest ST sales office.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

11 Revision history

Table 54. Document revision history

Date	Revision	Changes
22-Jun-2012	1	Initial release.
27-May-2013	2	Modified *12-bit ADC up to 1 Msps/27 channels*, *Table 1: Medium High density value line STM8L05xxx low power device features and peripheral counts* and *Section 3.9: Analog-to-digital converter*.
27-Feb-2017	3	Updated – Figure at *Features* section of the cover page – Footnotes from *Section 8: Electrical parameters* – *Section 8.2: Absolute maximum ratings* – *Table 1: High density value line STM8L05xxx low power device features and peripheral counts* – *Figure 4: Memory map* – *Figure 5: Pin loading conditions* – *Figure 6: Pin input voltage* – *Figure 7: Power supply thresholds* – *Figure 34: SPI1 timing diagram - slave mode and CPHA=1*(1)
23-Apr-2019	4	Updated pin 21 row in *Table 4: High density value line STM8L05xxx pin description*. Updated *Section 9: Package information* and added *Device marking for LQFP64* section.

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com

IMPORTANT NOTICE – PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries (“ST”) reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST’s terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers’ products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. For additional information about ST trademarks, please refer to *www.st.com/trademarks*. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2019 STMicroelectronics – All rights reserved

深圳市满度科技有限公司
Web:www.manduic.com
Tel:150-1290-5940
Email:sales@manduic.com